



CNT-104S

USER MANUAL



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1. User Manual CNT-104S	4		
2. Preparation for Use	4		
2.1. Preface	4		
2.1.1. Introduction	4		
2.1.1.1. Powerful and Versatile Functions	4		
2.1.1.2. No Mistakes	4		
2.1.2. Design Innovations	5		
2.1.2.1. State of the Art Technology Gives Durable Use	5		
2.1.2.2. High Resolution	5		
2.1.3. Remote Control	5		
2.1.3.1. Fast Data transfer over remote interfaces	5		
2.2. Safety	5		
2.2.1. Introduction	5		
2.2.2. Safety Precautions	5		
2.2.3. Caution and Warning Statements	6		
2.2.4. Symbols	6		
2.2.5. If in Doubt about Safety	6		
2.2.6. Disposal of Hazardous Materials	7		
2.3. Unpacking	7		
2.3.1. Check List	7		
2.3.2. Identification	7		
2.3.2.1. CNT-104S configuration guide	7		
2.3.2.2. CNT-104S configuration guide – Options and Accessories	8		
2.3.3. Installation	8		
2.3.3.1. Supply Voltage	8		
2.3.3.2. Grounding	8		
2.3.3.3. Orientation and Cooling	9		
2.3.3.4. Fold-Down Support	9		
2.3.3.5. Cleaning of the instrument	9		
2.3.3.6. Rackmount Adapter – one unit	10		
2.3.3.7. Assembling the Rackmount Kit (Option 22/90)	11		
2.3.3.8. Reversing the Rackmount Kit	11		
2.3.3.9. Rackmount Adapter – two units	12		
2.3.3.10. Assembling the Rackmount Kit (Option 22/05)	12		
3. Getting Familiar with the Instrument	14		
3.1. Front & Rear Panels	14		
3.2. Home Screen	15		
3.3. Settings	16		
3.4. Measurement Data Display	18		
4. Measurement principles and concepts	19		
4.1. Time and Frequency measurement principles	19		
4.2. Voltage measurement principles	21		
4.3. Sample Interval	23		
4.4. Input signal conditioning/Input Amplifiers	25		
4.4.1. Overview	25		
4.4.2. Configurable amplifiers	25		
4.4.2.1. Impedance	25		
4.4.2.2. Attenuation	25		
		4.4.2.3. Coupling	25
		4.4.2.4. Filter	26
		4.4.2.5. Preamp	26
		4.4.2.6. Trigger Level	26
		4.4.3. Input Amplifiers with fixed configuration	27
		4.5. Arming	27
		5. Measurement Functions	31
		5.1. Frequency/Period	31
		5.1.1. Frequency/Period Average measurements	31
		5.1.1.1. Frequency C measurement.	32
		5.1.2. Smart Frequency/Period	32
		5.1.3. Period Single	33
		5.1.4. Frequency Ratio	33
		5.2. Time Interval and Phase	33
		5.2.1. Time Interval	33
		5.2.2. Accumulated Time Interval	33
		5.2.3. Time Interval Single	35
		5.2.4. Measuring Time Interval between different trigger points of the same signal	35
		5.2.5. Phase	38
		5.2.6. Accumulated Phase	39
		5.3. Time Interval Error (TIE)	39
		5.4. Pulse characterization	40
		5.4.1. Positive and Negative Pulse Width	40
		5.4.2. Positive and Negative Duty Cycle	40
		5.4.3. Rise Time, Fall Time, Rise-Fall Time	41
		5.4.4. Positive and Negative Slew Rate	42
		5.5. Totalize	42
		5.5.1. Manual Totalize	42
		5.5.2. Timed Totalize	42
		5.5.3. Armed Totalize	42
		5.6. Voltage	43
		6. Measurement cheat-sheet	43
		6.1. Generic hints	43
		6.2. Measuring 1 PPS	43
		6.3. Measuring single cycles or pulses	43
		6.4. Measuring Frequency/Period	44
		6.5. Time measurements of continuous signals	44
		6.6. Jitter measurements	44
		6.6.1. Single cycle jitter	44
		6.6.2. Cycle-to-cycle jitter	44
		6.6.3. Wander measurements	44
		6.6.4. Deterministic jitter	44
		6.7. Frequency Modulated Signals	44
		6.7.1. Initial capture settings	45
		6.7.2. Carrier Wave Frequency f0	45
		6.7.3. Frequency deviation fmax - f0	45
		6.7.4. Modulation frequency fmod	45
		6.7.5. Errors in fmax, fmin, and fp-p	45
		6.8. Frequency profiling	46

6.8.1. Free-Running Measurements	46	9. Specifications	62
6.8.2. Repetitive Sampling Profiling	46	9.1. Measuring Functions	62
6.8.3. Vrms	46	9.2. Input Specifications	64
7. Other features	47	9.3. Rear Panel Inputs and Outputs	65
7.1. Hold-off	47	9.4. Auxiliary Functions	66
7.2. Timeout	48	9.5. Remote interfaces	67
7.3. Calibration	48	9.6. Calibration of Timebase Oscillator	67
7.3.1. Internal Calibration	48	9.7. General Specifications	67
7.3.2. Timebase Calibration	49	9.8. Time Base Options	68
7.3.3. Voltage Calibration	49	9.9. Ordering Information	68
7.4. Mathematics	50	10. Sales and Service Contacts	69
7.4.1. Example use cases	50		
7.5. Limits	51		
7.6. Pulse Output (option)	52		
7.7. Network	53		
7.7.1. Web Interface	54		
7.7.2. VNC	55		
7.8. Front USB ports	55		
7.9. File Manager	55		
7.10. Firmware Update	55		
7.11. Installing license	55		
8. Performance Check	56		
8.1. General Information	56		
8.2. Preparations	56		
8.3. Test Equipment	56		
8.4. Internal Self-Tests	56		
8.5. Front Panel Controls	56		
8.5.1. Touch Panel and Keyboard Test	56		
8.6. Short Form Specification Test	57		
8.6.1. Sensitivity and Frequency Range for Inputs A, B, D, E	57		
8.6.2. Sensitivity and Frequency Range for RF Input (Input C)	57		
8.6.3. Voltage	58		
8.6.4. Reference Oscillators	59		
8.6.4.1. Acceptance Test	59		
8.6.5. Resolution Test	59		
8.7. Rear Inputs/Outputs	60		
8.7.1. 10 MHz OUT	60		
8.7.2. EXT REF FREQ IN	60		
8.7.3. EXT ARM IN	60		
8.7.4. PULSE OUT	60		
8.8. Measuring Functions	60		
8.8.1. Optional RF Input C	61		
8.9. Check of HOLD OFF Function	61		

1. User Manual CNT-104S

Revision 1.1

12NC 4031.601.10401

About this Manual

This manual contains directions for use that apply to the the 4-channel CNT-104S Multi-channel Frequency Analyzer.

Warranty

The Warranty Statement is part of the folder Important Information that is included with the shipment.

Declaration of Conformity

The complete text with formal statements concerning product identification, manufacturer and standards used for certification type testing is available on request.

2. Preparation for Use

2.1. Preface

2.1.1. Introduction

Congratulations on your choice of instrument. It will serve you well and give you today's ultimate performance for many years to come, whether you work with advanced ultra-high resolution frequency analysis in R&D, high-precision calibration in Metrology, or high speed testing of time & frequency in test systems.

Your instrument is the industry's first bench-top multichannel frequency counter/analyzer designed to bring a new dimension to bench-top and system frequency counting and analysis. It gives significantly increased performance compared to traditional Timer/Counters. The CNT-104S offers for example the following benefits:

- 4-parallel time-stamping input channels, means you have 4 independent frequency counters in one box. An enormous save of money and space in test systems
- Phase-compare 4 stable frequencies continuously in real time in a time metrology lab, without the need for external signal switching
- The parallel-channel time-stamping design, where all channels run on the same time scale, allows to measure Time Interval with multiple stop channels, which is very valuable for exact timing of one-shot events
- Graphical intuitive User Interface, with large 5" color touch-screen control Easy control of instrument via mouse or web interface.
- Up to 13 digits of frequency resolution per second and up to 7 ps resolution/timestamp
- A high measurement rate of up to 20M readings/s to internal memory
- Optional oven-controlled timebase oscillators, Choice of RF prescaler options with upper frequency limits ranging from 3 GHz to 24 GHz
- Integrated 1Gbit Ethernet and USB interfaces with SCPI commands support

2.1.1.1. Powerful and Versatile Functions

In addition to the traditional measurement functions of legacy timer/counters, these instruments have a multitude of other functions such as Multi-stop Time Interval, Phase, Duty factor, rise/fall time, Slew Rate, TIE (Time Interval Error), Totalize and Peak Voltage. The CNT-104S introduces the concept of parallel measurements, for example 4 frequency measurements in parallel, or one rise time plus one fall time measurement in parallel on the same pulse. Even on single-shot pulses!

By using the built-in mathematics and statistics functions, the instrument can process the measurement results on your benchtop, without the need for a controller. Math functions include inversion, scaling and offset. Statistics functions include Max, Min and Mean as well as Standard and Allan Deviation on sample sizes up to 32×10^6 .

2.1.1.2. No Mistakes

You will soon find that your instrument is self-explanatory with an intuitive user interface. A settings menu tree with few levels makes the CNT-100 easy to operate. The large graphic LCD is the center of information and can show you several signal parameters at the same time as well as status.

Measurement samples are presented as numeric values, or graphically over time, to reveal signal stability, trends, or modulation. Stability information can easily be presented as value distribution or trend plots in addition to complete numerical calculation results like max, min, mean and standard deviation.

The Autoset function is available on any input waveform and can make best settings of the currently selected measurement function. Use the built-in web server interface or VNC to get an enlarged view of the front panel on your desktop or laptop PC, tablet or even mobile phone. You can control every setting, start & stop measurements, and even download measurement data.

2.1.2. Design Innovations

2.1.2.1. State of the Art Technology Gives Durable Use

These Analyzers are designed for quality and durability. The modern design with high integration and low component count reduces power consumption and results in an MTBF of 15,000 hours. A rugged mechanical construction, including a metal cabinet that withstands mechanical shocks and protects against EMI, is also a valuable feature.

Rubber bumpers around the front panel further enhance ruggedness.

2.1.2.2. High Resolution

The use of reciprocal interpolating time-stamping counting, combined with a smart calibration algorithm, results in excellent resolution: <7 ps per time stamp or 12-13 digits/s in frequency measurements for all frequencies.

Timestamps of trigger events are taken continuously, and the frequency values are calculated on the fly, while the set measurement is running without interruption in the background, thereby assuring gap-free zero-dead-time measurements between samples. Minimum time between calculated values is 50 ns, meaning a sampling speed of 20 MSa/s.

2.1.3. Remote Control

This instrument is programmable via Ethernet (ETH) or USB interfaces.

The ETH is the primary interface intended for use in test systems, on lab benches, and fully remote control and monitoring from “anywhere in the world”.

The web interface and VNC server are included, which gives you an exact copy, pixel by pixel, of the instrument's screen. All instrument settings can be controlled from the web interface or VNC, and result data can be read.

In test systems, the CNT-104S uses the standardized SCPI language for programming the instrument's functions and reading the results.

The USB interface is mainly intended for the lab environment with the “remote” controller in a nearby place.

2.1.3.1. Fast Data transfer over remote interfaces

The bus transfer rate is up to 200 measurements/s for individually triggered measurements, and 170k measurements/s in block transfer mode. Array measurements to the internal memory can reach 20M measurements/s.

This very high measurement rate makes new measurements possible. For example, you can perform jitter analysis on several tens of thousands of pulse width measurements and capture and transfer them in less than a second.

The 4-channel parallel frequency measurement architecture significantly improves measurement speed, compared to using 4 separate frequency counters, and individually addresses them in a sequence.

The CNT-104S also features data streaming “forever” of gap-free measurements. This means you could leave CNT-104S in a field site, either connected to a local PC or connected to a local network, to monitor e.g., 4 different synchronization signals for a week or two and come back and collect tons of gap-free data for analysis.

Programmer's Handbook helps you understand SCPI and the Analyzer's programming. Complete counter settings can be stored and can easily be recalled on a later occasion.

2.2. Safety

2.2.1. Introduction

Please take a few minutes to read through this part of the introductory chapter carefully before plugging the line connector into the wall outlet.

This instrument has been designed and tested for Measurement Category I, Pollution Degree 2, in accordance with EN 61010-1:2011, and CSA C22.2 No 61010-1-12 (including approval). It has been supplied in a safe condition. Study this manual thoroughly to acquire adequate knowledge of the instrument, especially the section on Safety Precautions hereafter and the section on Installation.

2.2.2. Safety Precautions

All equipment that can be connected to line power is a potential danger to life. Handling restrictions imposed on such equipment should be observed.

To ensure the correct and safe operation of the instrument, it is essential that you follow generally accepted safety procedures in addition to the safety precautions specified in this manual.

The instrument is designed to be used by trained personnel only. Removing the cover for repair, maintenance, and adjustment of the instrument must be done by qualified personnel who are aware of the hazards involved.



Note: The warranty commitments are rendered void if unauthorized access to the interior of the instrument has taken place during the given warranty period.

2.2.3. Caution and Warning Statements



CAUTION: Shows where incorrect procedures can cause damage to, or destruction of equipment or other property.



WARNING: Shows a potential danger that requires correct procedures or practices to prevent personal injury.

2.2.4. Symbols



Shows where the protective ground terminal is connected inside the instrument. Never remove or loosen this screw.



This symbol is used for identifying the functional ground of an I/O signal. It is always connected to the instrument chassis.



Indicates that the operator should consult the manual.

Personal safety is ensured when the input signal level is below $30 V_{rms}$ (when accidentally touching the input signal lead)

Damage level for the input decreases from $350 V_p$ to $12 V_{rms}$ when you switch the input impedance from $1 M\Omega$ to 50Ω .

Measurement BNC cables length shall be kept below 3m.

Circuits of external devices connected to BNC sockets, USB sockets and Ethernet sockets should be separated from the power supply network (and from other sources of dangerous voltage) at the level of reinforced insulation. This separation should not be confused with the permissible voltage of the external signal, including the voltage of $350 V_p$ referred to in the manual. If the equipment is used in a manner not specified by the manufacturer, the protection provided by the equipment may be impaired.

2.2.5. If in Doubt about Safety

Whenever you suspect that it is unsafe to use the instrument, you must make it inoperative by doing the following:

- Disconnect the line cord
- Clearly mark the instrument to prevent its further operation



Fig. 1-1 Do not overlook the safety instructions!

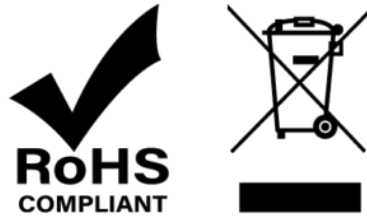
- Inform your Pendulum Instruments representative.

For example, the instrument is likely to be unsafe if it is visibly damaged.

2.2.6. Disposal of Hazardous Materials

There are no batteries or other potentially hazardous materials included.

You should dispose of your worn-out Frequency Analyzer, after a long and happy life, at an authorized recycling station or return it to Pendulum Instruments.



2.3. Unpacking

Check that the shipment is complete and that no damage has occurred during transportation. If the contents are incomplete or damaged, file a claim with the carrier immediately. Also notify your local Pendulum Instruments sales or service organization in case repair or replacement may be required.

2.3.1. Check List

The shipment should contain the following:

- Multi-channel Frequency Analyzer CNT-104S Line cord
- Printed version of the Getting Started Manual Brochure with Important Information Certificate of Calibration Options you ordered should be installed. See Identification below.



Note: To ensure always up-to-date user documentation, the user manual (this document) is not included on any media in the shipment. Instead, the user documentation can be read on-line or downloaded as PDF from manuals.pendulum-instruments.com

- Getting Started User's Manual
- User's Manual
- Programmer's Handbook

2.3.2. Identification

The type plate on the rear panel shows type number and serial number. Installed options are listed under the menu About, where you can also find information on firmware version and calibration date.

2.3.2.1. CNT-104S configuration guide

Product code (12NC): **9446 101 04XYZ**

CNT-104S is configured using factory installed HW options, and customer installable options via SW license keys. **The 12NC code only describes the HW configuration.** SW enabled options and built-in measurement apps are coded separately, and not shown in the HW configuration 12NC code

X = RF/Microwave frequency option

0 = None

1 = Not used

2 = Reserved

3 = Reserved

4 = Reserved

5 = Reserved

6 = 3 GHz (Option 10)

7 = 10 to 24 GHz CW (Option 110, SW upgradable from 10 to 24 GHz)

8 = Reserved

9 = Customer special

Y = Oscillator option
 2 = TCXO (standard oscillator in CNT-100, New)
 5 = OCXO, High stability (Option 30, same as for CNT-9x)
 6 = OCXO, Ultra-high stability (Option 40, same as for CNT-9x)
 Z = Rear panel inputs and other HW options
 1 = standard
 2 = rear inputs A, B, D, E and C (Option 11/100)
 3 = Reserved
 4 = Reserved
 5 = Reserved
 6 = Reserved
 9 = Customer special

2.3.2.2. CNT-104S configuration guide – Options and Accessories

Product code for ordered SW licenses (12NC): **9446 101 XXXYY XXX/YY** = Main option / Version.

NOTE: the first "X" cannot be a 0

110 group – Prescaler frequency upgrade

110/15 = upgrade from 10 to 15 GHz CW input C SW 110/20 = upgrade from 15 to 20 GHz CW input C SW 110/24 = upgrade from 20 to 24 GHz CW input C SW

130 group – Enable HW inputs/outputs 132 = Enable Pulse output SW

150 group – Enable measurement functions

151 = Enable TIE measurements

2.3.3. Installation

2.3.3.1. Supply Voltage

Setting

The Analyzer may be connected to any AC supply with a voltage rating of 90 to 250 VAC, 47 to 63 Hz. The Analyzer automatically adjusts itself to the input line voltage.

Fuse

The secondary supply voltages are electronically protected against overload or short circuit. The primary line voltage side is protected by a fuse located on the power supply unit. The fuse rating covers the full voltage range.

Consequently, there is no need for the user to replace the fuse under any operating conditions, nor is it accessible from the outside.



CAUTION: If this fuse is blown, it is likely that the power supply is badly damaged.
 Do not replace the fuse. Send the Analyzer to the local Service Center.

Removing the cover for repair, maintenance and adjustment must be done by qualified and trained personnel only, who are fully aware of the hazards involved.

Removing the cover for repair, maintenance and adjustment must be done by qualified and trained personnel only, who are fully aware of the hazards involved.

The warranty commitments are rendered void if unauthorized access to the interior of the instrument has taken place during the given warranty period.

2.3.3.2. Grounding



Grounding faults in the line voltage supply will make any instrument connected to it dangerous. Before connecting any unit to the power line, you must make sure that the protective ground functions correctly. Only then can a unit be connected to the power line and only by using a three-wire line cord. No other method of grounding is permitted.

Extension cords must always have a protective ground conductor.



CAUTION: If a unit is moved from a cold to a warm environment, condensation may cause a shock hazard. Ensure, therefore, that the grounding requirements are strictly met.



WARNING: Never interrupt the grounding cord. Any interruption of the protective ground connection inside or outside the instrument or disconnection of the protective ground terminal is likely to make the instrument dangerous.

2.3.3.3. Orientation and Cooling

The Analyzer can be operated in any position desired. Make sure that the air flow through the ventilation slots at the side panels is not obstructed. Leave 5 centimeters (2 inches) of space around the Analyzer.

2.3.3.4. Fold-Down Support

For bench-top use, a fold-down support is available for use underneath the Analyzer. This support can also be used as a handle to carry the instrument.

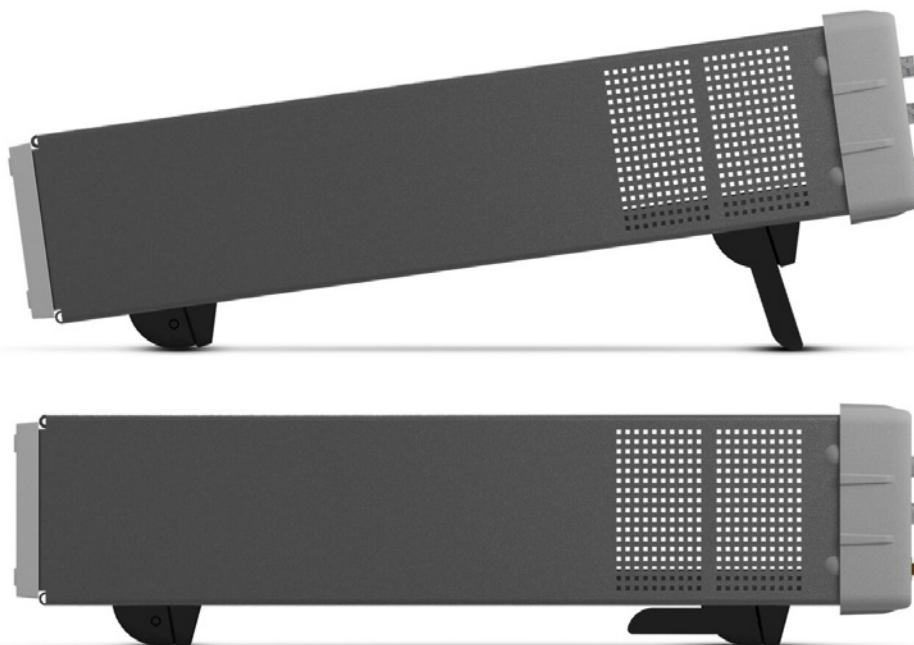


Fig. 1-2 Fold-down support for comfortable bench-top use.

2.3.3.5. Cleaning of the instrument

When cleaning the instrument, wipe it with a silicone cloth or soft cloth to remove dust or dirt. When it is hard to remove the dirt, wipe it with a cloth wet with water and dry the instrument completely after cleaning.



CAUTION :Never use any organic solvent such as benzene, acetone, etc.

2.3.3.6. Rackmount Adapter – one unit



Fig. 1-3 Dimensions for rackmounting hardware.

If you have ordered a 19-inch rack-mount kit for your instrument, Option 22/90 for one instrument, it has to be assembled after delivery of the instrument. The rackmount kit consists of the following:

- 2 brackets, (short, left; long, right)
- 4 screws, M5 x 8
- 4 screws, M6 x 8

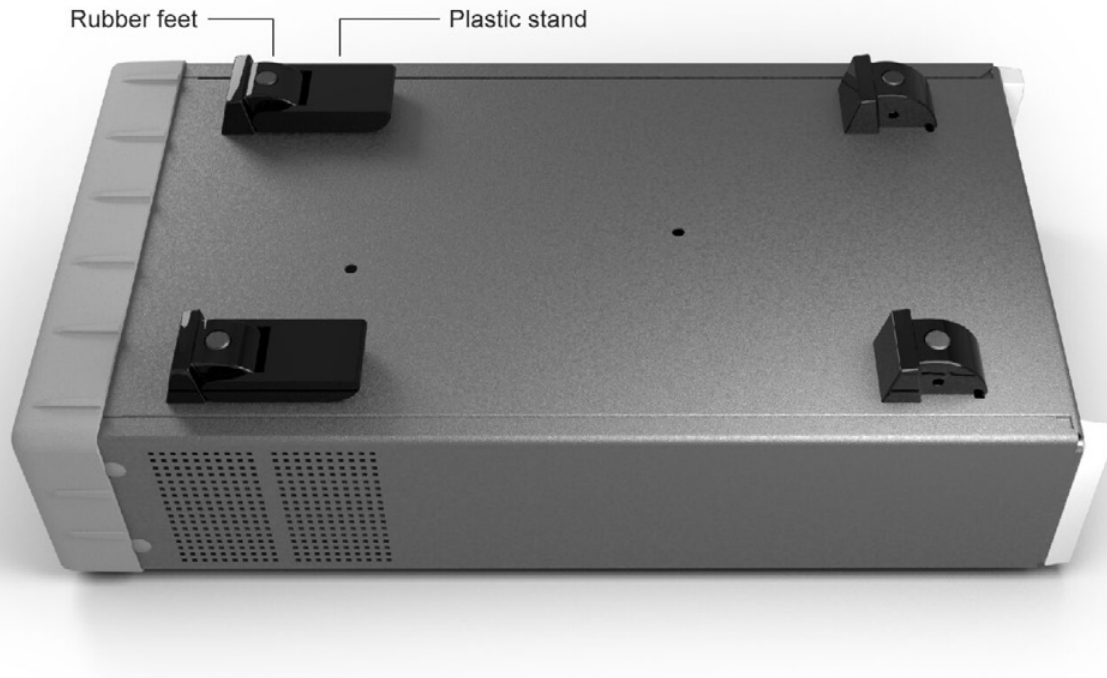


WARNING: Do not perform any internal service or adjustment of this instrument unless you are qualified to do so.



Fig. 1-4 Fitting the rack mount brackets on the Analyzer.

2.3.3.7. Assembling the Rackmount Kit (Option 22/90)



1-5

- Turn the device upside down
- Remove the rubber feet in the plastic stand
- Loosen the screws underneath the rubber feet
- Remove the plastic stands
- Remove the rubber bumper around the front
- Remove the four decorative plugs that cover the screw holes on the right and left side of the front panel.
- The long bracket in Option 22/90 has an opening so that cables for Input signals can be routed inside the rack.
- Mount the rackmount kit with the included screws

2.3.3.8. Reversing the Rackmount Kit

The instrument may also be mounted to the right in the rack. To do so, swap the position of the two brackets.

2.3.3.9. Rackmount Adapter – two units

This rackmount adapter can hold any two standard Pendulum ½ x 19" unit, like FDA-301A, CNT-9x, CNT-10x, GPS-12x etc.

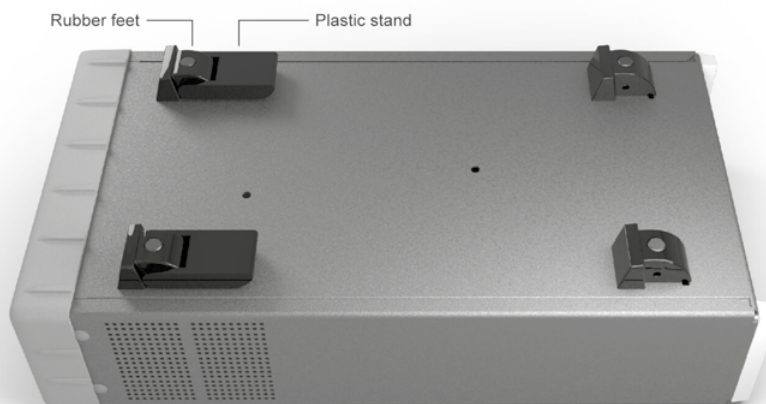


1-6

If you have ordered the Option 22/05 rack-mount kit for two instruments, it has to be also assembled after delivery of the instrument. The rackmount kit consists of the following:

- 4 Brackets, rear
- 1 Hinge Spring Latch
- 2 Ear, rack
- 1 Assembly instruction, SXS Rack kit
- 2 Screws M4x8
- 8 Screws M5x10
- 1 Spacer M4x16

2.3.3.10. Assembling the Rackmount Kit (Option 22/05)



1-7

- Turn the devices upside down
- Remove the rubber feet in the plastic stand
- Loosen the screws underneath the rubber feet

- Remove the plastic stands
- Remove the rubber bumper around the front
- Remove the four decorative plugs that cover the screw holes on the right and left side of the front panel.

Use the following steps to complete the side by side rack mount installation for your products. If necessary, refer to the item numbers in the following diagram for additional detail.

- Determine where you would like each unit positioned (i.e., on the right or left side)
- If plugs exist on the mounting holes on the front left and right side of product cover, remove and discard them
- Using screwdriver, screw the rack ear (Item #2) into place using the supplied 10mm screws (Item #5)
- Pinch the hinge pins together to separate the right and left hinge halves (Items #3 and 4)
- Attach hinge halves to the unit with hinge facing towards the front (as displayed in diagram)
- Using a screwdriver, remove the existing rear brackets on the back of each unit
- Using existing machine screws removed in previous steps, attach the rear brackets supplied with the mounting kit (Item #1)
- Pinch the hinge pins together into the stored position. Align the hinge halves together between the two units, and swing together side by side. The hinge pins should snap into place securing the front of the two units together
- Take the supplied Hex Spacer (Item #7) and place between middle rear brackets, and secure using the supplied 8mm screws (Item #6)
- Assembly is now ready for installation into standard 19" rack



1- 8

3. Getting Familiar with the Instrument

3.1. Front & Rear Panels

USB Host ports

The ports allow to use keyboard/mouse to control the device, Wi-Fi dongle for wireless connection, USB Mass Storage that holds measurement results, settings presets, FW update files.

STANDBY LED

The LED lights up when the Analyzer is in STANDBY mode and blinks when the display is off, but the device is powered on.

In STANDBY mode internal timebase oscillator is kept powered on.

STANDBY/ON

Pressing this button toggles STANDBY mode.

Main screen

Graphics display for touch settings, result readout, graphs, status indication and more.

Hard keys

Auto Set (best settings)

RUN/HOLD measurements

Restart measurements

Home key (goto start screen)

Back (go to previous screen)



STANDBY LED

The LED lights up when the Analyzer is in STANDBY mode, indicating that power is still applied to an internal optional OCXO.

STANDBY/ON

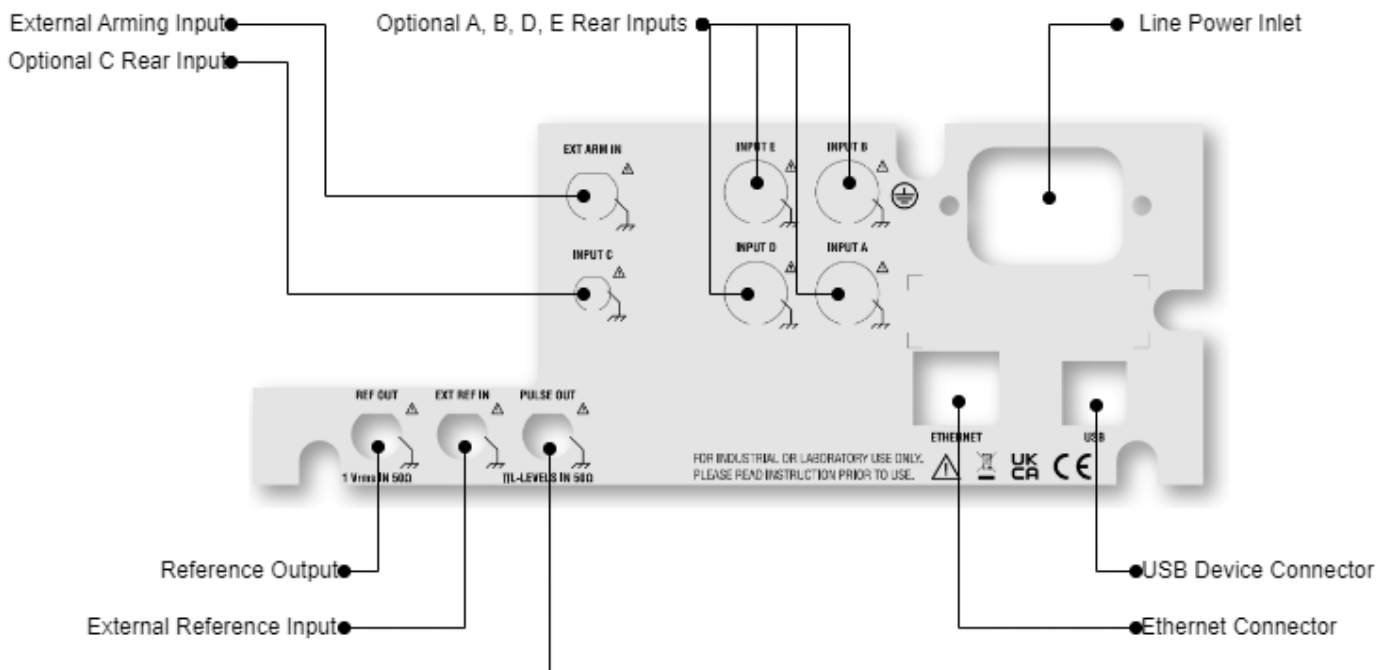
Toggling secondary power switch. Pressing this button in standby mode turns the Analyzer ON and restores the settings as they were at power-down.

Input Channels

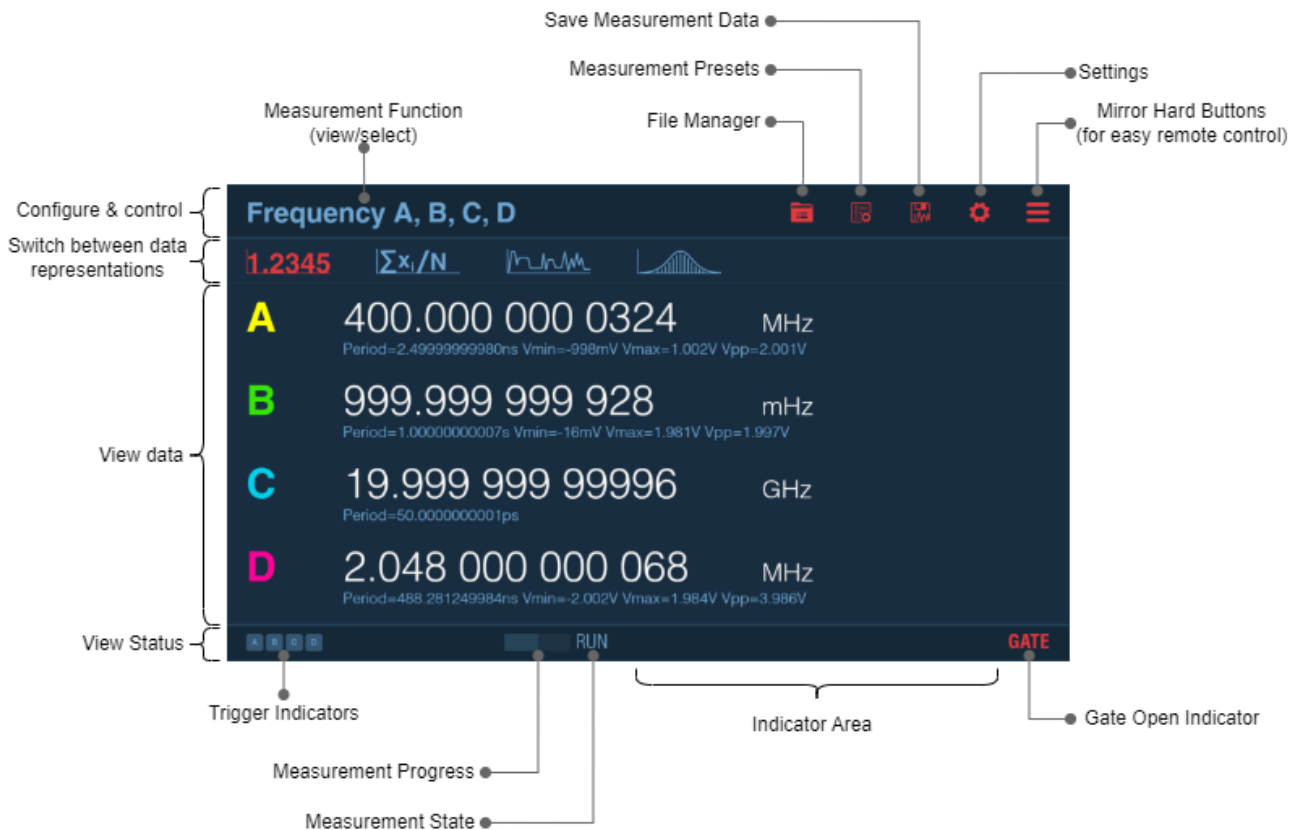
A, B: 400 MHz channels with BNC inputs. Always present

D, E: 400 MHz channels with BNC inputs.

C: 400 MHz to 3/24 GHz optional microwave input (prescaler input)



3.2. Home Screen



Measurement State:

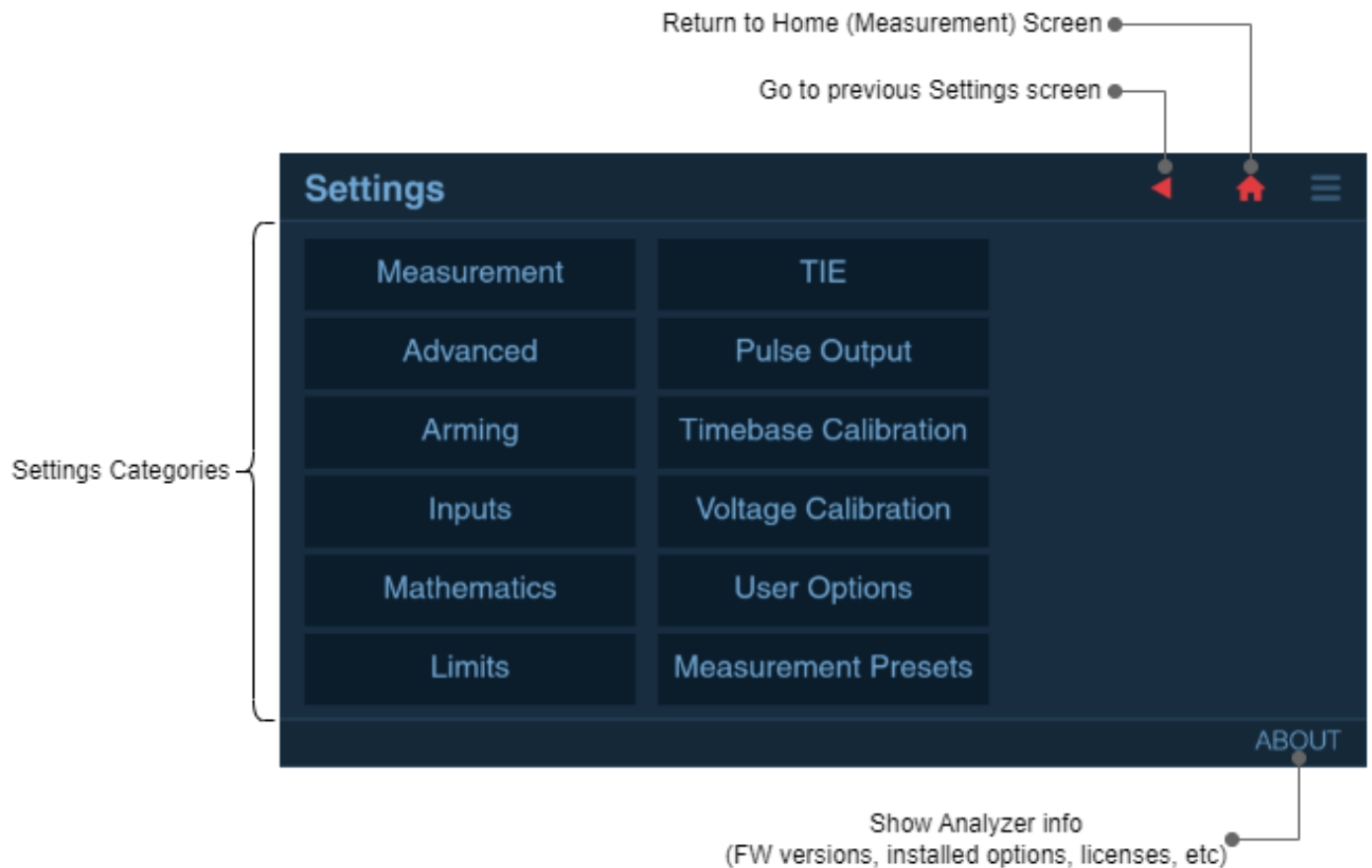
- RUN – next measurement will start automatically as soon as current one is over. Pressing RESTART in this state starts new measurement, measurement state remains RUN. Pressing RUN/HOLD in this state changes the state to SINGLE, but current measurement continues. Exception is Totalize measurement functions, when state is changed to HOLD.
- SINGLE – measurement is in progress. After measurement is over – measurement state will change to HOLD, no new measurement will start. Pressing RESTART in this mode starts new measurement, measurement state remains SINGLE. Pressing RUN/HOLD in this state stops the measurement and changes state to HOLD.

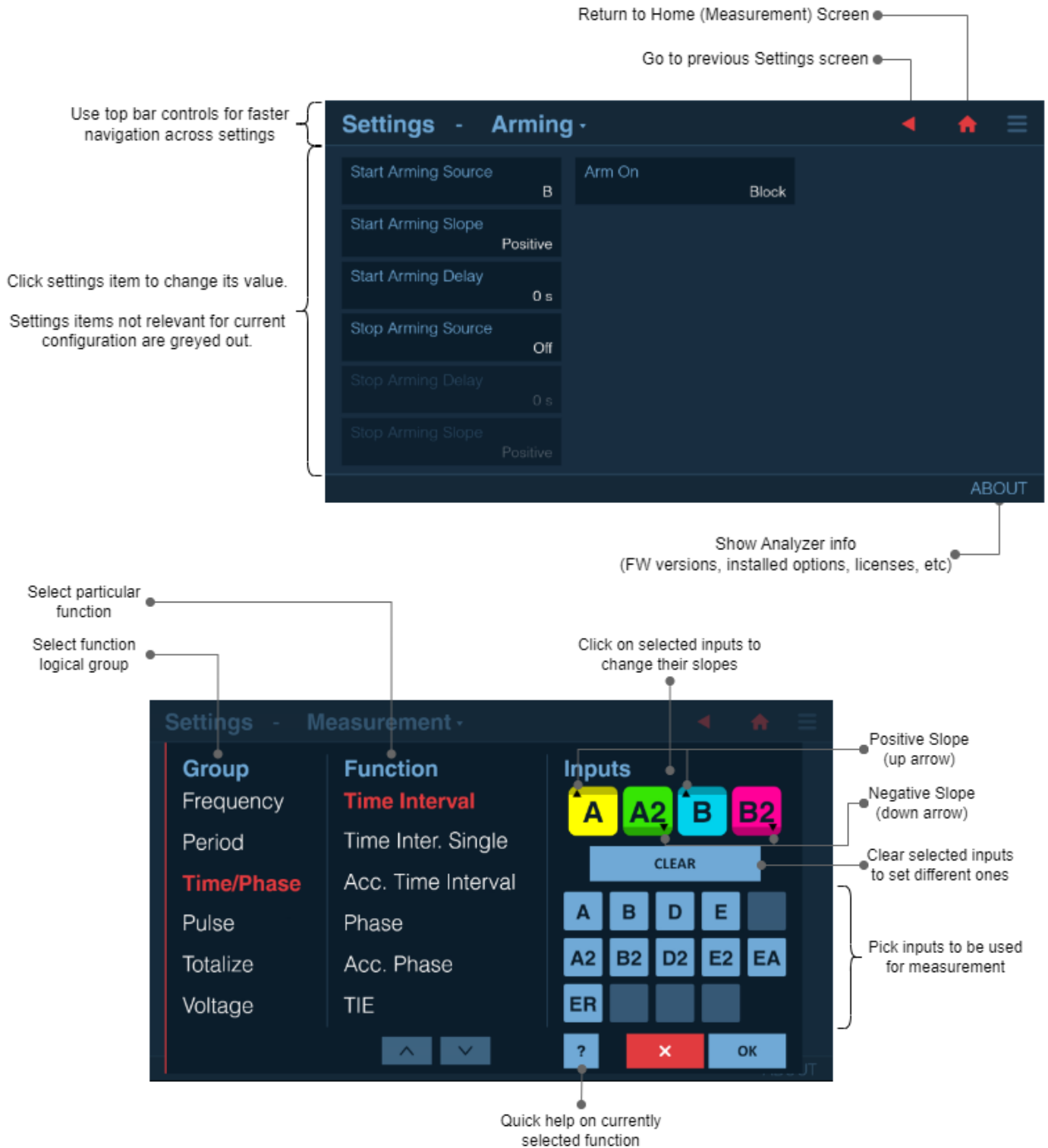
- HOLD – measurement is not active. Results of previous measurement are displayed. Pressing RESTART starts new measurement and changes state to SINGLE. Pressing RUN/HOLD in this state starts new measurement and changes state to RUN.

Indicators:

- Trigger indicators – if signal crosses set trigger level(s) for particular input, then corresponding trigger indicator is lit, otherwise it is grayed out.
- GATE – red when measurement is active, grayed out otherwise.
- MATH – Math function is active. User selectable formula is applied to one or all (depending on user choice) measurement series.
- LIM – Limits function is active. Values of one or all (depending on user choice) measurement series are checked against the limit(s) specified by the user. User can configure the desired behavior when measurement data exceeds the limit(s).
- ER – External Reference clock is used as a timebase for measurements.
- REM – instrument is now in Remote state (controlled by remote application). In this state the instrument can not be controlled from the front panel. Press BACK to switch to Local state and enable front panel control. If REM! indicator is displayed, Remote Lockout mode is active and BACK button cannot be used to return to Local Mode. Only remote party can undo this state. In web interface or VNC client use F7 key in place of BACK.
- ARM – measurement configured to start and/or stop on arming signal.

3.3. Settings





Inputs description:

- A, B, D, E – main inputs
- A2, B2, D2, E2 – supplementary comparators of main inputs (e.g. for measuring time intervals inside multi-level signals)
- C – optional High Frequency input EA – External Arming input
- ER – External Reference Input

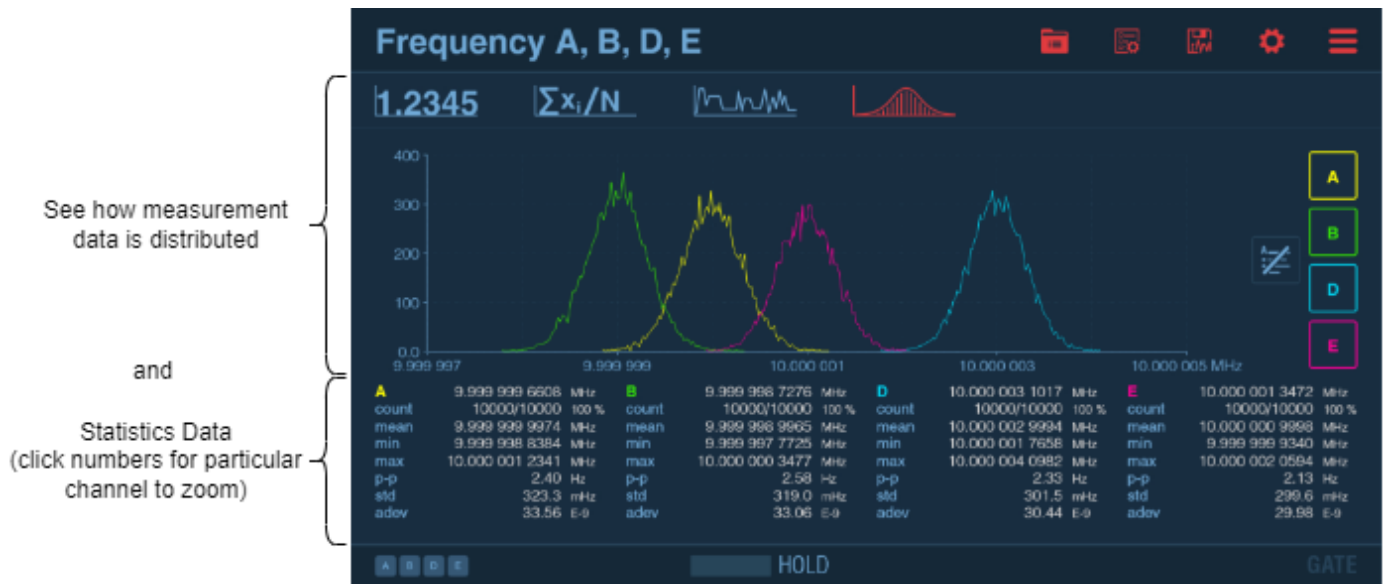
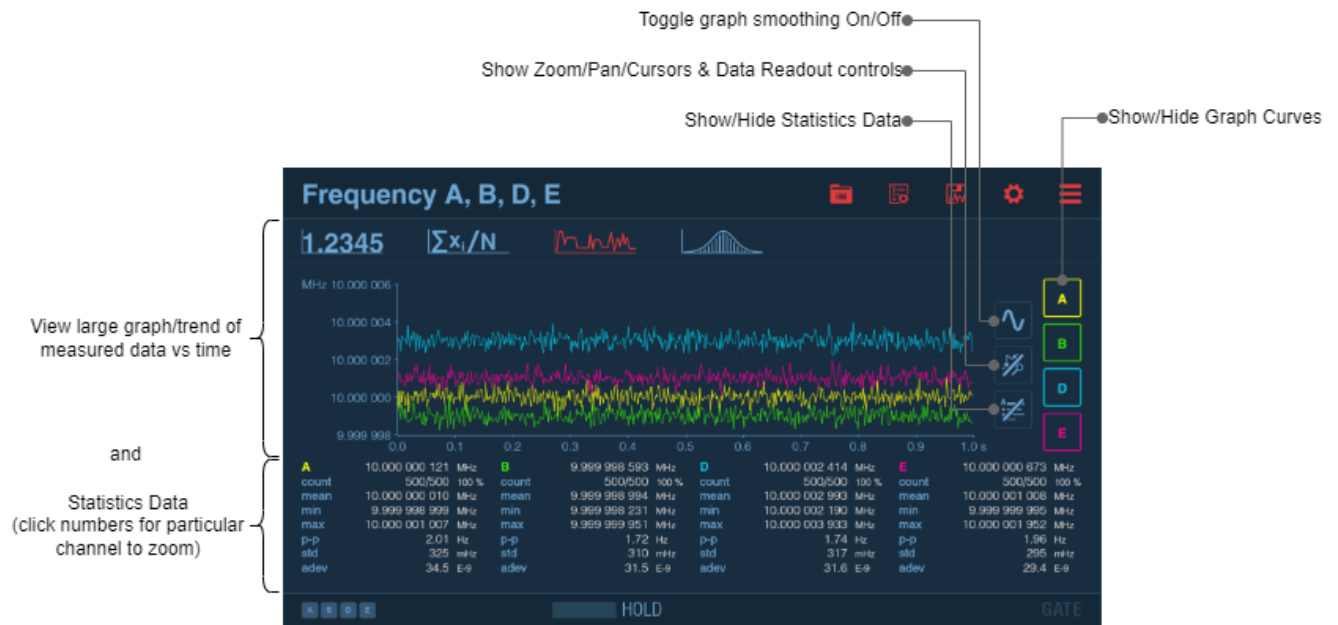
3.4. Measurement Data Display



View large numeric data from 4 measurement channels at the same time along with auxiliary data (e.g. voltage)



View detailed statistics for all measurement channels (click numbers for particular channel to zoom)



4. Measurement principles and concepts

4.1. Time and Frequency measurement principles

Block diagram on Figure 1 demonstrates input signal transformation to series of time and frequency measurement data points.

First, input signal gets into input amplifier. The generic role of input amplifier circuits is matching the input to signal source, and optionally: attenuate or amplify it, remove DC offset and/or filter out high-frequency noise.

Please note: There are several kinds of input amplifier circuits (configurable input amplifiers, prescalers, fixed input amplifiers), please refer to 4.5 Input signal conditioning/Input Amplifiers chapter for more details about them.

After the input amplifiers the signal is digitized using one (inputs C, EA, ER) or 2 comparators (inputs A, B, D, E). It works the following way: when the signal crosses the set trigger level, comparator generates a positive (in case of transition from below to above the trigger level) or negative (in case of transition from above to below the trigger level) slope. Please refer to Figure 2 for an example.

Please note: For most measurement modes on inputs with 2 comparators, output of only one comparator is used for measuring the signal from this input. However, there are measurement modes using both comparators implicitly:

- Rise/Fall Time and Slew Rate measurements use 2 comparators for getting Time Interval between lowest (10%) and highest (90%) levels of the signal (see details in 5.4.3 Rise Time, Fall Time, Rise-Fall Time);
- Pulse width and Duty Cycle measurements use 2 comparators to produce pulses on positive and negative slope of a signal and measure Time Interval between these;

- Frequency and Period Average use 2 comparators to implement implicit wide hysteresis targeted on improving noisy signals measurements (see details in 5.1.1 Frequency/Period Average measurements chapter).

Second comparator can also be explicitly selected for measurement. E.g., Time Interval A, A2 will measure time interval between signal level set by trigger level A and signal level set by trigger level A2 (can be useful for measuring characteristics of multi-level signals, e.g. TDR measurements – see 5.2.4 Measuring Time Interval between different trigger points of the same signal). It can also be explicitly used as a source of start or stop arming.

Digitized signals from physical inputs are just pulse trains which can be multiplexed to 4 internal measurement channels. Each measurement channel starts with Wide Hysteresis block. Wide Hysteresis block just passes through the signal for most measurement functions except Frequency, Period Average, their Smart versions, TIE, and Frequency Ratio for which implicit wide hysteresis is used for better noise tolerance (see 5.1.1 Frequency/Period Average measurements).

The resulting pulse train is then counted independently in each measurement channel. Measurement logic specific for each measurement mode makes snapshots of channel's pulse counter, timestamps it and adds channel number, forming series of so-called raw results.

Raw results are further post-processed in calculation block to form series of final value-timestamps pairs. See Figure 2 for a visualized example of signal processing happening inside CNT-104S.

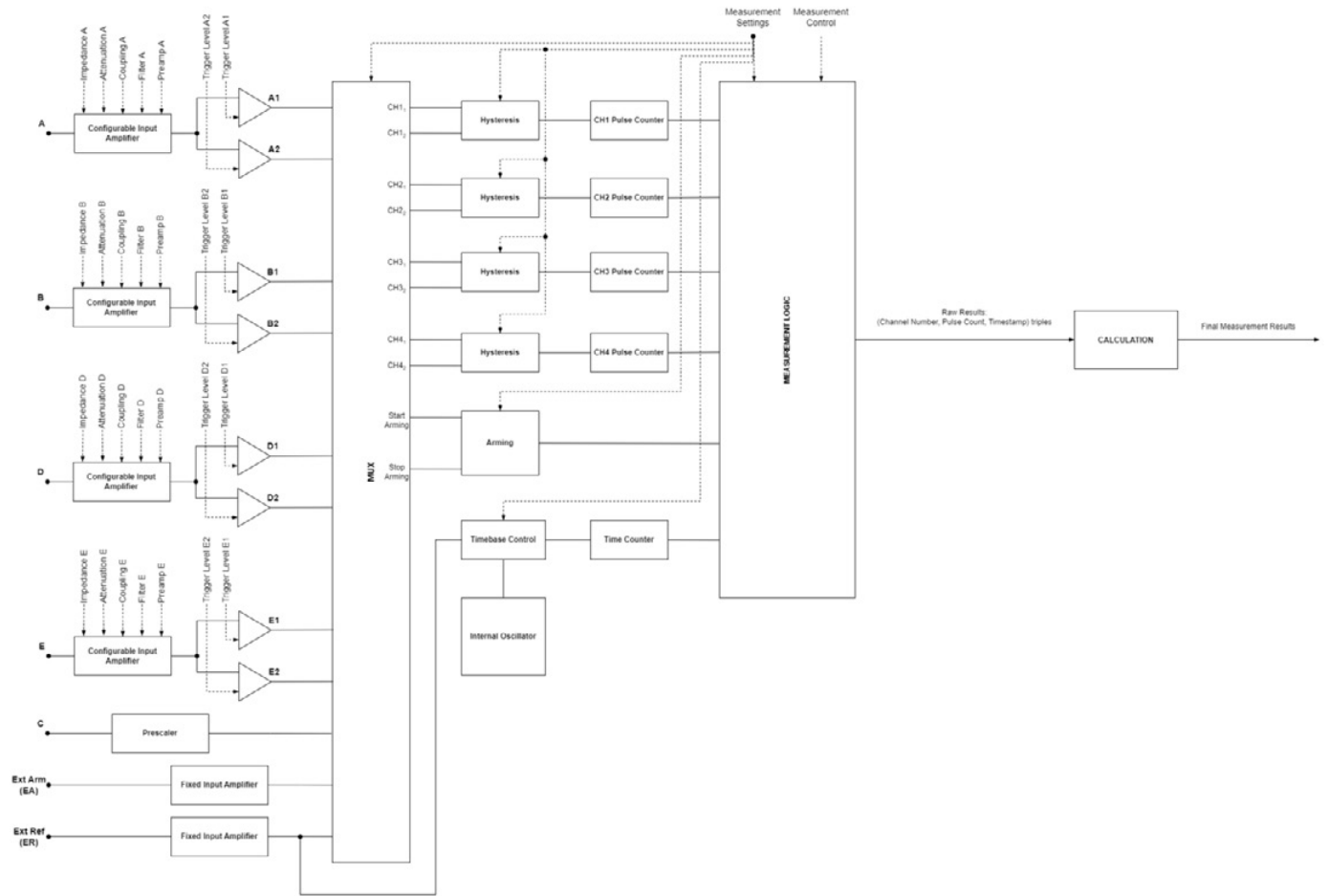


Figure 1. Input signal to Time & Frequency measurement results transformation

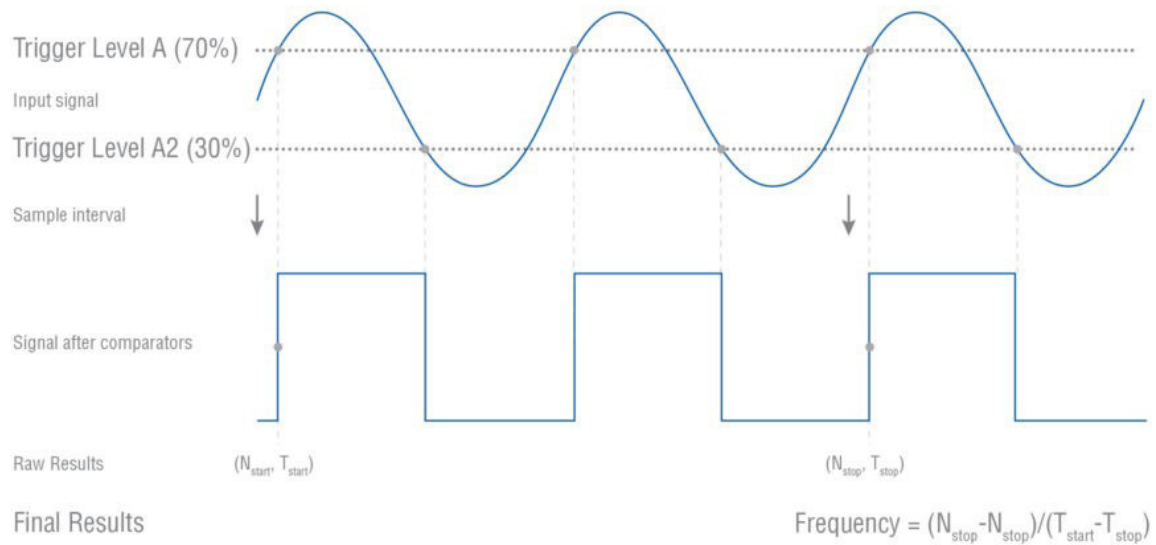


Figure 2. Example of input signal to result transformation for Frequency measurement mode with Wide Hysteresis

4.2. Voltage measurement principles

Measuring voltage of the input signal is available only on inputs A, B, D, E. On each input there are 2 dedicated comparators used to search for signal's lower and upper levels. 4 inputs can be measured in parallel.

Adaptive search algorithm is used which depends on Voltage Mode setting. Each voltage mode implies minimum input signal frequency which the voltage measurement can handle. E.g. in Normal Voltage mode (default) CNT-104S is able to measure voltage of signals with frequencies starting with 100 Hz and above. Allowing lower frequencies makes the voltage measurement slower so it is not recommended to set Voltage mode below Normal unless really needed (one might want to consider using Autoset instead).

Table below summarizes Voltage Modes available in CNT-104S:

Voltage Mode	Minimum Frequency	Average Time to measure 1 voltage sample
Very Slow	1 Hz	15 s
Slow	10 Hz	1.5 s
Normal	100 Hz	450 ms
Fast	1 kHz	65 ms
Very Fast	10 kHz	30 ms

Table 1. Voltage Modes

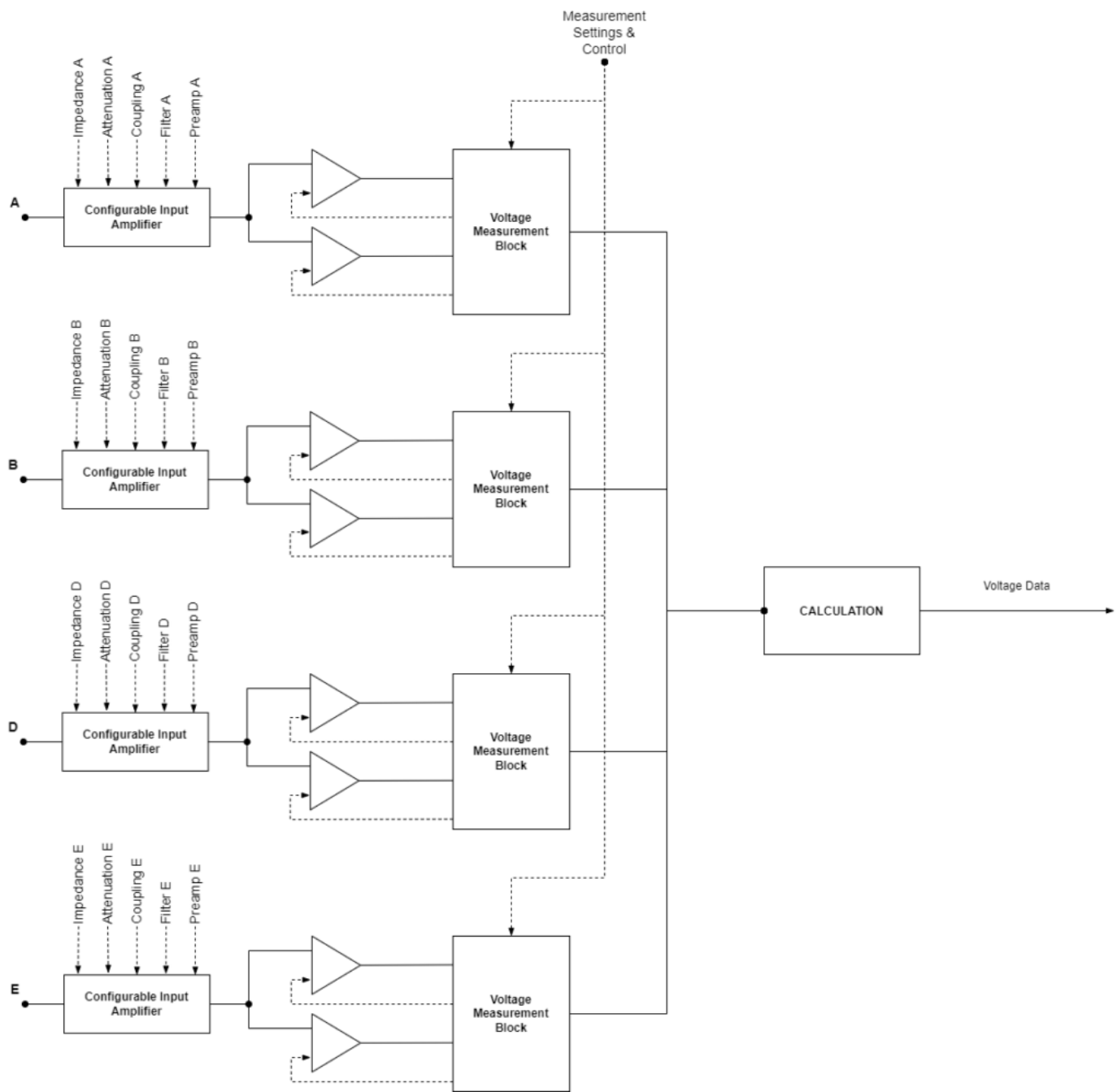


Figure 3. Input signal to Voltage measurement results transformation.

4.3. Sample Interval

On each measurement channel CNT-104S can produce gap-free samples back-to-back as fast as 1 sample per 50 ns which corresponds to setting Sample Interval to 0 s. However, for most cases one doesn't need samples to be generated with such a high frequency, then using non-zero Sample Interval can be considered. In this case samples in each measurement channel will be generated not faster than once per set Sample Interval.

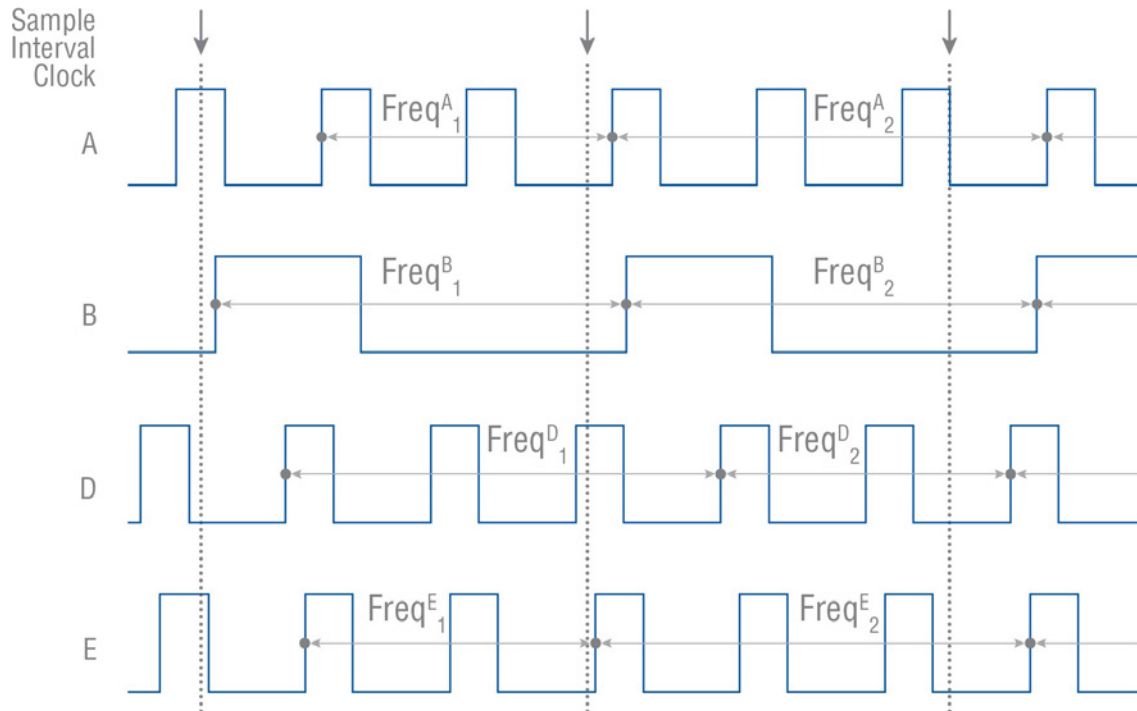


Figure 4. Example of how sample interval works with multi-channel Frequency measurement.

Sample Interval hints:

- Sample Interval clock is not synchronized to signal, meaning actual Sample Interval between 2 consecutive samples can be less or more than Sample Interval set by the user.
- When doing parallel measurement, sample interval is applied to each measured series independently. E.g., when measuring Frequency A, B, D, E and using 1 ms Sample Interval, one will get 1000 Frequency Samples per second from each input.
- Sample Interval for averaging measurement functions (Frequency, Period Average and their Smart alternatives) acts as an averaging gate. The larger the gate (Sample Interval) – the greater the resolution.
- The CNT-104S contains two cascaded memories for result saving. The first is the cache buffer that can hold up to 20000 raw samples with a maximum writing speed of 20 million Samples/s. The second is the main memory, that can hold up to 32 million results, with a maximum writing speed of 12.5 million samples per second, or 80 ns between samples. The data is written to the cache buffer in parallel from up to 4 inputs, meaning the capture speed is independent of the number of inputs used. The data transfer from the fast cache buffer to the slower main memory is done in serial, so the maximum capture speed varies with the number of channels. Setting max number of samples of samples to 20k for a single channel measurement, or 5k for a 4 channel measurement, will guarantee a sampling rate of 20 million values/s, at a sample interval of 50 ns. When setting a larger number of samples, the Sample Interval (given that signal period is less than or equal to the set Sample Interval) must be increased to minimum 80 ns for 1-channel and minimum 320 ns for 4-channel measurements, to avoid cache buffer overflow. If not, the measurement is aborted to avoid data loss.

Example. Measurement function is Frequency A,B,D,E, Sample Interval is 50 ns, Sample Count is set to 10000 and period of all input signals is 50 MHz. 4 measurement channels are used in parallel, each supposed to deliver samples at a rate of 20 million samples per second, which is greater than the speed cache buffer can be fetched with (12.5 million samples). Total number of samples to be generated is $4 \times (10000 + 1) = 40004$ ($N + 1$ raw samples are needed to calculate N frequencies), which is twice greater than measurement logic buffer capacity. So, the buffer will overflow and measurement will be aborted. Solution would be to either increase Sample Interval to 320 ns (4 channels x 80 ns, giving 12.5 million samples per second total) or to decrease Sample Count to 4999 (giving $4 \times (4999 + 1) = 20000$ samples total).

To avoid this situation please watch out for warning text when setting Sample Count and/or Sample Interval or warning icon when choosing measurement function and inputs.

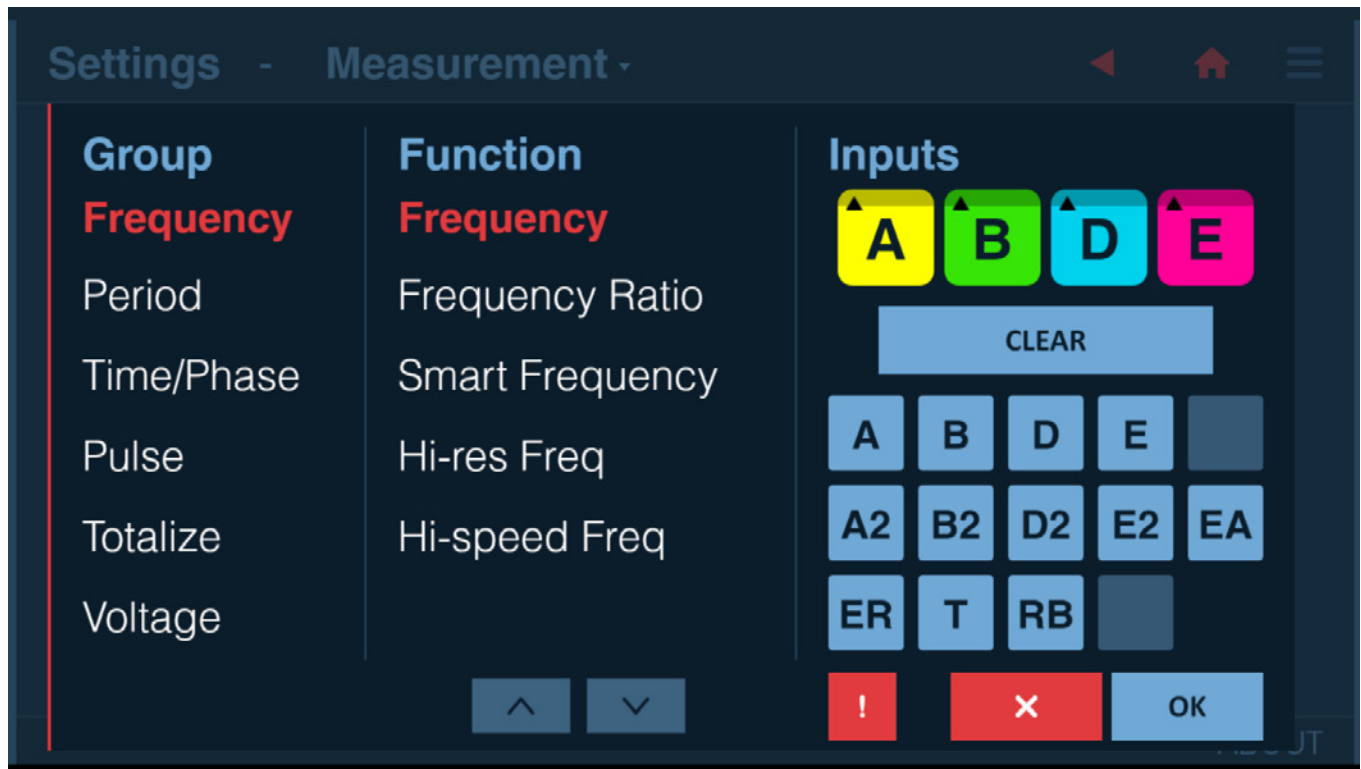


Figure 5. Warning icon on Function/Inputs selection dialog (see clickable red button with exclamation sign to the left of Cancel).

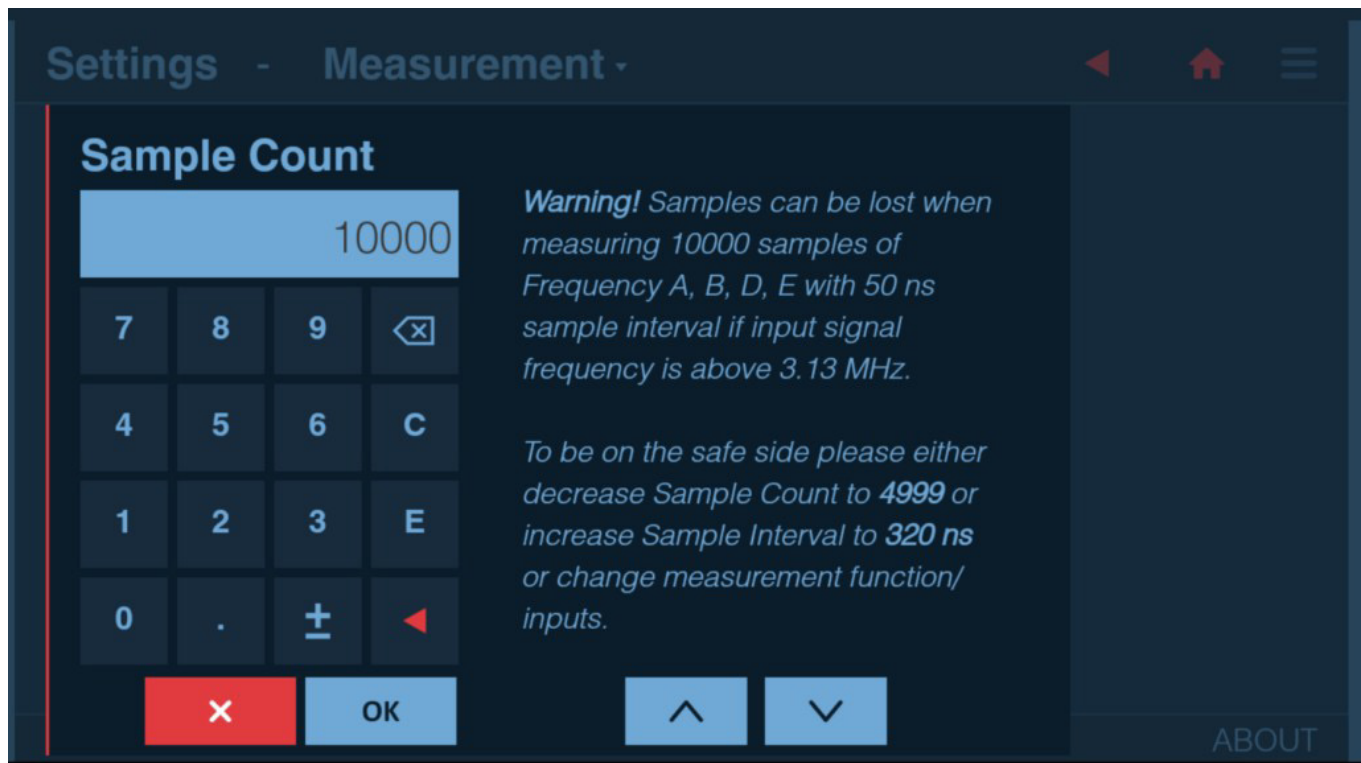


Figure 6. Warning text when editing Sample Count

- When using Sample Interval close to 50 ns, actual sample interval might vary between 50 ns and 100 ns. In case of Time Interval measurement – it can result in generating less samples than was ordered by Sample Count setting. To avoid this please consider setting Sample Interval to 0 if you need minimal sample interval between samples. Setting Time Interval to 0 disables Sample Interval clock, meaning taking samples as fast as possible (close to 50 ns if signal period is 50 ns or greater).
- Sample Interval setting doesn't affect Voltage measurement where interval between samples directly depends on Voltage Mode (please see Voltage measurement principles for details).
- Sample Interval setting doesn't affect manual Totalize measurement where interval between samples is always 100 ms.

4.4. Input signal conditioning/Input Amplifiers

4.4.1. Overview

The input amplifiers are used for adapting the widely varying signals in the ambient world to the measuring logic of the timer/Analyzer.

These amplifiers have many controls, and it is essential to understand how these controls work together and affect the signal.

4.4.2. Configurable amplifiers

Input amplifiers for inputs A, B, D & E are configurable (Inputs section of the Settings dialog) and allow to select a bunch of parameters described in the following sections.

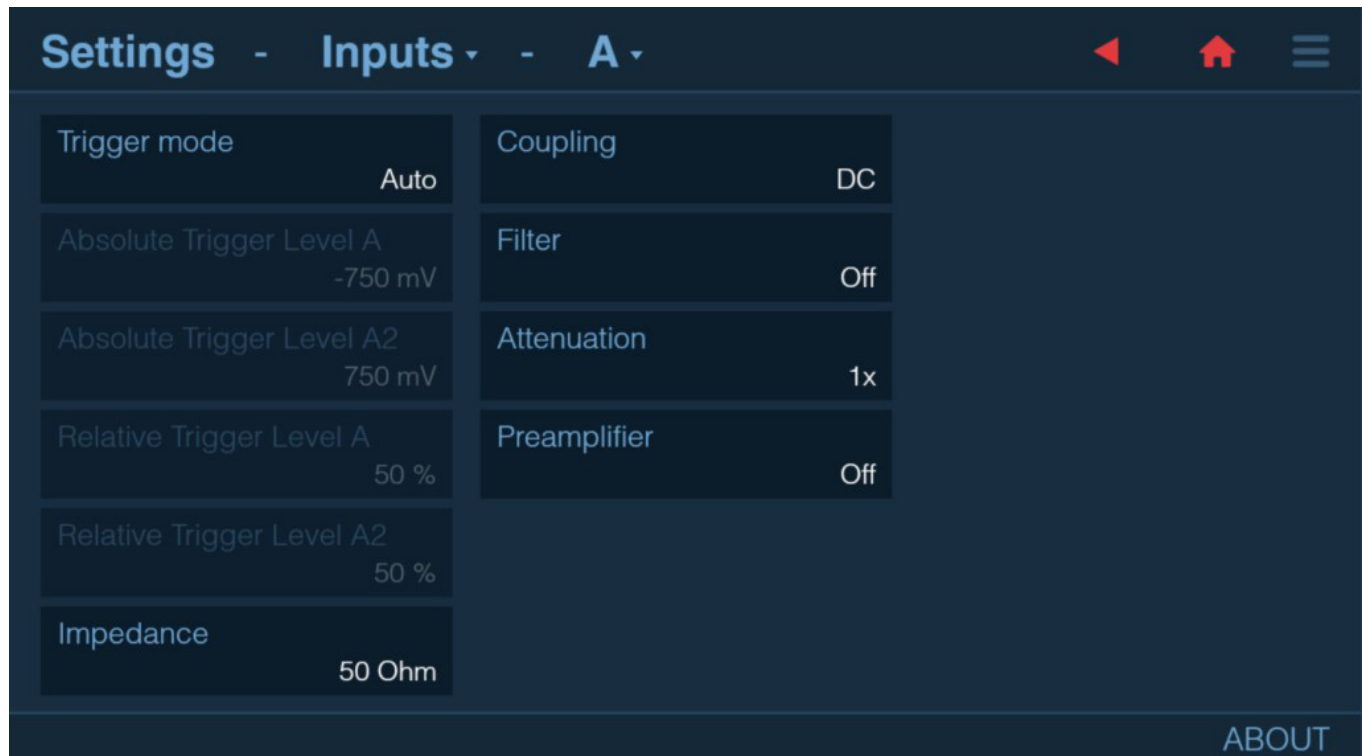


Figure 7. Input amplifiers configuration menu

4.4.2.1. Impedance

Impedance setting allows to match the impedance of the input to signal source. One can choose between 1 M Ω or 50 Ω impedance.



CAUTION: Switching the impedance to 50 Ω when the input voltage is above 12 Vrms may cause permanent damage to the input circuitry.

4.4.2.2. Attenuation

This setting allows attenuating the signal by factor of 10 if its dynamic range exceeds ± 5 V. 1x, 10x and AUTO attenuation options are available. If AUTO is selected then first sample of any voltage measurement (including the ones performed during Autoset and Auto-trigger) will be analyzed to determine the dynamic range of the signal. If the range exceeds ± 5 V then 10x attenuation will be switched on automatically. 1x will be used otherwise.

4.4.2.3. Coupling

Use the AC coupling feature to eliminate unwanted DC signal components or keep DC offset by using DC coupling.

Hint: Always use AC coupling when the AC signal is superimposed on a DC voltage that is higher than the trigger level setting range. However, we recommend AC coupling in many other measurement situations as well. When you measure symmetrical signals, such as sine and square/triangle waves, AC coupling filters out all DC components. This means that a 0 V trigger level is always centered around the middle of the signal where triggering is most stable.

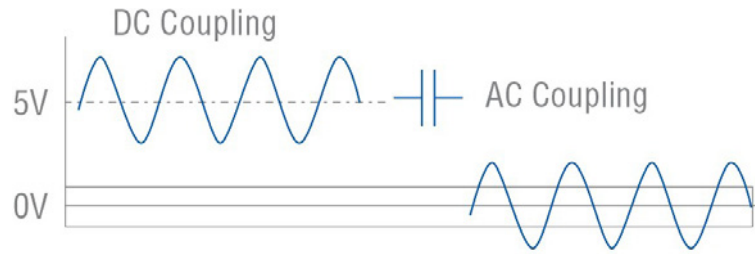


Figure 8. AC coupling a symmetrical signal.

Hint: Signals with changing duty cycle or with a very low or high duty cycle do require DC coupling. Figure 8 shows how pulses can be missed, while Figure 9 shows that triggering does not occur at all because the signal amplitude and the hysteresis band (please see for explanation of what is Hysteresis Band) are not centered.

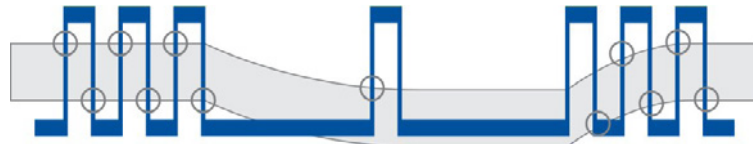


Figure 9. Missing trigger events due to AC coupling of signal with varying duty cycle.



Figure 10. No triggering due to AC coupling of signal with low duty cycle.

Hint: always use DC coupling for signals below 10 Hz.

4.4.2.4. Filter

This setting allows you to apply analog low-pass filter for signals with high-frequency noise or interference. 10 kHz and 100 kHz low-pass filters are available. All filters have a signal rejection slope of approx. 20 dB / decade.

Hint: keep filters off unless you cannot obtain stable readings otherwise.

Hint: it is not recommended to use filters for pulse signals as filters affect pulse signal shape.

4.4.2.5. Preamp

Pre-amplifier allows to amplify the signal to improve sensitivity for signals with amplitudes below 100 mVpp.

Hint: avoid using pre-amplification if signal amplitude is above 100 mVpp. Prefer using Autoset instead – it will turn on pre-amplification only if necessary

4.4.2.6. Trigger Level

Set trigger level. Setting proper trigger level is essential for getting accurate and stable results. So it is advised to keep Trigger Mode Auto letting the instrument select adequate trigger levels. Please see measurement functions description for details.

In Auto and Relative Trigger Modes, the instrument performs voltage measurement (using current Voltage Mode setting) – so-called auto-trigger – before each Time or Frequency measurement which delays the measurement start. In cases when it is undesirable, please use Manual Trigger Mode.

When measuring non-continuous signals or single cycles, auto-trigger might fail to measure signal voltage range correctly which won't allow setting trigger levels properly and might result in wrong measurement results. It is advised to use Manual Trigger Mode in this case.

In Manual Trigger Mode in most cases one can get the best results if Trigger Level is set to the center of signal voltage range. It will help avoid capturing signal edge artifacts and in most cases the middle of the signal voltage range will be the point with maximum slew rate, which minimizes timing trigger error.

Setting trigger level close to signal minimum or maximum level can result in intermittent readings and/or unreliable result. For example, measured Frequency value twice greater or twice lower than actual can be a typical consequence of poor trigger level choice when measuring pulse signals with significant artifacts on edges.

Please note: Actual triggering does not occur when the input signal crosses the trigger level at 50 percent of the amplitude, but when the input signal has crossed the entire hysteresis band (Figure 11). Which causes measurement timing errors.

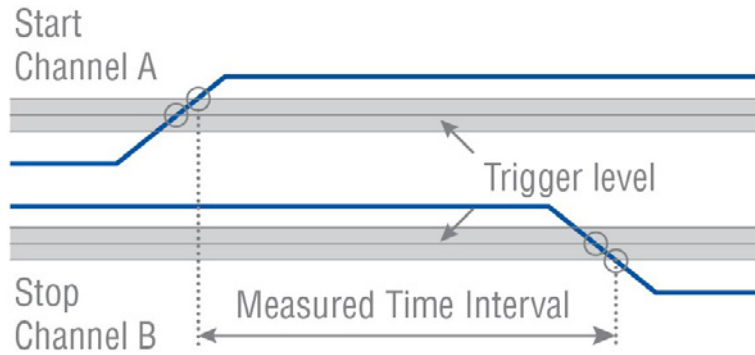


Figure 11. Trigger hysteresis

The hysteresis band is about 20 mV with attenuation **1x**, and 200 mV with attenuation **10x**. The hysteresis compensation reduces hysteresis trigger error to <2 mV

To keep the hysteresis trigger error low, the attenuator setting should be **1x** when possible. Use the **10x** position only when input signals have excessively large amplitudes, or when you need to set trigger levels exceeding the -5 V to +5 V window.

4.4.3. Input Amplifiers with fixed configuration

The following inputs have fixed amplifier parameters:

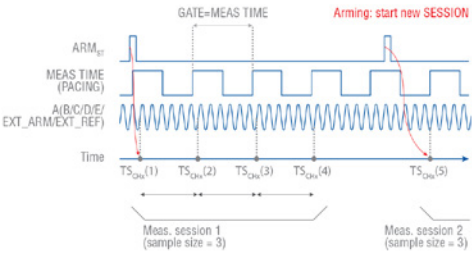
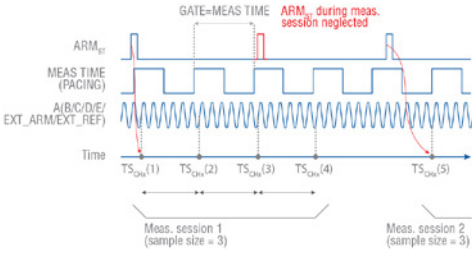
- EA (External Arming) is fixed to 1 k Ω impedance and approx. 1.5 V trigger level;
- ER (External Reference) is fixed to 50 Ω impedance and accepts signals with 0.1 to 5 V_{rms} amplitude;
- C (Prescaler input) is fixed to 50 Ω impedance.

4.5. Arming

Arming, in general, gives the opportunity to start and stop a measurement when an external qualifier event occurs.

Arming can initialize either a single sample acquisition (Arm on Sample) or a single measurement session defined by sample count (Arm on Block). Measurement can be started and stopped by rising or falling edge of signals on instrument's inputs and delayed from 0 ns (delay off) to 2 s with 10 ns resolution step. In case of Totalize measurement mode, timer (set by a combination of Sample Interval and Stop Source set to Timer) can be used as a source of stop arming.

Table 1 shows possible arming modes and their specifics. Modes absent in this table are not supported.

Start Arming Source	Stop Arming Source	Arm on	Measurement Function	Comment
Off	Off	N/A	Any	Arming is not used, measurement is started and stopped normally
Input	Off	Block	Any, except Totalize	<p>Start arming input initialize measurement session (block). Measurement session ends when all samples (number is set by Sample Count) have been collected.</p>  <p>Figure 12. Frequency measurement with measurement session repeated after start arming pulses. Arming start pulses that occur during measurement session are neglected (see).</p>  <p>Figure 13. Frequency measurement with arming start pulses occurring during the measurement session</p>

Input	Input	Block	Any, except Totalize	<p>Start arming starts measurement session (block). Measurement session ends when either all samples (number is set by Sample Count) have been collected or by signal front on stop arming input (whatever comes first).</p> <p>Figure 14. Frequency measurement with measurement session controlled by start and stop arming signals</p>
Off	Timer	Sample	Totalize	<p>Totalize measurement is started by pressing Restart button, Sample Interval defines Totalize Gate length. The Analyzer counts number of events during the gate and produces single sample (1 sample per series).</p>
Input	Timer	Sample	Totalize	<p>Start arming pulses start Totalize Gates (gate length is defined by Sample Interval). Each gate produces 1 sample (per series). Measurement session ends once required number of samples (set by Sample Count) was collected.</p> <p>Figure 15. Totalize measurement in timed mode (stop arming signal set to timer)</p>
Input	Off	Sample	Any, except Totalize	<p>Start arming is used as a pacing clock – single sample measurement is executed just after the arming event.</p> <p>Figure 16. Pulse width measurement with arming signal used as a pacing clock In case of Frequency/ Period Average measurement, samples are measured with dead-time, no back-to-back.</p> <p>Maximum total number of samples is reduced to up to 16 million.</p> <p>Figure 17. Frequency measurement initialized by arming pulses</p>

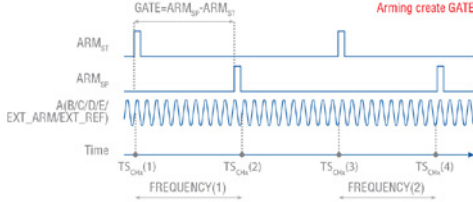
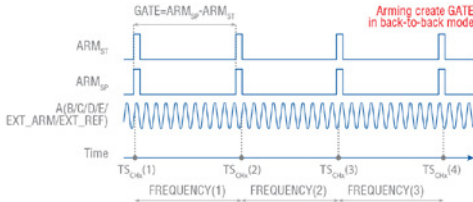
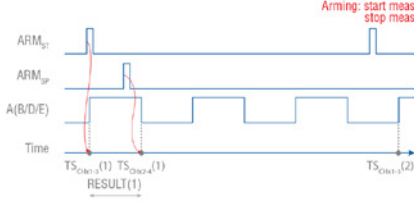
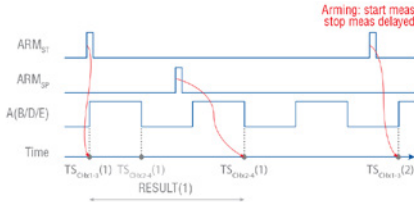
Input	Input	Sample	Totalize, Frequency, Period Average, Smart Frequency, Smart Period Average	<p>Start arming events start Gate (gate length is defined by Sample Interval). Stop arming events end Gate. Each gate produces 1 sample (per series). Measurement session ends once required number of samples (set by Sample Count) was collected. In case start and stop arming settings are not the same, measurements are performed with dead-time, no back-to-back. Maximum total number of samples is reduced to up to 16 million.</p>  <p>Figure 18. Frequency measurement in a gate created by arming signals</p> <p>When arming start and stop conditions are the same, measurements are performed continuously (back-to-back) with no dead-time.</p>  <p>Figure 19. Frequency measurement when arming stop is set the same as arming start (back-to-back measurements) In case Smart versions of Frequency/Period Average are used, each sub-gate (Sample Interval divided by 1000) is being armed, i.e. one sample is calculated using data from 1000 arming gates.</p>
Input	Input	Sample	Any, except Totalize, Frequency, Period Average, Smart Frequency, Smart Period Average	<p>Start arming is used as a pacing clock – a single sample measurement is executed just after active edge of arming pulse. Stop arming delays registration of timestamps other than the first one. Depending on particular measurement mode, two, three or four timestamps are registered that give a single result.</p>  <p>Figure 20. Pulse width measurement with arming on sample and start and stop arming active, case 1</p>  <p>Figure 21. Pulse width measurement with arming on sample, start and stop arming active, case 2</p>

Table 2. Arming modes

Start arming is useful for measurement of frequency in signals, such as the following:

- Pulse modulated RF signals (bursts) Single-shot events or non-cyclic signals.
- Pulsed signals where pulse width or pulse positions can vary. Signals with frequency variations versus time ("profiling").
- A selected part of a complex waveform signal.

Signal sources that generate complex wave forms like pulsed RF, or sweep signals, usually also produce a sync signal that coincides with the start of a sweep, or start of a radar burst. These sync signals can be used to arm the Analyzer. See Figure 21.

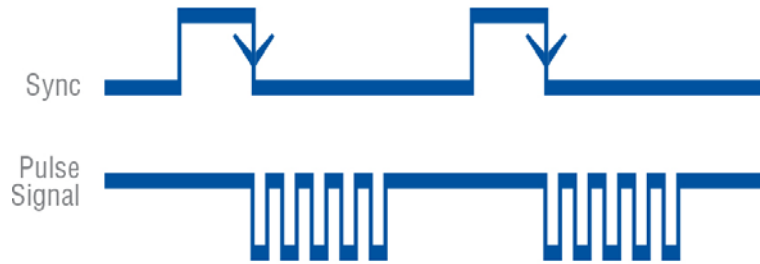


Figure 22. Sync signal used as start arming starts the measurement.

You normally use stop arming together with start arming. That means that the external gating signal controls both the start and the stop of the measurement. Such a gating signal can be used to measure the frequency of an RF burst signal. Here the position of the external gate must be inside a burst. See Figure 22.

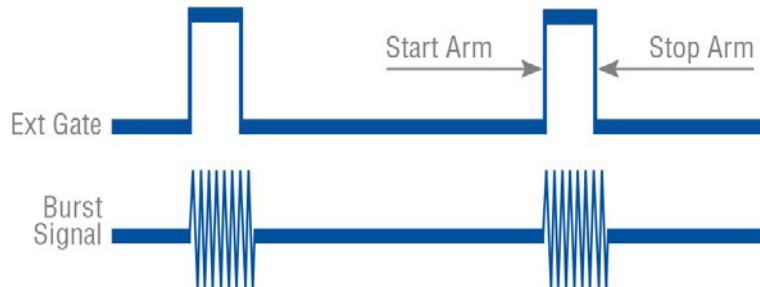


Figure 23. Start and stop arming together is used for burst signal gating.

Note that burst measurements with access to an external sync signal are performed in the normal Frequency mode. In time interval measurements, you can use the stop arming signal as a sort of “external trigger Hold Off signal”, blocking stop trigger during the external period. See Figure 24.

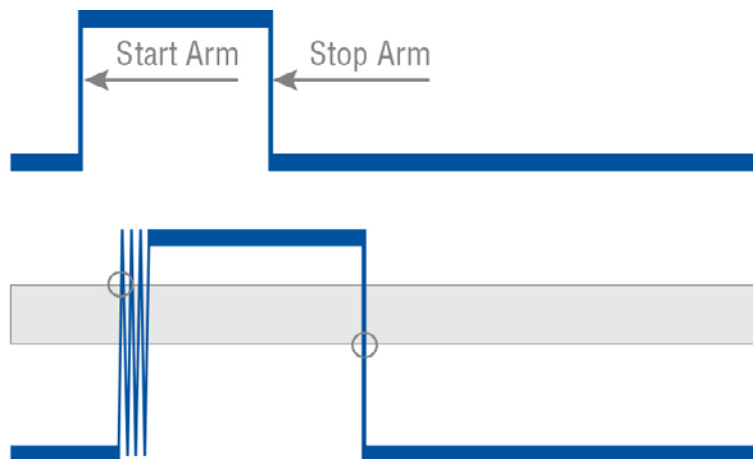


Figure 24. Using start/stop arming as an external Hold-Off

Please note: start arming setup time is up to 5 ns. Which means that the measurement is actually started within 5 ns since start arming event.

5. Measurement Functions

5.1. Frequency/Period

There are several functions suited for measuring Frequency or Period. Next sections provide details about each particular function and when one should be preferred over another.

5.1.1. Frequency/Period Average measurements

These are the most universal measurement functions for Frequency and Period. In this mode each sample is a Frequency/Period value averaged over sample interval (which acts as gate).

This is back-to-back measurement with no dead-time between the samples (see chapter 4.6 Arming for exceptions). 4 input signals can be measured in parallel. Minimal sample interval is 50 ns. Up to 32 million samples total can be measured in a single measurement session. Resolution is 12 digits per 1 s of gate time (Sample Interval).

If the signal period is greater or equal to the set Sample Interval – each signal period can be captured. When measuring Frequency/Period Average on inputs A, B, D, E and Trigger Mode is set to Auto or Relative, wide hysteresis (see details below) is used to improve noise tolerance. In this mode 2 comparators with different trigger levels are used for each input. First trigger level (e.g. Trigger Level A) defines the upper limit of wide hysteresis band and the second one (e.g. Trigger Level A2) defines the lower limit. Trigger Mode Auto sets trigger levels to 60% and 40% of signal's voltage range and Relative allows modifying them to fine tune the hysteresis band.

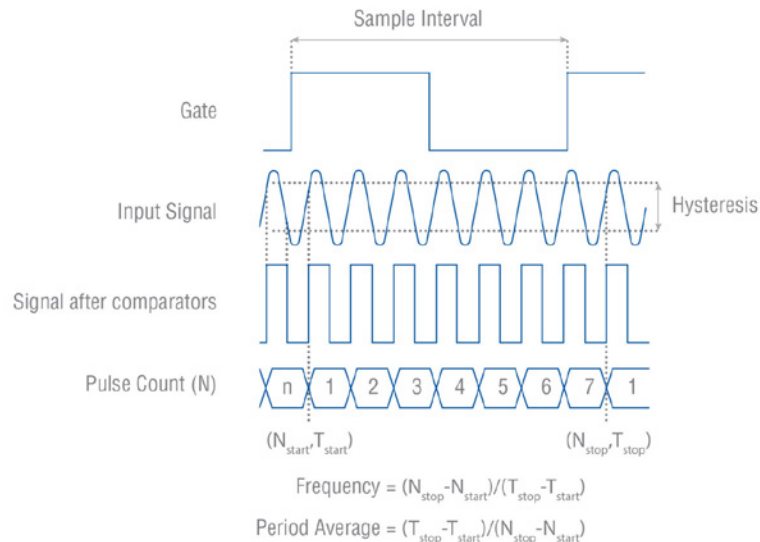


Figure 25. Frequency/Period Average measurement with Wide Hysteresis

Without wide hysteresis, the signal needs to cross the approx. 20 mV in case of 1x Attenuation (200 mV in case of 10x) input hysteresis band before triggering occurs. This hysteresis prevents the input from self-oscillating and reduces its sensitivity to noise. If signal noise is comparable or higher than hysteresis band – it can result in false extra triggering producing erroneous counts. These could ruin the measurement.

Figure 11 shows how spurious signals can cause the input signal to cross the trigger or hysteresis window more than once per input cycle and give erroneous counts. Figure 12 shows that a wide enough hysteresis prevents false counts.

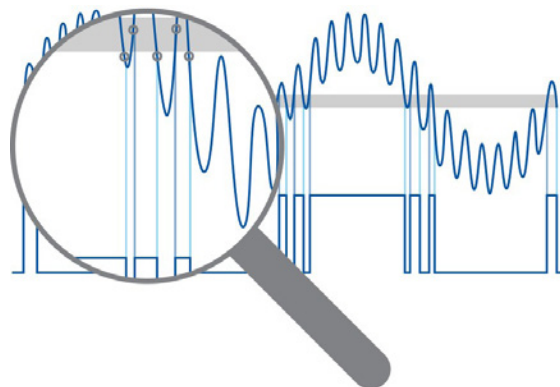


Figure 26. Too narrow hysteresis gives erroneous triggering on noisy signals.

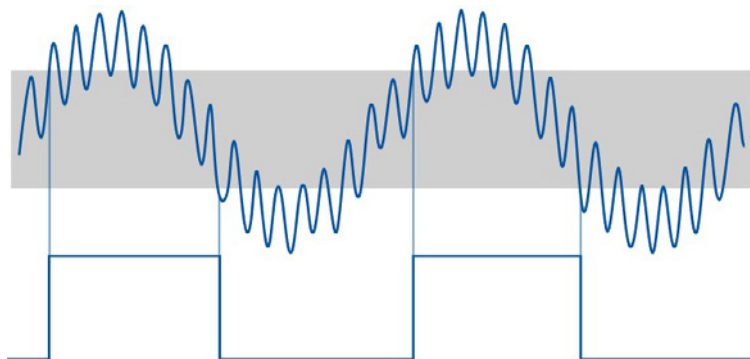


Figure 27. Wide trigger hysteresis gives correct triggering.

5.1.1.1. Frequency C measurement.

With an optional RF input prescaler the Analyzer can measure up to 3, 10, 15, 20, or 24 GHz on Input C. These RF inputs are fully automatic, and no trigger setup is required. Set Sample Interval to achieve optimal compromise between resolution (long Sample Interval) and speed (short Sample Interval). The optional RF input C contains a prescaler that divides the RF signal with an integer value (Prescaler factor), to enable the normal counting circuitry to measure the frequency. The Option 10 (3 GHz) divides by 16, and the option 110/xx (10 to 24 GHz) divides by 64.

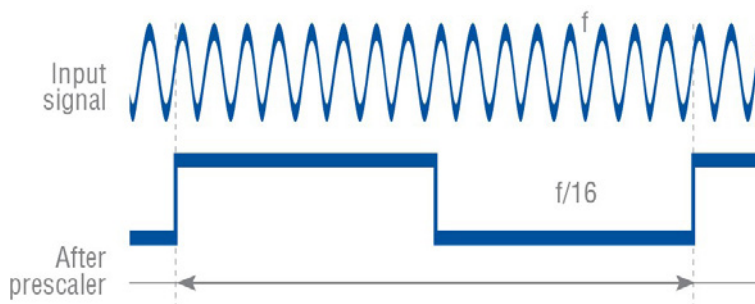


Figure 28. Divide-by-16 Prescaler.

Figure 14 shows the effect of the 3 GHz prescaler. For each 16 input cycles, the prescaler gives one square wave output cycle. An input frequency of let's say 1.6 GHz is divided down to 100 MHz and measured by the normal counting circuitry. The display shows the correct input frequency since the microcomputer compensates for the effect of the division factor.

Prescalers do not reduce resolution. The relative quantization error is the same; 12-13 digits for 1s Sample Interval (Gate Time). See Table 1 to find the prescaler factors.

Function	Prescaling Factor
All input A, B, D, E, EA, ER functions (up to 400 MHz)	1
Frequency C (3 GHz)	16
Frequency C (10, 15, 20, 24 GHz)	64

Table 3. Prescaler factors

5.1.2. Smart Frequency/Period

Smart Frequency/Period is based on the same principle as normal Frequency/Period Average. Measurement gate is divided into 1000 sub-gates, giving additional samples and statistics resolution enhancement algorithm is applied on top of it. Thanks to that it allows to get up to 1 extra digit of resolution per 1 s of gate time (depending on input signal and measurement settings).

This comes with expense of additional constraints though. Minimal possible Sample Interval for Smart Frequency/Period is 50 μ s with possibility to measure up to 32000 samples per measurement session. Setting Sample Interval to 40 ms or more allows to get up to 4290000 samples per measurement session.

This is back-to-back measurement with no dead-time between the samples (see chapter 4.6 Arming for exceptions). 4 signals can be measured in parallel. Wide Hysteresis is used in Trigger Modes Auto and Relative.

Smart Frequency/Period is the best choice when one needs maximal possible resolution and can bear with lower sampling rate and sample count per session.

Please, note: resolution enhancement algorithm is based on the assumption that signal frequency is static. If it is not the case – the algorithm won't be effective and it might make sense to fall back to normal Frequency/Period Average. Please note: section Frequency C measurement. Applies to Smart Frequency C as well.

5.1.3. Period Single

This measurement function is handy if one needs to capture individual periods of continuous signals or single cycles which are less than 50 ns. Individual periods starting from 2.5 ns can be captured.

This is not a back-to-back measurement, meaning that there is a dead-time of 50 ns between the samples if High-Speed license is installed, 1 μ s otherwise. 2 signals can be measured in parallel. Up to 16 million samples total can be measured in a single measurement session.

Unlike Frequency/Period Average and their Smart versions, Period Single doesn't use wide hysteresis. So only one comparator is used on A, B, D, E and Trigger Mode Auto sets trigger level to the middle of signal voltage range (Relative Trigger Level 50%).

Please, note: when measuring non-continuous signal or single cycles, Trigger Mode Auto/Relative might fail to find proper trigger level. One need to fall back to Manual Trigger Mode in this case.

5.1.4. Frequency Ratio

In Frequency Ratio mode, the instrument measures Frequency Average of up to 4 signals in parallel and then divides the resulting frequencies of any two signals.

Since the instruments measures on four input channels in parallel, two frequency ratio values can be displayed in parallel.

This is back-to-back measurement with no dead-time between the samples. 4 input signals can be measured in parallel. Minimal sample interval is 50 ns if High-Speed license is installed, 1 μ s otherwise. Up to 16 million samples total can be measured in a single measurement session.

5.2. Time Interval and Phase

5.2.1. Time Interval

This function allows to measure phase delay between clock signals with the same nominal frequency. At least $N + 1$ signal cycles are needed on each measurement input to get N Time Interval samples.

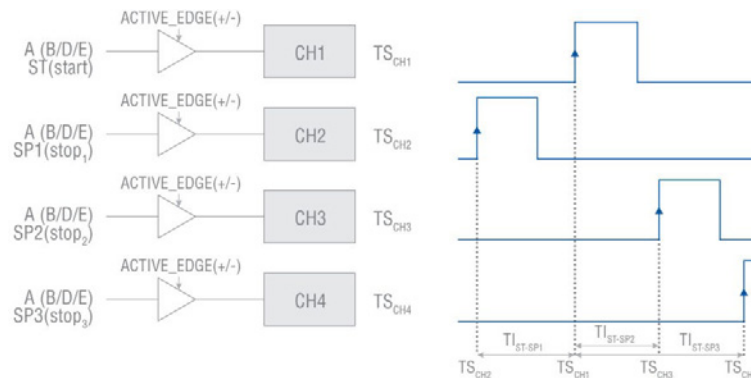


Figure 29. Time Interval Continuous measurement mode

Time intervals in the range $[-1000 \text{ s} .. 1000 \text{ s}]$ can be measured. Resulting values are normalized to always be in the range $[-0.5 * \text{Period} .. \text{Period}]$.

4 input signals can be measured in parallel. Minimal sample interval is 50 ns. Up to 16 million samples total can be measured in a single measurement session.

Please note: Time Interval Continuous is not suitable for measuring time interval between single shot events, use Time Interval Single instead.

When using Sample Interval close to 50 ns, actual sample interval might vary between 50 ns and 100 ns. In case of Time Interval measurement – it can result in generating less samples than was ordered by Sample Count setting. To avoid this please consider setting Sample Interval to 0 if you need minimal sample interval between samples. Setting Time Interval to 0 disables Sample Interval clock, meaning taking samples as fast as possible (close to 50 ns if signal period is 50 ns or greater).

5.2.2. Accumulated Time Interval

Accumulated Time Interval is useful for comparing phase delay between signals with the same nominal frequencies, but when frequencies of individual signals

have small constant offset to each other. Time Interval will gradually increase over time and then drop after reaching value equal to signal Period, thus forming a sawtooth like graph. Accumulated Time Interval corrects this by adding or subtracting signal Period to Time Interval values when necessary. Other than that, it is exactly the same measurement as Time Interval Continuous.

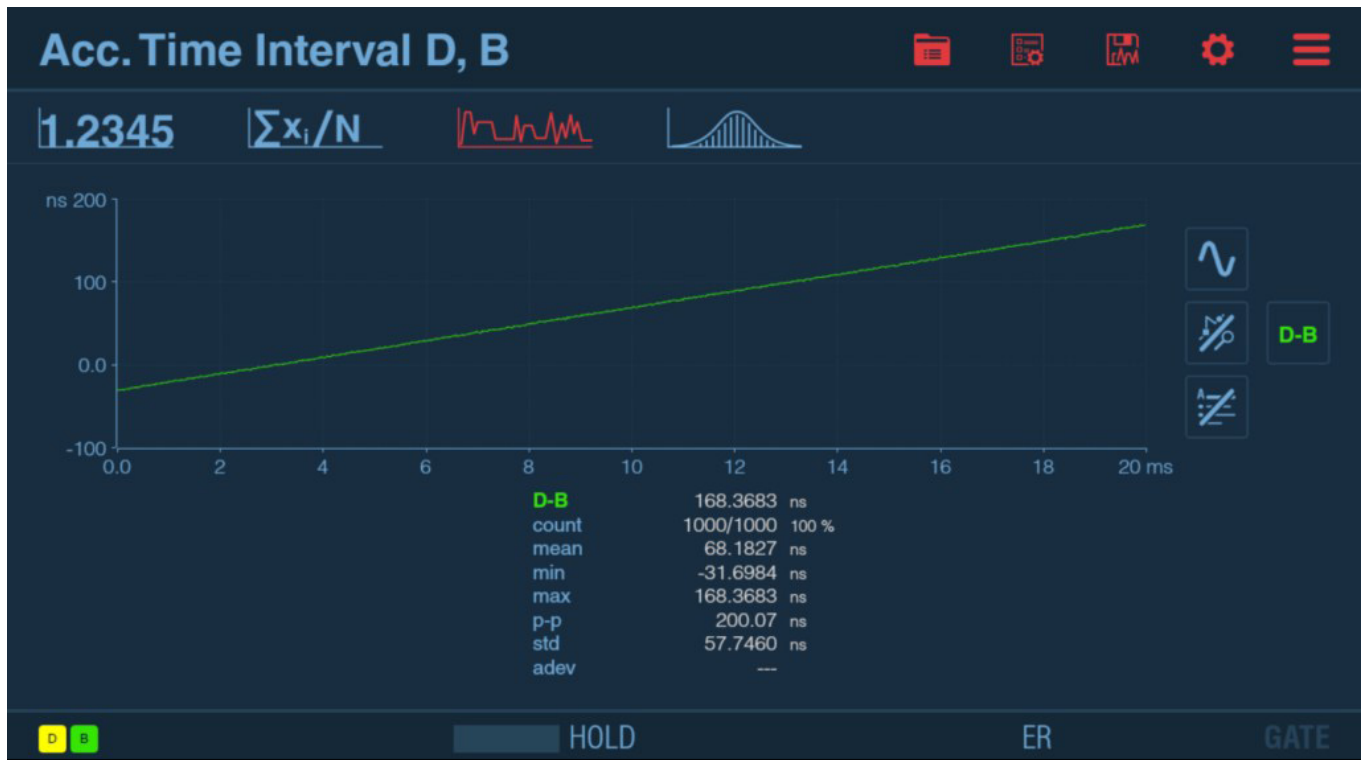


Figure 30. Time Interval Continuous of 2 clock signals with constant frequency offset

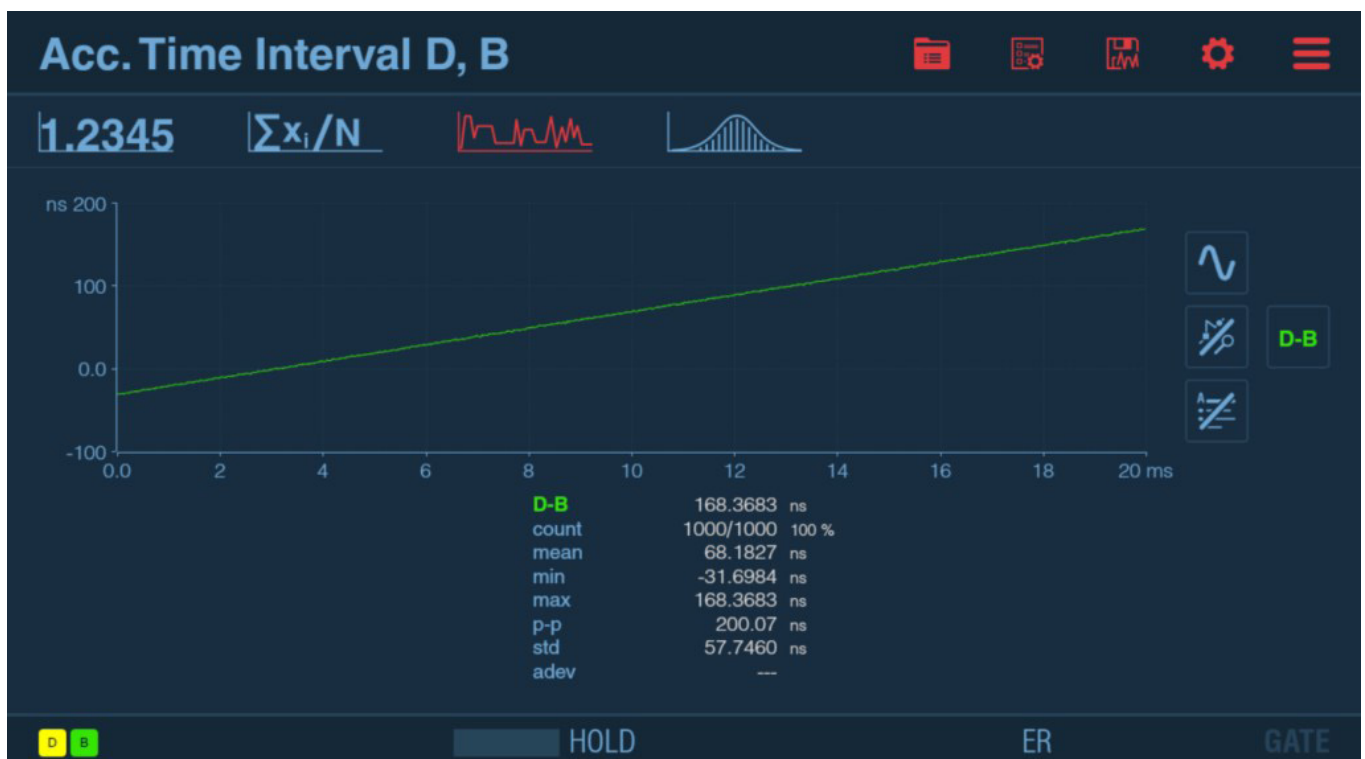


Figure 31. Accumulated Time Interval of the same clock signals

As can be seen on Figure 26 and Figure 27, Accumulated Time Interval gives much better view on relative clock drift over time.

5.2.3. Time Interval Single

This function should be used to measure Time Interval between single events. Sample Interval setting is discarded, samples are captured as fast as it is possible.

Time intervals in the range [-1000 s .. 1000 s] can be measured. Resulting values are not normalized.

4 input signals can be measured in parallel. Minimal sample interval is 50 ns. Up to 16 million samples total can be measured in a single measurement session.

5.2.4. Measuring Time Interval between different trigger points of the same signal

Thanks to the presence of 2 comparators on each of A, B, D, E inputs it is possible to measure Time Interval, Accumulated Time Interval, Time Interval Single, Phase and Accumulated Phase between 2 trigger points inside the same signal.

This can be useful for measuring intervals inside multi-level a signal, e.g. TDR measurement.



Figure 32. Measuring Time Interval between 2 levels of reflected signal in TDR measurement allows to calculate the distance to cable break

Settings
Inputs
A

Trigger mode
Manual trigger levels

Absolute Trigger Level A
-750 mV

Absolute Trigger Level A2
750 mV

Relative Trigger Level A
50 %

Relative Trigger Level A2
50 %

Impedance
50 Ohm

Coupling
DC

Filter
Off

Attenuation
1x

Preamplifier
Off

ABOUT

Settings
Inputs
A

Trigger mode
Manual trigger levels

Absolute Trigger Level A
-750 mV

Absolute Trigger Level A2
750 mV

Relative Trigger Level A
50 %

Relative Trigger Level A2
50 %

Impedance
50 Ohm

Coupling
DC

Filter
Off

Attenuation
1x

Preamplifier
Off

ABOUT

Figure 33. Analyzer configuration for TDR measurement on Figure 28

Another example is measuring time interval from start on input A positive slope to input A negative slope to input B positive slope to input B negative slope. This can be achieved by selecting Time Interval A, A2, B, B2 and specifying trigger levels and slopes accordingly (see Figure 30).

Settings - Inputs - B

Trigger mode

Auto

Absolute Trigger Level B

-750 mV

Absolute Trigger Level B2

750 mV

Relative Trigger Level B

50 %

Relative Trigger Level B2

50 %

Impedance

50 Ohm

Coupling

DC

Filter

Off

Attenuation

1x

Preamplifier

Off

ABOUT

Settings - Inputs - A

Trigger mode

Auto

Absolute Trigger Level A

-750 mV

Absolute Trigger Level A2

750 mV

Relative Trigger Level A

50 %

Relative Trigger Level A2

50 %

Impedance

50 Ohm

Coupling

DC

Filter

Off

Attenuation

1x

Preamplifier

Off

ABOUT



Figure 34. Example configuration for Time Interval A to A to B to B measurement

However, Time Interval A to A to A to A is not possible since that would require 4 different trigger conditions on input channel A, while only 2 comparators are present.

5.2.5. Phase

Phase is similar to Time Interval but with phase delay expressed as angle. This measurement assumes same nominal frequency on all measured inputs. At least $N + 1$ signal cycles are needed on each measurement input to get N Phase samples.

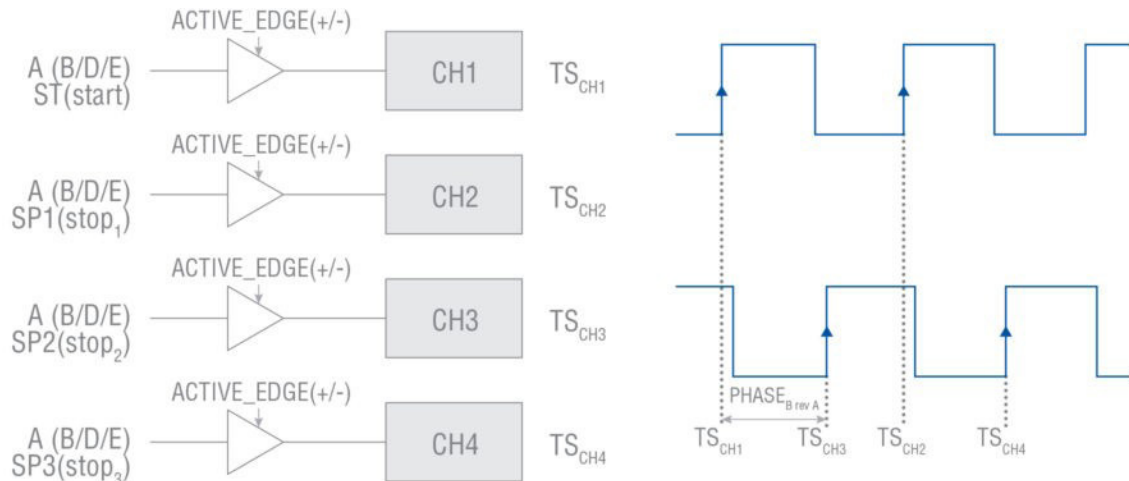


Figure 35. Phase measurement mode

During this measurement, the Analyzer estimates continuous Time Interval and clock Period and calculates Phase as following:

Phase= $360^\circ \times ((\text{Time Interval}) / \text{Period})$ where

Time Interval= $TS_{CH3} - TS_{CH1}$ Period= $TS_{CH2} - TS_{CH1}$

Resulting Phase values are normalized to always be in the range $[-180^\circ .. 360^\circ]$.

2 input signals can be measured in parallel. Minimal sample interval is 50 ns. Up to 16 million samples total can be measured in a single measurement session.

The typical measurement case is to measure the phase shift in various electronic components or systems, for example, filters or amplifiers. In this case, the input A signal is the input signal to the filter/amplifier, and the input B signal is the output signal from the

filter/amplifier. That means that the input A and B signals are typically sine waves, with exactly the same frequency per test point, and the phase should be constant with zero drift (per test point).

Another typical use case is to compare two ultra-stable signals from different sources, but with the same nominal frequency, and express their phase difference in degrees. Then the signal shape could be both sine or pulse, and there is a possibility for a small phase drift between the signals.

5.2.6. Accumulated Phase

The same as for Time Interval, there is an Accumulated version of Phase measurement function to ease drift visualization over time when clock signals in comparison have same nominal frequency with a slow phase drift. But it has no meaning for phase measurements on sources with a more erratic behavior, or when the two frequencies are not the same.

5.3. Time Interval Error (TIE)

Please note: license is needed to unlock TIE option.

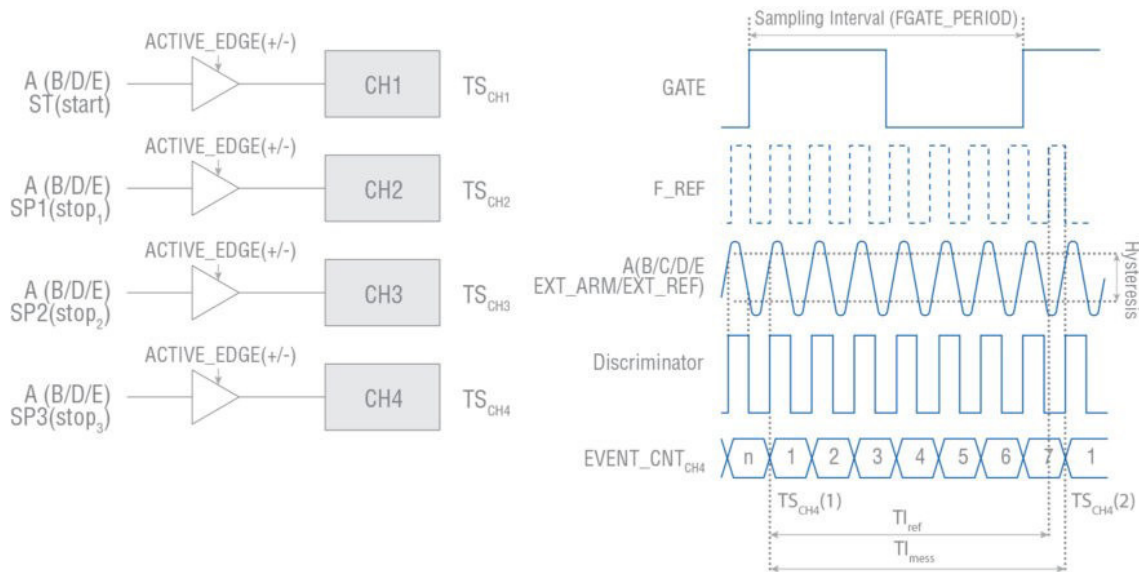
TIE measurement uses continuous back-to-back time-stamping to observe slow phase shifts (wander) in nominally stable signals during extended periods of time. The measurement itself is performed the same way as Frequency/Period Average but different processing is applied.

TIE is only applicable to clock signals, not data signals. Monitoring distributed PLL clocks in synchronous data transmission systems is a typical application.

The nominal frequency of the signal under test can be either manually or automatically set. Auto detects the frequency from the first samples, and rounds to number of digits set by the user (5 by default). TIE is measured as the period deviation of the input signal from the "ideal" reference period, and the accumulated deviation, up or down, is calculated for each Sample Interval, and displayed.

4 input signals can be measured in parallel. Minimal sample interval is 50 ns. Up to 32 million samples total can be measured in a single measurement session.

Resolution is 12 digits per 1 s of gate time (Sample Interval).



$$TIE_{A(B/D/E)}(i) = TS_{CHx}(i) - TS_{CHx}(1) - ((EVENT_CNT_{CHx}(i) - EVENT_CNT_{CHx}(1)) / F_{ref})$$

Figure 36. TIE measurement

5.4. Pulse characterization

5.4.1. Positive and Negative Pulse Width

Positive pulse width measures the time between a rising edge and the next falling edge of the signal. Negative pulse width measures the time between a falling edge and the next rising edge of the signal.

The selected trigger slope is the start trigger slope. The Analyzer automatically selects the inverse polarity as stop slope.

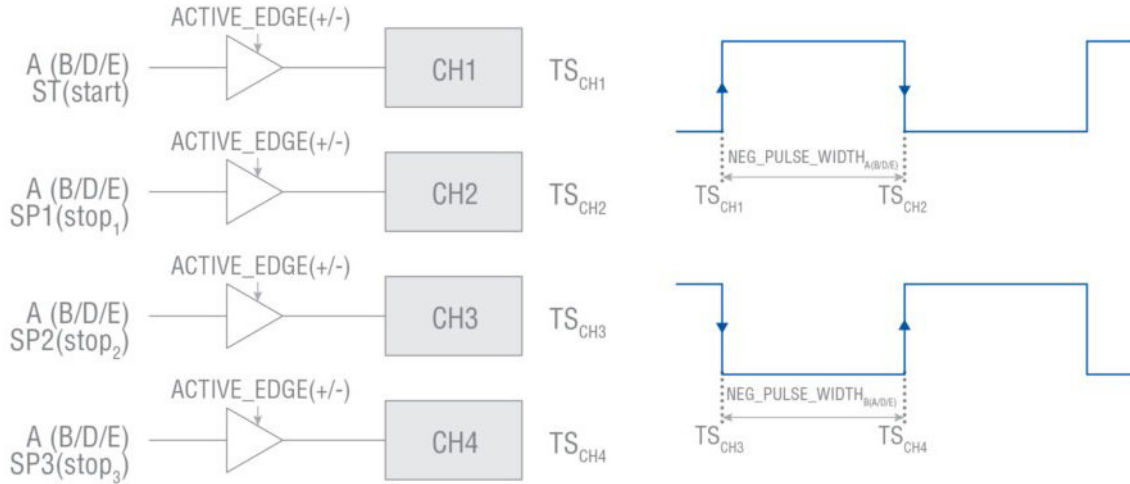
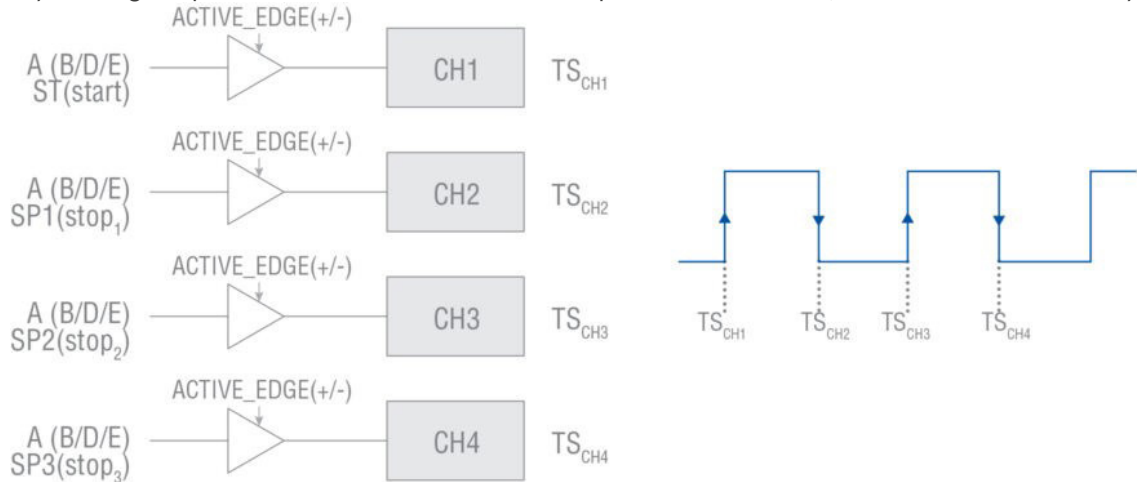


Figure 37. Pulse width measurement

This is not a back-to-back measurement, meaning that there is a dead-time of 50 ns between the samples. 2 signals can be measured in parallel. Up to 16 million samples total can be measured in a single measurement session.

5.4.2. Positive and Negative Duty Cycle

Duty cycle (or duty factor) is the ratio between pulse width and period time. The Analyzer determines this ratio by simultaneously making a pulse width measurement and a period measurement, and calculates the duty factor as:



$$\text{Positive Duty Cycle} = \frac{\text{Positive Pulse Width}}{\text{Period}}$$

$$\text{Negative Duty Cycle} = \frac{\text{Negative Pulse Width}}{\text{Period}}$$

$$\text{Positive Pulse Width} = TS_{CH2} - TS_{CH1}$$

$$\text{Negative Pulse Width} = TS_{CH3} - TS_{CH2}$$

$$\text{Period} = TS_{CH3} - TS_{CH1}$$

Figure 38. Duty cycle measurement

This is not a back-to-back measurement, meaning that there is a dead-time of 50 ns between the samples. 2 signals can be measured in parallel. Up to 16 million samples total can be measured in a single measurement session.

5.4.3. Rise Time, Fall Time, Rise-Fall Time

By convention, rise/fall time measurements are made with the trigger levels set to 10% (start) and 90% (stop) of the maximum pulse amplitude. For ECL circuits, the reference levels are instead nominally 20 % (start) and 80 % (stop). In this case one can use Relative Trigger Levels mode and set trigger levels to 20% and 80% respectively.

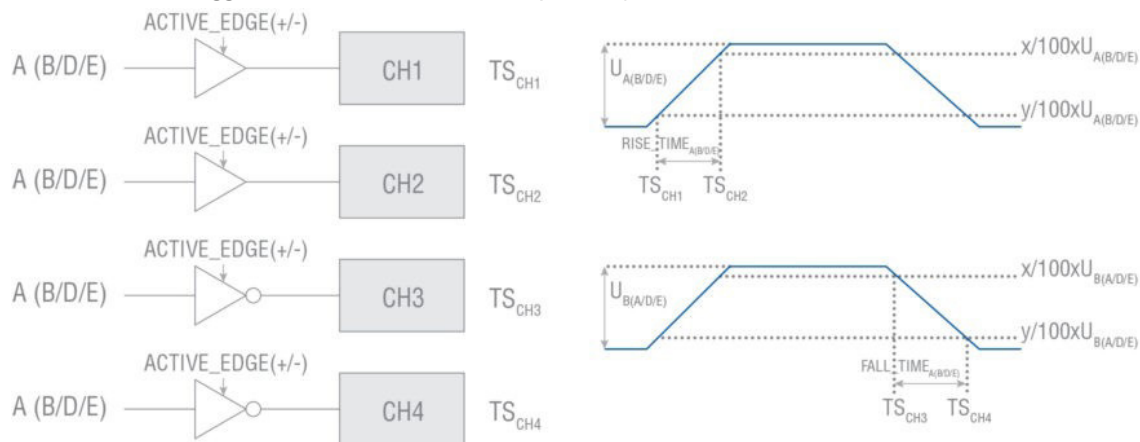


Figure 39. Rise Time and Fall Time measurement

These are not a back-to-back measurement, meaning that there is a dead-time of 50 ns between the samples.

Rise Time and Fall Time functions can measure up to 2 signals in parallel with up to 16 million samples per session total.

Rise-Fall Time function can measure only 1 signal but provides both rise and fall time at once. Up to 8 million samples total can be measured in one measurement session.



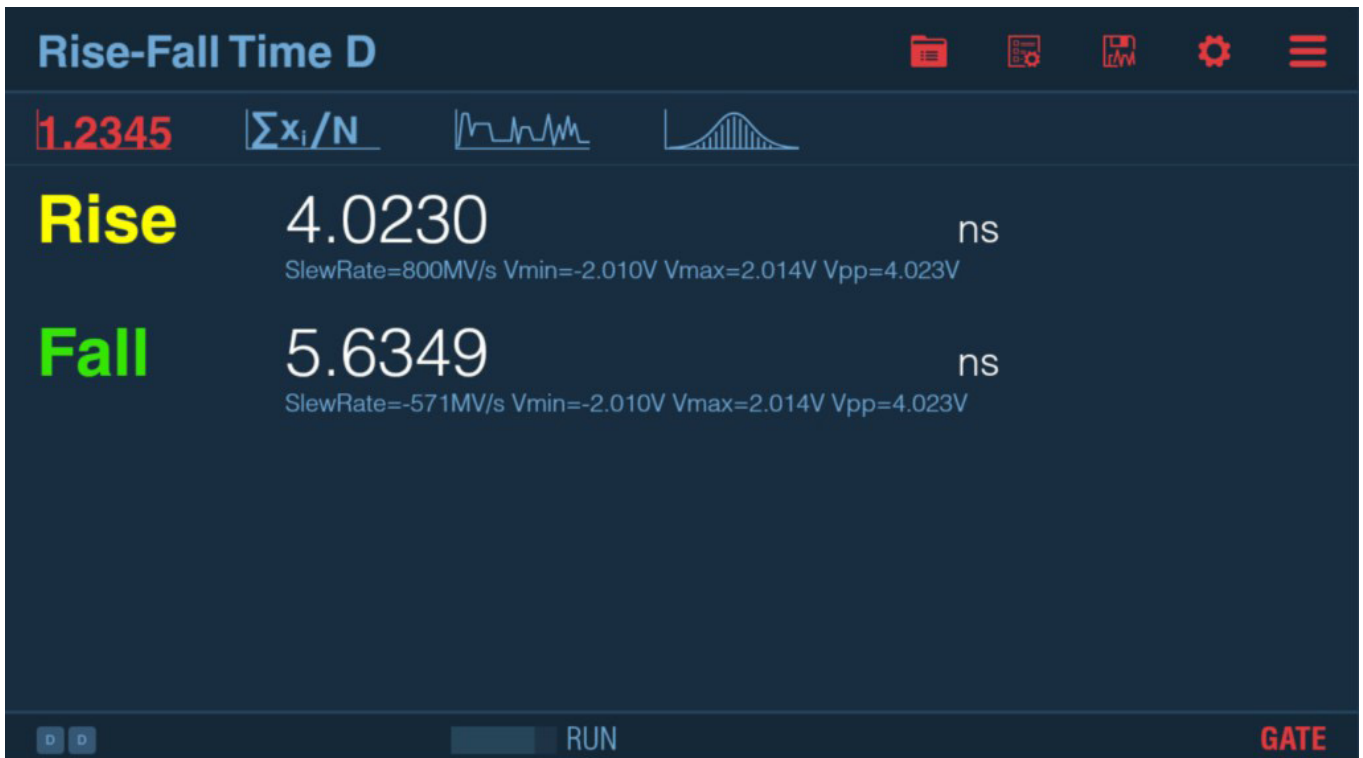


Figure 40. Rise Time vs Rise-Fall Time

5.4.4. Positive and Negative Slew Rate

Slew rate is the speed of voltage change on pulse positive or negative edge. Hence, Positive and Negative Slew Rate are based on Rise Time and Fall Time measurements, the following formulae are applied:1.1.1.

Positive and Negative Slew Rate

$$\text{Positive Slew Rate} = \frac{\text{Rise Time}}{V_{\max} - V_{\min}}$$

$$\text{Negative Slew Rate} = \frac{\text{Fall Time}}{V_{\max} - V_{\min}}$$

5.5. Totalize

Totalize functions count the number of trigger events on Analyzer inputs. There are few modes Totalize can operate in. See next sections for details. In each of these modes the user can choose between Totalize, Totalize X+Y, Totalize X-Y or Totalize X/Y.

5.5.1. Manual Totalize

If neither Start nor Stop Arming is used, Totalize operates in so-called Manual Totalize mode.

In this mode RESTART button start counting trigger events, while HOLD/RUN button is used to pause and resume the counting. Sample Interval setting has no effect, samples are generated each 100 ms.

5.5.2. Timed Totalize

Setting Start Arming Source to Off and Stop Arming Source to Timer enables so- called Totalize Timed Mode.

In this mode RESTART button start counting trigger events for time duration set by Sample Interval (which defines the length of Totalize Gate). Single sample is generated after the end of the Gate.

5.5.3. Armed Totalize

If both Start Arming Source and Stop Arming Source are set, then start and stop arming events define start and stop of Totalize Gate for each Sample (Arm On setting is ignored, the Analyzer uses arming in Sample implicitly).

See 4.6 Arming for details on this Totalize mode.

5.6. Voltage

The Analyzer measures the voltage by searching the minimum and maximum signal levels. See 4.2 Voltage measurement principles for details.

Vmin, Vmax and Vpp functions allow measuring voltage on 4 inputs in parallel, Vminmax allows only one input but provides both – min and max – at the same time. Resolution is 1 mV, up to 16 million samples can be acquired in one measurement session.

6. Measurement cheat-sheet

6.1. Generic hints

- Whenever you find yourself in trouble while setting up the measurement – use Autoset:
 - Connect the signals, Choose measurement function/inputs, Choose Sample Count and Sample Interval,
 - Press Autoset button,

And it will find proper settings for most cases when measuring continuous signals.

- Use Auto choice for settings items unless you understand the implications of selecting other option.
- Settings → User Option → Recall Defaults will reset measurement settings to Defaults.
- Save complex measurement configurations as Presets (Settings → Measurement Presets or dedicated icon on measurement screen). In this case you can easily recreate the same measurement setup if you need it later.
- Make sure input circuits are setup appropriately:
 - Use Auto-trigger for signals above 100 Hz, otherwise make sure Absolute trigger level is set. appropriately (prefer using Autoset for low frequency signal – it will set trigger levels for you). Make sure input impedance is set correctly. Use only DC coupling for low frequency signals and rely on Autoset to setup proper trigger levels. Keep Preamp OFF, except for extremely low input signal levels (below 50 mVrms). Keep Attenuation 1x, except for signals with amplitudes above exceeding +/- 5V.
 - Keep Filter OFF, except for low frequency sine wave signals (below 100 kHz).
- Settings → Advanced → Voltage Mode should be set to Normal, except for signals below 100 Hz. For signals below 100 Hz please use Autoset to let the counter select best voltage mode for you. Set Voltage mode explicitly only if Autoset fails to find appropriate instrument setup (e.g. for not continuous signals)

6.2. Measuring 1 PPS

Hints:

- Set DC on inputs 1 PPS signals are connected to,
- Select measurement function and inputs,
- Set Sample Interval to 0,
- Use Autoset or set Trigger Mode to Manual and set Trigger Level to the middle of 1 PPS signal voltage range.

Same is most of the time true for signals below 100 Hz.

6.3. Measuring single cycles or pulses

Hints:

- Set DC on the inputs, which the signals are connected to,
- Select:
 - Period Single for measuring single cycle frequency period, or
 - Time Interval Single for measuring intervals between events, or
 - Totalize for counting events, or
 - Any function from Pulse group for measuring pulse characteristics.

Please note: using other functions will not give reliable results for single cycles/pulses.

- Set Trigger Mode to Manual and set Trigger Level to the middle of signal voltage range.

Please note: auto-trigger won't work for single cycles/pulses.

6.4. Measuring Frequency/Period

See 6.2 Measuring 1 PPS if signal is below 100 Hz.

Hints:

- The basic setting Sample Interval in the Measurement menu is central to all Frequency related measurement. This setting means the same as Measuring time, or Gate time, used by other counter manufacturers.
- A long Sample Interval (Gate time) increases resolution (counting during a longer time) but decreases measurement speed. The Sample Interval is always a compromise between how many digits you want to read, and how fast you want to take your frequency samples. For normal bench use – 200 ms is a good choice, because it is hard for the eye to follow faster changes in the displayed value.
- The CNT-104S will give 12-13 digits resolution with 1 s Sample Interval, 9 digits with 1 ms Sample interval, and 6 digits with 1 μ s Sample Interval
- Use AC Coupling because possible DC offset is normally undesirable. Use Trigger Mode Auto and/or Autoset.
- Use Preamp ON for signals with amplitudes below 200 mVpp.

Please note: amplifying the signal also amplifies the noise.

- Sample Interval of 200 ms is a reasonable tradeoff between measurement speed and resolution on the bench.

6.5. Time measurements of continuous signals

Hints:

- Use DC coupling.
- High signal level, and Steep signal edges.

6.6. Jitter measurements

Statistics provides an easy method of determining the short term timing instability, (jitter) of pulse parameters.

Note: that the measured pulse parameter should be a single cycle value, whether it is period, or pulse width.

6.6.1. Single cycle jitter

Single cycle jitter made on random samples of single periods, is usually specified with its rms value, which is equal to the standard deviation based on single measurements. The Analyzer can then directly measure and display the rms jitter. Jitter can also be expressed as peak-to-peak value, which is also displayed in the Statistics screen.

6.6.2. Cycle-to-cycle jitter

Cycle-to-cycle jitter demands zero dead-time measurements without gaps and can be made on input signals with a jitter frequency of up to 20 MHz. There is currently no dedicated measurement function, but the raw data of a Period Average measurement, with Sample Interval of 0 or down to 50 ns, could be exported to e.g. Matlab or Excel for “number crunching” and analysis.

6.6.3. Wander measurements

Wander measurements, which is a “slow jitter” measurement with jitter frequencies <10 Hz is made by using the TIE function, which compares the accumulated period phase drift, with the ideal phase from an ideal clock.

6.6.4. Deterministic jitter

Deterministic jitter is revealed in the Distribution graph, which will show underlying noise sources in a clear way. For example a sine modulated noise source would give a bathtub shape, a pulse modulated noise source would give a twin peak shape, and a measurement of a source containing not one, but two, fundamental frequencies will be displayed as “double hump”.

6.7. Frequency Modulated Signals

A frequency modulated signal is a carrier wave signal (CW frequency = f_0) that changes in frequency to values higher and lower than the frequency f_0 . It is the modulation signal that changes the frequency of the carrier wave.

The Analyzer can accurately measure:

- f_0 = Carrier frequency.
- f_{dev} = Frequency deviation = $(f_{max} - f_{min})/2$. And via the timeline graph, you will also get a good indication of the modulation frequency f_{mod}

6.7.1. Initial capture settings

The optimum settings is to find a balance between large enough sample intervals to achieve high resolution per individual frequency sample, max. 10% of the Frequency deviation.

And small enough Sample intervals to capture enough frequency samples per modulation cycle for good graph visibility.

A rule of thumb is that the number of samples per modulation cycle should be

>10, for good graphical view of the modulation signal, and acceptable error of f_{max} and f_{min}

Example: 10 kHz modulation frequency (100 μ s modulation cycle) of a 200 MHz carrier with 200 kHz deviation (0.1% modulation).

Set Sample interval to 10 μ s (10% of the modulation cycle). Set Sample Count (N) to 100 (to cover 10 modulation cycles).

Now every frequency sample will have a resolution of $(10 \mu\text{s}/10 \mu\text{s}) \times 200 \text{ MHz} = 200 \text{ Hz}$.

This resolution is 1000 times better than the frequency deviation.

Start measurement and view the Timeline graph, which will show 10 modulation cycles, with 10 samples per modulation cycle.

To improve the graphical experience, lower Sample Interval to 1 μ s (1% of the modulation cycle), and increase Sample Count to 1000.

Now each frequency sample has a resolution of $(10 \mu\text{s}/1 \mu\text{s}) \times 200 \text{ MHz} = 2 \text{ kHz}$. Still with a lot of margin to deviation.

You may want to play around with the Sample Interval and Sample Count setting until you have found your optimum view of the FM signal (no of displayed mod. cycles).

6.7.2. Carrier Wave Frequency f_0

To determine the carrier wave frequency, just look at f_{mean} which is best approximation of f_0 .

Ideally the sum of all Sample Intervals should be selected to cover an integer number of modulation periods. This way the positive frequency deviations will compensate the negative deviations during the measurement.

Example: If the modulation frequency is 1 kHz, the Sample Interval 10 μ s and $N = 1000$ will make the Analyzer measure exactly 10 complete modulation cycles. A bad combination of Sample Interval and N would worst case mean that exactly half a modulation cycle is uncompensated for, giving a max. error for a sine modulation of:

$$f_0 - f_{mean} = \Delta f_{max} / (\text{sample int.}) \times N \times f_{mod} \times \pi$$

For very accurate measurements of the carrier wave frequency f_0 , make an extra measurement session and set Sample Interval as close as possible to an integer number of modulation cycles, and increase the number of samples substantially. A worst case error of half a modulation cycle means far less in a million cycles compared to 10 cycles.

6.7.3. Frequency deviation $f_{max} - f_0$

Read the max, min, and mean frequency values from statistics screen or beneath the graph and calculate f_{dev} as either:

- $f_{max} - f_{mean}$
- $f_{mean} - f_{min}$
- $f_{p-p}/2$

These three values should be exactly the same for an ideal sine wave or square wave modulation.

6.7.4. Modulation frequency f_{mod}

The modulation frequency is easiest found by visual estimate in the graph on screen by using Cursors. Place one cursor on the beginning of the first modulation cycle and the other – on the end of the last modulation cycle. If the end point time difference between cursors is T seconds and the exact integer number of modulation cycles between cursors is M , the modulation frequency is: $f_{mod} = M/T$

6.7.5. Errors in f_{max} , f_{min} , and f_{p-p}

A too large Sample Interval compared to the modulation cycle time leads to an averaging error that will underestimate the true deviation. A Sample interval corresponding to 10% of the modulation cycle, or 36° of the modulation signal, leads to an error of approx. 1.5%.

If that error is not acceptable, decrease the Sample Interval to make more samples than 10 during the modulation cycle.

6.8. Frequency profiling

Profiling means measuring and plotting frequency variation versus time. Examples are measuring warm-up drift in signal sources over hours, measuring the linearity of a frequency sweep during seconds, VCO switching characteristics during milliseconds, or the frequency changes inside a “chirp radar” pulse during sub- microseconds.

The Analyzer can handle many profiling measurement situations with some limitations. In profiling applications, the Analyzer acts as a fast, high-resolution sampling front end, storing results in its internal memory. These results are later displayed on screen and/or transferred to the controller for analysis and graphical presentation.

You must distinguish between two different types of measurements called free- running and repetitive sampling.

6.8.1. Free-Running Measurements

Free-running measurements are performed over periods down to the sub- microseconds range, e.g., to measure initial drift of a signal generator or oscillator, to plot linearity of a sweep signal ramp, or to measure short-term stability down to microsecond averaging times. In these cases, measurements are performed at user-selected Sample Intervals, and performed as gap-free measurements in the range 50 ns to 1000 s.

Just start the block measurement and view the profile in the graph presentation mode.

6.8.2. Repetitive Sampling Profiling

The measurement setup just described will not work when the profiling demands less than 50 ns intervals between samples.

How to do a VCO step response profiling with 50 samples during a time of 1 us.

This measurement scenario means that you need to come to 20 ns between samples (50 points * 20 ns = 1 ms observation time).

You will need a repetitive input step signal, and you have to repeat your measurement 50 times, taking one new sample per cycle. And every new sample should be delayed 20 ns with respect to the previous one.

Profiling can theoretically be done manually, but the best would be to perform this series of measurements with a dedicated program on PC, controlling the Analyzer and collecting data from it remotely.

The following are required to setup a measurement:

A repetitive input signal (e.g., frequency output of VCO). An external SYNC signal (e.g., step voltage input to VCO). Use of start arming delay (20, 40, 60 ns, etc).

See Figure 38 for a test setup diagram.

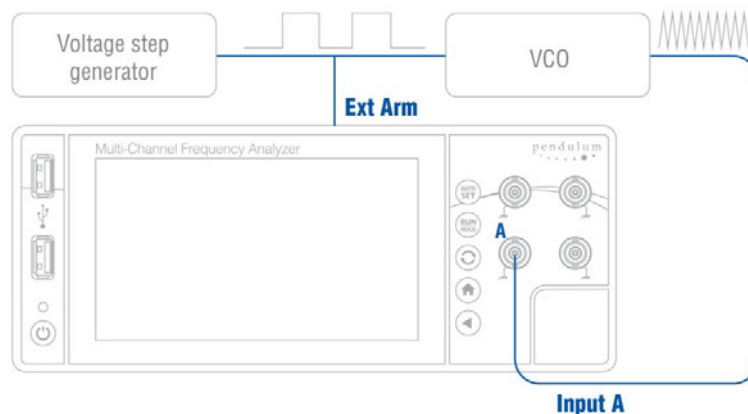


Figure 41. Setup for transient profiling of a VCO.

6.8.3. V_{rms}

When the waveform (e.g. sinusoidal, triangular, square) of the input signal is known, its crest factor, defined as the quotient (Q_{CF}) of the peak (V_p) and RMS (V_{rms}) values, can be used to set the constant K in the mathematical function $K \cdot X + L$. The display will then show the actual V_{rms} value of the input signal, assuming that V_{pp} is the main parameter.

$$V_{RMS} = \frac{1}{2 \times Q_{CF}} \times V_{pp}$$

Example: A sine wave has a crest factor of 1.414 ($\sqrt{2}$), so the constant in the formula above will be 0.354.

7. Other features

7.1. Hold-off

Hold-off function allows to insert dead-time into input trigger circuit which effectively acts as a digital lowpass filter. Hold-off can be set to 0 (Hold-off OFF) or in the range [20 ns .. 2.683 s] which correspond to low-pass filter frequency from 100 MHz down to 0.5 Hz. Setting Hold-off to approx. 75% of the cycle time of the signal allows to inhibit erroneous triggering for noisy signals.

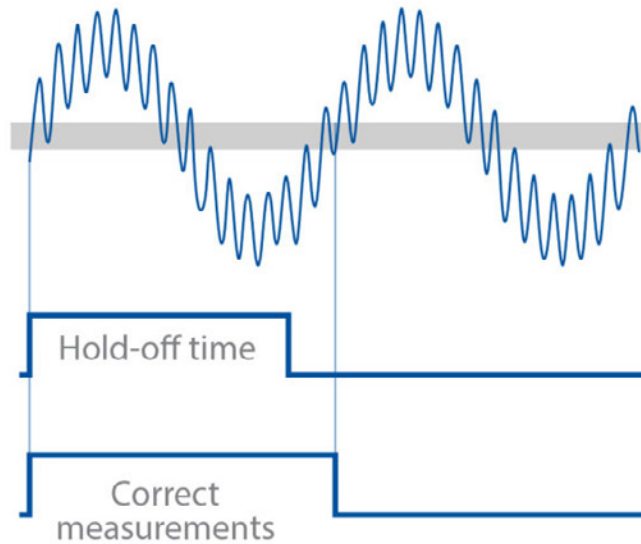


Figure 42. Using hold-off as a Digital LP filter to cope with erroneous triggering on noisy signal

Hold-off is also an effective measure to cope with contact bouncing on the front of the signal under test.

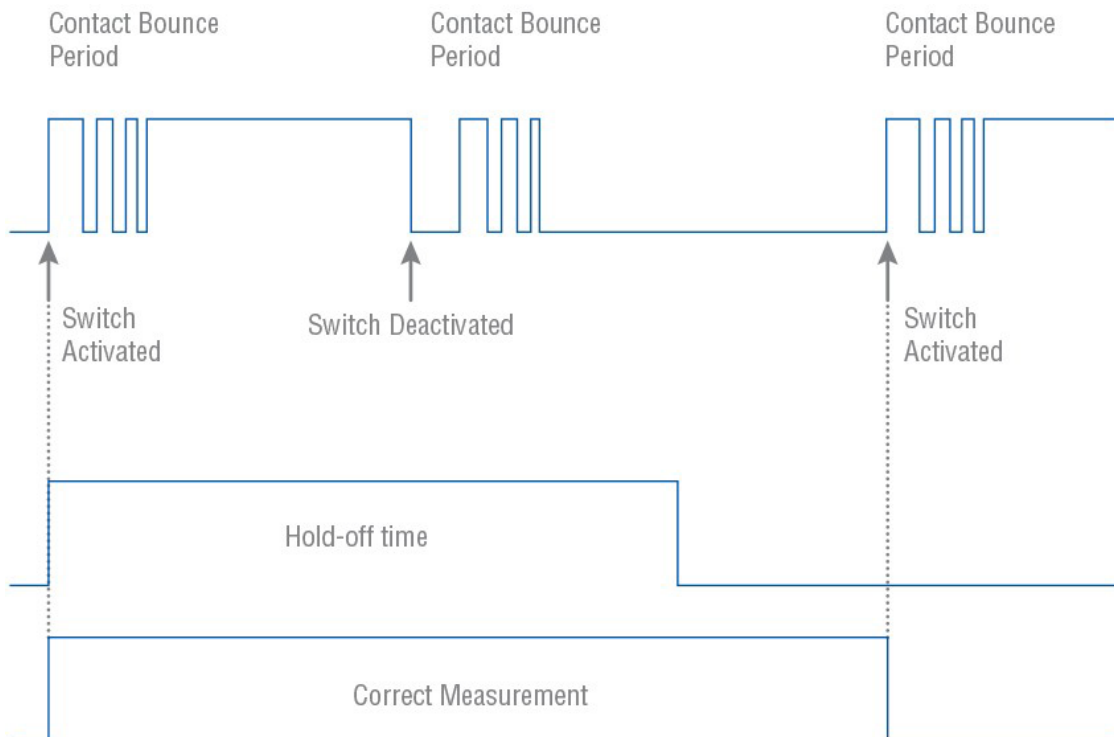


Figure 43. Using Hold-off to cope with switch bounce effect



You should be aware of a few limitations to be able to use the Hold-off feature effectively and nambiguously. First you must have a rough idea of the frequency to be measured. A cutoff frequency that is too low might give a perfectly stable reading that is too low. In such a case, triggering occurs only on every 2nd, 3rd or 4th cycle. A cutoff frequency that is too high (>2 times the input frequency) also leads to a stable reading. Here one noise pulse is counted for each half-cycle.

7.2. Timeout

If stop arming is not used, the Analyzer ends measurement when all requested samples have been collected. However, if signal is absent (or lost) on one of the inputs used for the measurement – timestamps from this channel will never come and Analyzer will wait forever unless measurement is stopped explicitly.

However, in many cases this is undesirable behavior. For example in an automated test system when absence of signal can be a result of a wrong test setup or device under test malfunction, it is would be a waste of time to wait until the expected end of a long measurement to discover that one of the signals is just missing.

This is where Timeout function comes to help. If Timeout is ON, the measurement will end in case there are no samples from one of measurement inputs for the time duration set by Timeout Time.

7.3. Calibration

7.3.1. Internal Calibration

The Analyzer has a possibility to compensate for some internal sources of error by the means of internal calibration. This procedure doesn't require any external signal, the Analyzer can perform it automatically.

Performing internal calibration before the start of measurement helps getting maximum accuracy and best resolution. However, because internal calibration takes up to 2 s it has impact on measurement speed which might be important in automated test systems. Hence, the Analyzer allows to choose the schedule of internal calibration. Summarizes available options.

Mode	Description
Every 30 minutes	The Analyzer performs internal calibration every 30 minutes between successive measurements or when it is idle. This is the default option which provides the best trade-off between accuracy, resolution and average measurement speed.
Before every measurement	The analyzer performs internal calibration before each timing measurement to ensure best resolution and accuracy. This results in additional time overhead of around 2 s per measurement session. If such overhead is not critical – this is the recommended choice.
Once (after warm-up)	The Analyzer performs internal calibration only once – after the instrument has warmed up. This guarantees no calibration overhead, but resolution will deteriorate over time.

Table 4. Internal Calibration Modes

To provide maximum flexibility, the Analyzer also provides the possibility to perform internal calibration implicitly. This is especially useful when Interpolator Calibration Mode is set to Once.

All above can be configured under Settings → Advanced section (see Figure 39).

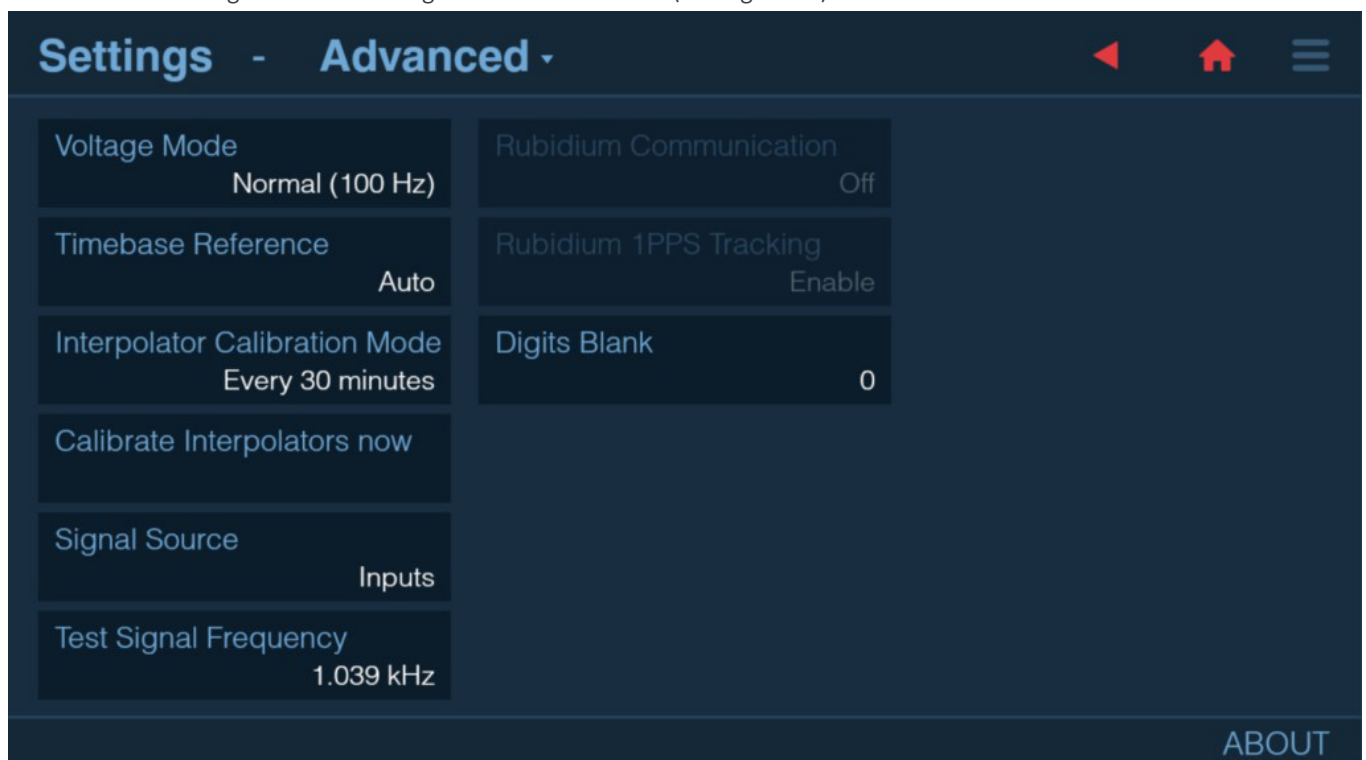


Figure 44. Internal Calibration configuration

7.3.2. Timebase Calibration

For increasing measurement accuracy, a good reference source can be used for timebase calibration. Connect the source to Input A, select Settings→Timebase Calibration, choose reference frequency and start the procedure. It is possible to interrupt the process midway, re-apply result from previous calibration or reset to factory calibration setting.



Figure 45. Timebase Calibration menu

7.3.3. Voltage Calibration

For increasing accuracy of voltage measurements and manual trigger level setting accuracy, a good source of DC voltage can be used for voltage calibration. Open Settings → Voltage menu, select the input to be calibrated and follow the instructions.

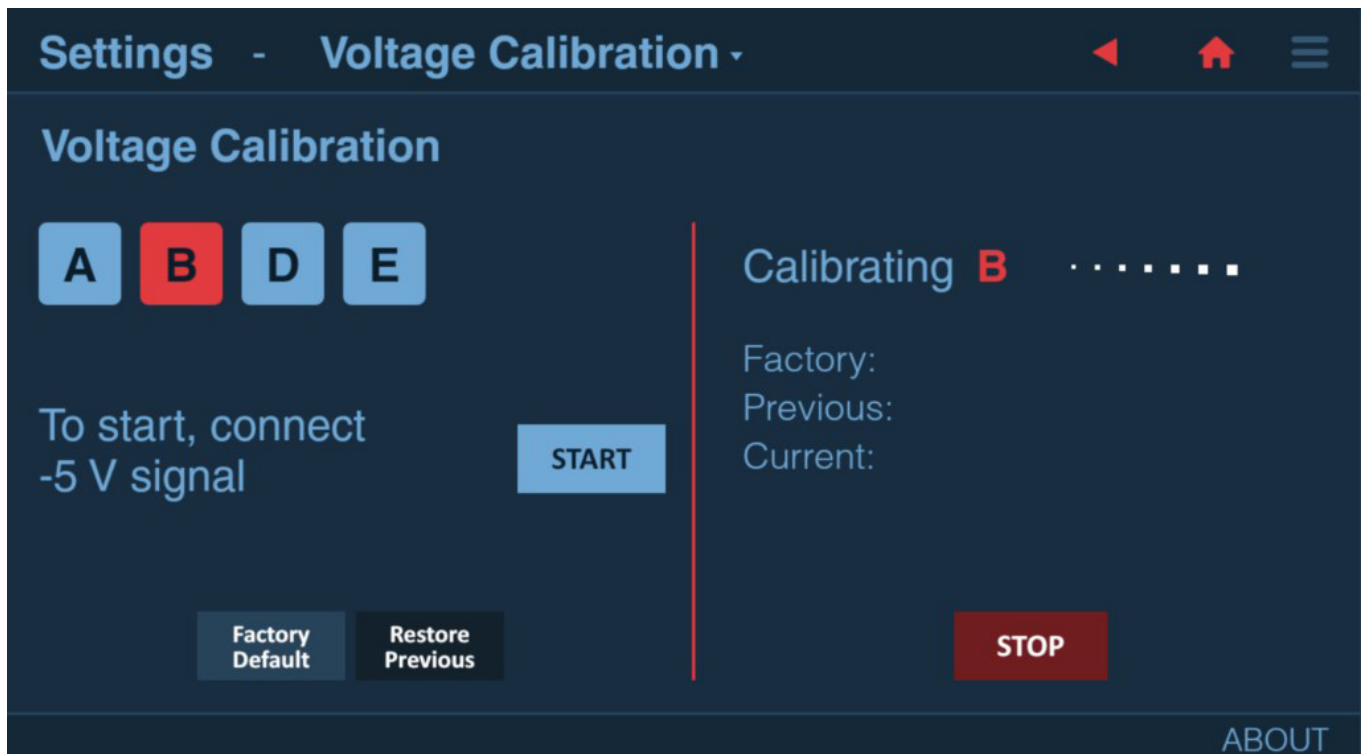


Figure 46. Voltage Calibration menu

Please note: voltage calibration sets inputs to 1 MOhm impedance.

7.4. Mathematics

The Analyzer can use five mathematical expressions to process the measurement result before it is displayed:

- $K \times X + L$
- $K/X + L$
- $(K \times X + L)/M$
- $(K/X + L)/M$
- $X/M - 1$

Select Settings → Mathematics to enter the mathematics submenu.

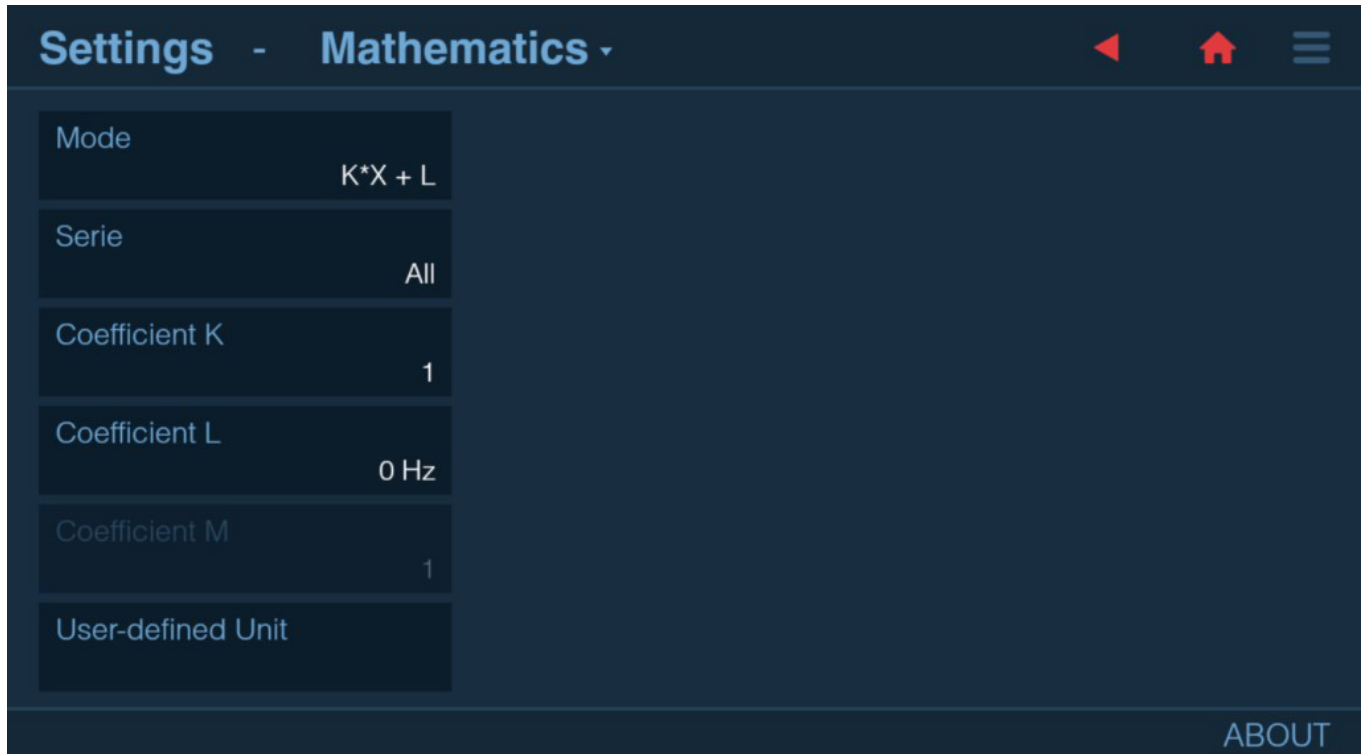


Figure 47. Mathematics menu

The default values of K (Scale factor), L (Offset) and M (Reference value) are chosen to 1, 0 and 1 respectively, so that the measurement result is not affected directly after activating Math. Recalling the default setting will restore these values as well.

It is possible to apply Mathematics function to all measurement series or to selected one.

When Mathematics is turned on, the Analyzer status bar shows MATH indicator.

7.4.1. Example use cases

If you want to observe the deviation from a nominal frequency, for example 10 MHz, instead of the absolute frequency itself, you can do like this:

- Select Math
- Select the expression $K \times X + L$
- Select $K = 1$ (if not already set)
- Select $L = -10 \text{ MHz}$
- Now the display will show the deviation from the value you have just entered.

By changing the constant K you can scale the result instead. Set for example $K = 60$ to convert Frequency in Hz to RPM (revolutions per minute) from rotation transducers.

Use the expression $X/M - 1$ if you want the result to be displayed as a relative deviation. The result will be displayed as %, ppm, ppb, or as a dimensionless number like $+1.2345E-12$

7.5. Limits

Limits feature is used for setting numerical limits and selecting the way the instrument will report the measurement results in relation to them.

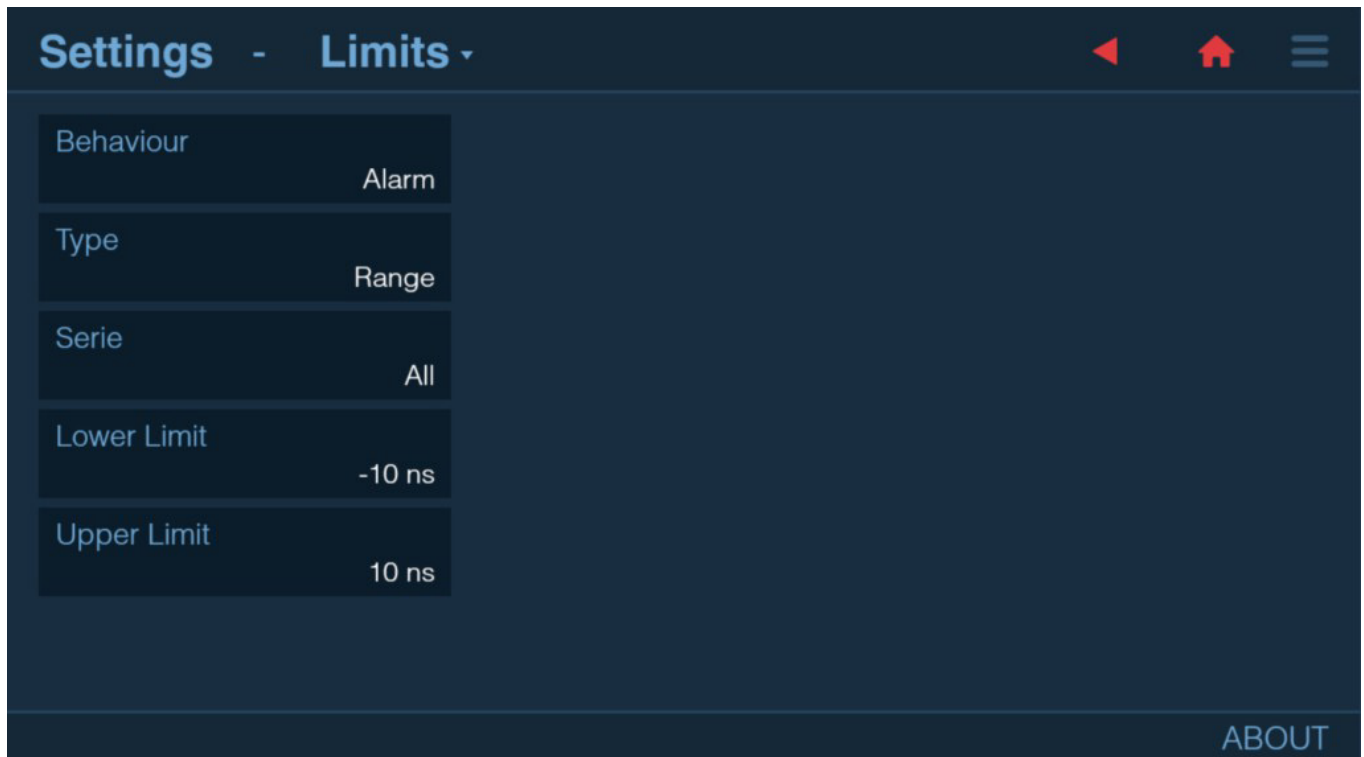


Figure 48. Limits configuration

Limit Behavior setting defines how the device will react on limits:

- Off – limits are not checked.
- Capture – only samples meeting the limit criterion are captured, the rest are discarded. Limit status is displayed.
- Alarm – all samples are captured; limit status is displayed.
- Alarm Stop – measurement session stops if measured value doesn't meet the limit criterion.

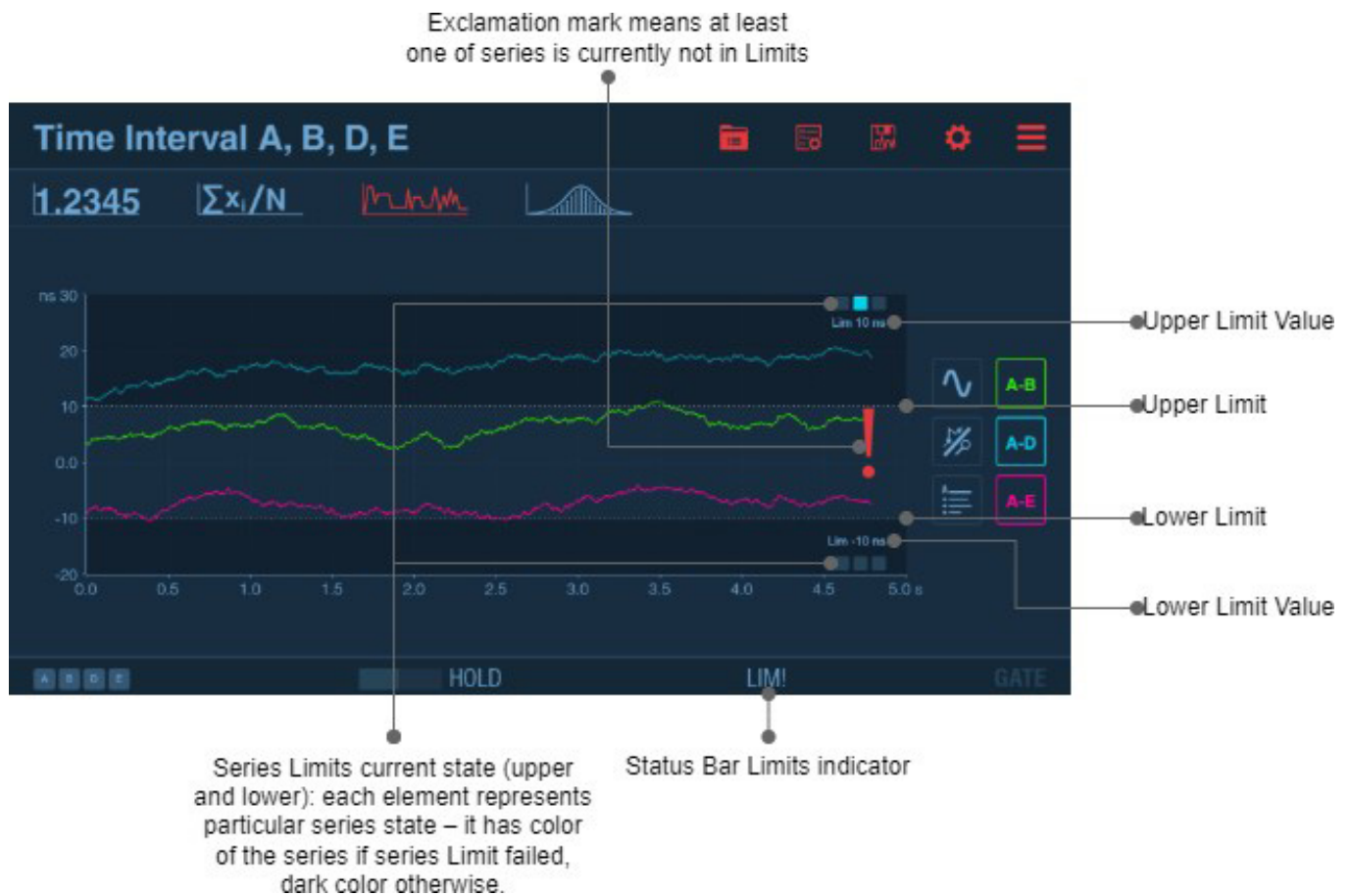
Limit Type:

- Above – results above set Lower Limit will pass.
- Below – results below set Upper Limit will pass.
- Range – results within the set limits will pass.

Limits can be applied to all measurement series or to selected one, depending on user's choice.

When Limit Behavior is not Off, Analyzer status bar shows LIM. It will change to LIM! if at least one sample didn't meet set Limit criterion during measurement session.

Numeric, Graph and Distribution screens will also have additional Limit indicators displayed.



7.6. Pulse Output (option)

Please note: license is needed to unlock Pulse Output functionality in the Analyzer

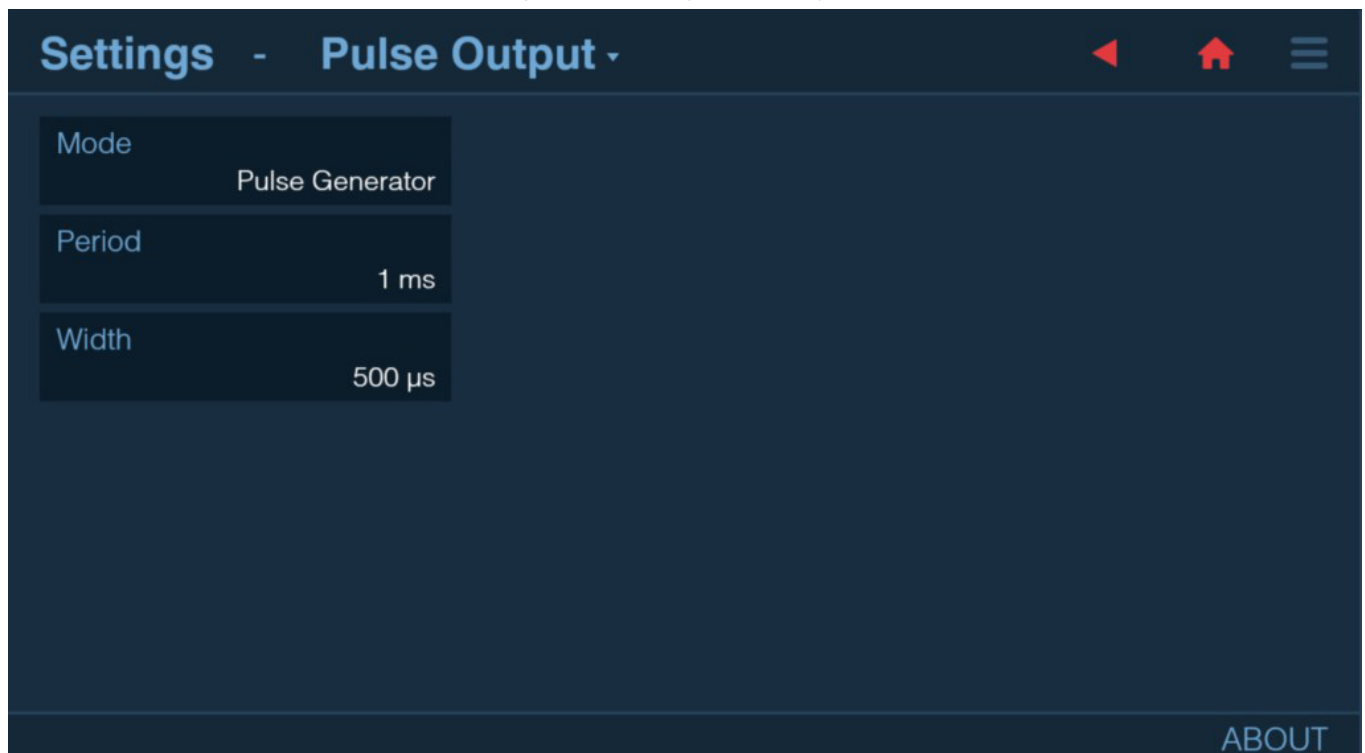


Figure 50. Pulse Output configuration

Pulse Output is located on rear panel of the Analyzer and can be used for one of the following purposes:

- Pulse Generator. Pulse period can be selected from the range [10 ns .. 2.147 s] in 2 ns steps, pulse width – in the range [6 ns .. .147 s] in 2 ns steps.
- Gate Open. Indicates if measurement is in progress.
- Alarm Out. Indicates when Limits Alarm is active. Can be selected between Active High and Active Low

Irrespective to the selected mode, the amplitude of Pulse Output signal is set to TTL levels into 50 Ohm termination

7.7. Network

The Analyzer supports wired 10/100/1000 Mbps connection as well as wireless (via external USB Wi-Fi adapter).

It has IPv4 support and can be configured in either Static or Dynamic (DHCP) mode. If Static mode is selected, user is expected to manually enter IP address, Network mask and Gateway. For Dynamic mode, these fields are read-only and display IP address, network mask and gateway that are currently in use.

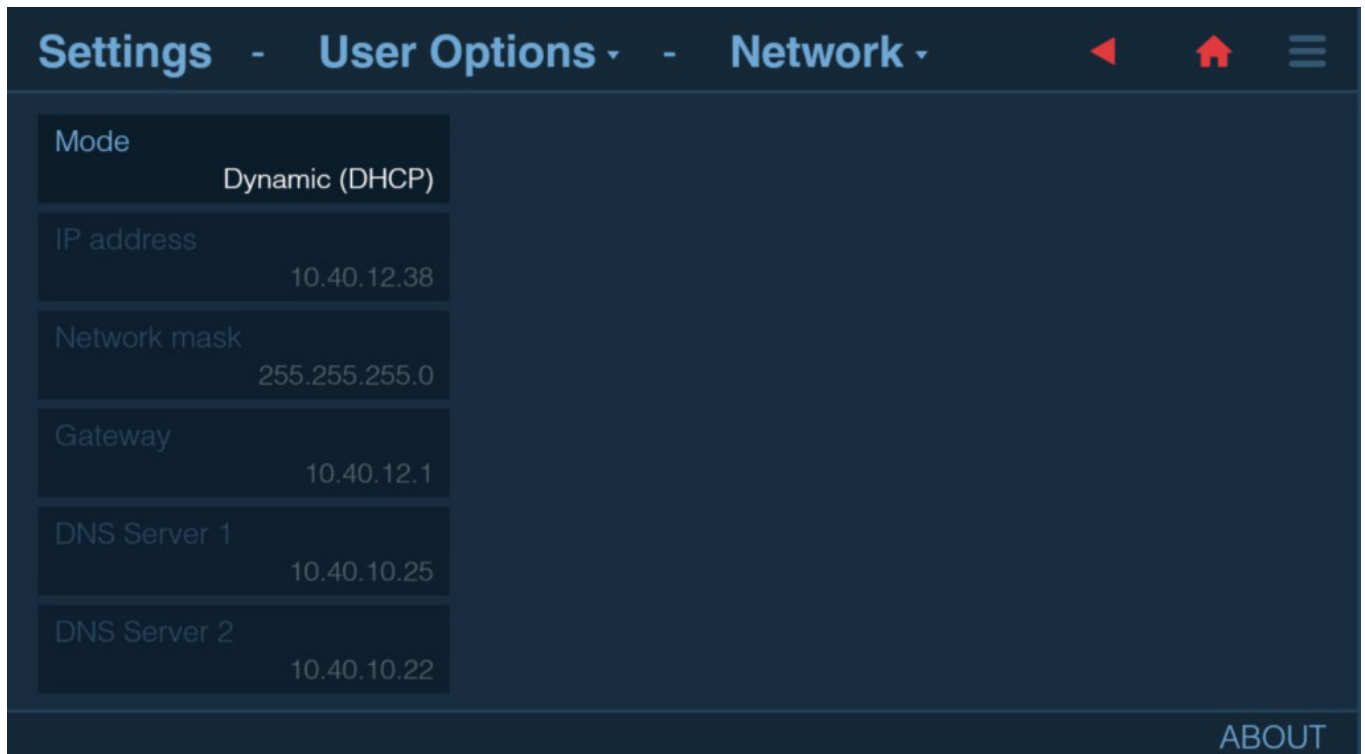


Figure 51. Network configuration

7.7.1. Web Interface

The Analyzer has built in web server that provides Web Interface allowing to see the instrument screen and control it remotely, download files and upgrade firmware.

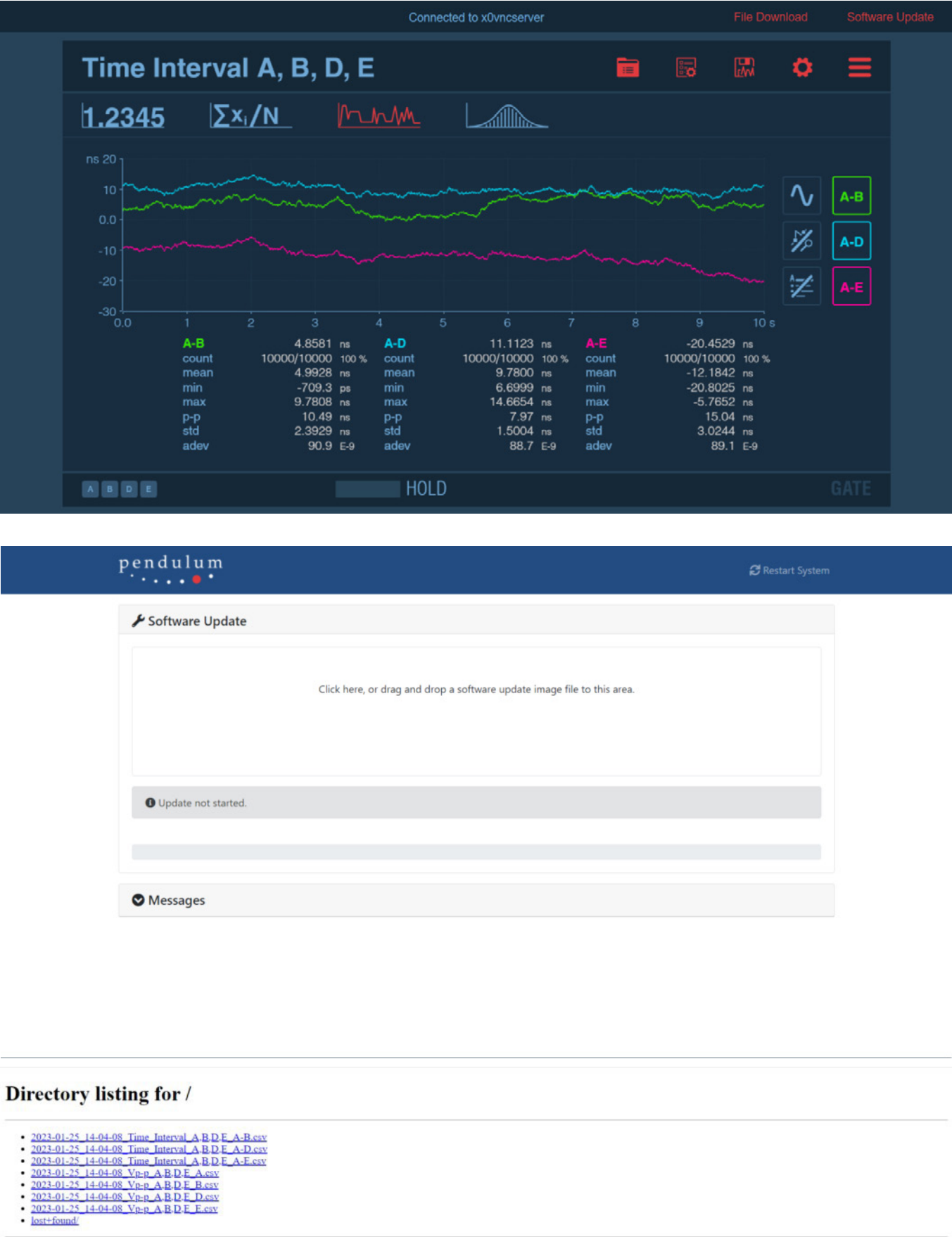


Figure 52. Web Interface

7.7.2. VNC

The Analyzer also exposes VNC server on port 5901 which allows remote access and control. One can use any VNC client software on PC, mobile phone or tablet.

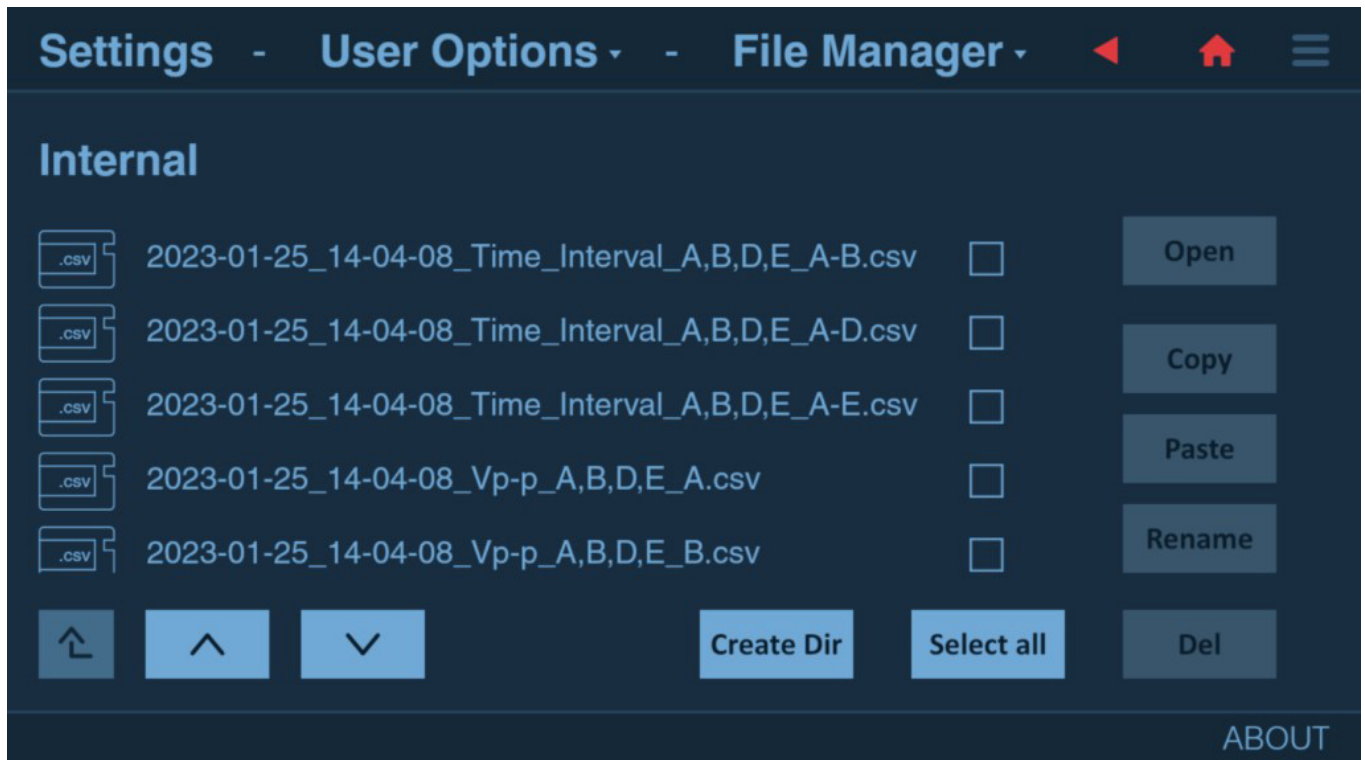
7.8. Front USB ports

Front panel USB ports can be used for connecting:

- Peripherals (PC keyboard and mouse) which complement the touch screen interface.
- USB storage for saving measurement results, presets or upgrading firmware.
- Wi-Fi adapter for enabling wireless networking.

7.9. File Manager

The Analyzer has built-in File Manager accessible via Settings → User Options → File Manager or dedicated icon on measurement screen.



7.10. Firmware Update

There are 2 ways of updating firmware of the Analyzer:

- Open Web Interface, press Update Firmware and follow instructions
- Put firmware file on USB stick, plug it to one of front USB ports, open Settings → User Options → Firmware Update

7.11. Installing license

- Put License File on USB stick
- Plug it to one of front USB ports
- Navigate to Settings → User Options → Import License
- Select License to be imported

8. Performance Check

8.1. General Information



WARNING: Before turning on the instrument, ensure that it has been installed in accordance with the Installation Instructions outlined in Chapter 1 of the User's Manual.

This performance procedure is intended for:

- checking the instrument's specification.
- incoming inspection to determine the acceptability of newly purchased instruments and recently recalibrated instruments.
- checking the necessity of recalibration after the specified recalibration intervals.



NOTE: The procedure does not check every facet of the instrument's calibration; rather, it is concerned primarily with those parts of the instrument which are essential for determining the function of the instrument.

It is not necessary to remove the instrument cover to perform this procedure.

8.2. Preparations

Power up your instrument at least 30 minutes before checking to let it reach normal operating temperature. Failure to do so may result in certain test steps not meeting equipment specifications.

8.3. Test Equipment

Type of Equipment	Required Specifications
Reference Oscillator	10 MHz, 1×10^{-8} (e.g. 6688) for calibrating the standard TCXO oscillator 10 MHz, 1×10^{-9} (e.g. 6689) for calibrating Opt 30 & Opt 40 (OCXO)
Voltage Calibrator	DC -50 V to +50 V (e.g. Fluke 5500) for calibrating the built-in voltage reference, alternatively corresponding DC power supply + DVM with uncertainty <0.1 %
LF Synthesizer	Square/ Sine up to 10 MHz, 10 VRMS
Pulse Generator	2 ns rise time, 5 V peak, >10 MHz, continuous & one-shot trigger
Oscilloscope	1 GHz, <3% voltage uncertainty
RF Signal Generator	0.1 to 3, 10, 15, 20, or 24 GHz dep. on RF input, <1dBm level uncertainty, 10 MHz ext.ref.
Power Splitter	50 Ohm 6dB BNC
T-piece	BNC
Termination	50 Ohm feed through BNC
Low-pass Filter	50 kHz (for 1 MOhm) load
BNC Cables	Approx. 10 pcs of suitable lengths

Table 5. Recommended equipment for calibration and performance check.

8.4. Internal Self-Tests

Internal self-tests are run on every instrument power up. In case of a failure information message box appears described the type of the error.

8.5. Front Panel Controls

8.5.1. Touch Panel and Keyboard Test

- Press Settings icon on top right. Open User Options → Recall Defaults. Confirmation dialog will appear.
- Press Yes.
- Press BACK hard button. Main Settings screen will appear.

- Press Advanced, then press Signal Source and select Test.
- Press ABOUT in bottom right corner. About box will appear.
- Press OK.
- Press HOME hard button. Measurement screen will appear. Frequency around 1 MHz will be measured.
- Press HOLD hard button. Measurement will be put in HOLD after current one finishes.
- Press RESTART hard button. Instrument will perform single measurement.
- Press Measurement Function name in top left corner. Function selection dialog will appear.
- Select Period → Period Single → A, B.
- Press OK. Measurement screen will appear.
- Press AUTOSET hard button. Autoset progress dialog will appear followed by “Autoset finished” notification.

8.6. Short Form Specification Test

8.6.1. Sensitivity and Frequency Range for Inputs A, B, D, E

- Recall Defaults Select Frequency A.
- Select 50 Ω input impedance, 1x attenuation, Manual Trigger Levels and Absolute Trigger Level A 0V.
- Select Preamp ON
- Connect a signal from a HF generator to a BNC power splitter.
- Connect the power splitter to Input A of your counter and an oscilloscope. Set the input impedance to 50 Ω on the oscilloscope.
- Adjust the amplitude according to the following table. Read the level on the oscilloscope. The timer/counter should display the correct frequency.
- Repeat the measurements and input settings above for Input B, D, and E.

Frequency MHz	Level mVrms	Level dBm	Pass/Fail
10	15	-23	
50	15	-23	
100	15	-23	
200	15	-23	
300	25	-19	
400	35	-16	

Table 6. Sensitivity for inputs A, B, D & E at various frequencies

8.6.2. Sensitivity and Frequency Range for RF Input (Input C)

To verify the specifications of the different RF prescalers, use the following basic test setup:

- Connect the output of a signal generator covering the specified frequency range to the RF input (C) of the Analyzer.
- Connect the 10 MHz REF OUT from the generator to the EXT REF on the rear panel of the Analyzer. Choose External in Settings → Advanced → Timebase Reference.
- Select Frequency C as Measurement Function.
- Generate a sine wave in accordance with the data in the relevant table (Table 7, Table 8).
- Verify that the Analyzer is counting correctly. (The last digits will be unstable).

Frequency GHz	Amplitude dBm
0.1-0.3	-21
0.3-2.5	-27
2.5-2.7	-21
2.7-3.0	-15

Table 7. RF input sensitivity, Option 10 (3 GHz) Frequency GHz Amplitude dBm

Frequency GHz	Amplitude dBm
0.15-0.3	-15
0.3-0.5	-21
0.5-7.5	-27
7.5-20	-24
20-22	-21
22-24	-15

Table 8. RF input sensitivity, Option 110 (10, 15, 20 or 24 GHz)

8.6.3. Voltage

- Recall Defaults. Select Vpp A
- Select DC coupling and Filter 10 kHz. Do not apply an input signal to Input A yet.
- The display should now indicate (disregard the main parameter Vpp): $V_{min} = 0 \pm 0.015 \text{ V}$ and $V_{max} = 0 \pm 0.015 \text{ V}$
- Adjust the current limit of the DC voltage source to $<200 \text{ mA}$.
- Connect $+2.500 \text{ Vdc}$ to Input A, using the external 50 kHz low-pass filter on the input.
- The display should now indicate: $V_{min} = 2.500 \pm 0.040 \text{ V}$ and $V_{max} = 2.500 \pm 0.040 \text{ V}$ Repeat the measurement with inverted polarity.
- Select Input A and select 10x.



CAUTION: Before the next step, make sure the input impedance is still $1 \text{ M}\Omega$. Applying more than 12 V without proper current limiting may cause extensive damage to the main PCB, if the impedance is set to 50Ω .

- Change the DC level to $+50.00 \text{ V}$.
- The display should now indicate: $V_{min} = 50.00 \pm 0.65 \text{ V}$ and $V_{max} = 50.00 \pm 0.65 \text{ V}$ Repeat the measurement with inverted polarity.
- Disconnect the DC voltage from Input A. Remove the external low-pass filter.
- Select Input A and select 1x.
- Connect the LF generator to Input A, and set an amplitude of 4.000 Vpp and a frequency of 100 kHz . Verify the Amplitude with a good Voltmeter
- The display should now indicate: $4.000 \pm 0.150 \text{ Vpp}$.
- Select Input A and select 10x. Change the amplitude to 18.00 Vpp .
- The display should now indicate: $18.00 \pm 1 \text{ Vpp}$. Disconnect the LF generator from Input A.
- Select Input A and select 1x, 50 ohm , and Filter = OFF.
- Connect the RF generator to Input A and set an amplitude of 4.000 Vpp and a frequency of 100 MHz . Verify the amplitude on an oscilloscope.
- The display should now indicate: $4.000 \pm 0.40 \text{ Vpp}$. Select Input A and select 10x.
- Change the amplitude to 18.00 Vpp .
- The display should now indicate: $18.00 \pm 2.2 \text{ Vpp}$
- Proceed by repeating the measurements for Input B, D, and E, as described above for Input A.

Supplied Voltage	Instrument limits Vmax, Vmin, Vpp		A	B	D	E	P/F
	Vmin	Vmax					
DC-coupled, ATT x1, 1 Mohm impedance, LP filter 10 kHz							
Open input	-15 mV	+15 mV					
+2.500V DC	+2.460V	+2.540V					
-2.500V DC	-2.540V	-2.460V					
ATT x10, 1 Mohm, LP filter 10 kHz WARNING! A 50 ohm input will be DAMAGED							
+50.00V DC	+49.35V	+50.65V					
-50.00V DC	-50.65V	-49.35V					
ATT x1, 1Mohm, LP filter 30 MHz, LF generator with low output impedance							
4.00Vpp AC sine, 100kHz	3.85Vpp	4.15Vpp					
ATT x10, 1Mohm, LP filter 30 MHz							
18.0Vp-p AC sine, 100kHz	17.1Vpp	18.9Vpp					
ATT x1, 50 ohm, LP filter OFF, RF generator with 50 ohm output impedance							
4.00Vpp AC sine, 100 MHz	3.6Vp-p	4.4Vp-p					
ATT x10, 50 ohm, LP filter OFF							
18.0Vp-p AC sine, 100kHz	15.8Vp-p	20.2Vp-p					

8.6.4. Reference Oscillators

X-tal oscillators are affected by a number of external conditions like ambient temperature and supply voltage. Aging is also an important factor. Therefore, it is hard to give limits for the allowed frequency deviation. The user himself must decide the limits depending on his application and recalibrate the oscillator accordingly.

To check the accuracy of the oscillator you must have a calibrated reference signal that is at least five times more stable than the oscillator that you are testing. See Table 7-6 and the list of test equipment on page 7-2. If you use a non-10 MHz reference, you can use the mathematics in the timer/counter to multiply the reading.

- Recall Defaults.
- Connect the reference to input A
- Check the readout against the accuracy requirements of your application.

8.6.4.1. Acceptance Test

Table 7 can serve as an acceptance test and gives a worst case figure after 30 minutes warm-up time. All deviations that can occur in a year are added together.

Oscillator	Frequency Readout	Suitable Reference	P/F
Standard (TCXO)	10.00000000 MHz + 150 Hz	6688	
Option 30 (OCXO)	10.00000000 MHz + 1Hz	6689	
Option 40 (OCXO)	10.00000000 MHz + 0.25 Hz	6689	

Table 9. Acceptance test for oscillators

8.6.5. Resolution Test

- Connect the pulse generator to a power splitter.
- Connect one side of the power splitter to Input A on the Analyzer using a coaxial cable.
- Connect the other side of the power splitter to Input B on the Analyzer.

Settings for the pulse generator:

- Amplitude = 4 V_{pp}, (high level +4 V and low level 0 V) Period = approx. 1 ms
- Duration = approx. 50 ns Rise time = 2 ns

Settings for the Analyzer:

- Recall Defaults,
- Select Time Interval Single A, B,
- Set for Inputs A & B: 50 Ω , DC coupling, Manual Trigger Levels,
- Set Absolute Trigger Level A to +1 V, Set Absolute Trigger Level B to +1 V,
- The standard deviation (std) should be less than 140 ps, corresponding to a resolution of 7 ps per timestamp.

8.7. Rear Inputs/Outputs

8.7.1. 10 MHz OUT

- Connect an oscilloscope to the 10 MHz output on the rear of the Analyzer. Use a coaxial cable and 50 Ω termination.
- The output voltage should be sinusoidal and $>1V_{p-p}$, typically $1V_{rms}$.

8.7.2. EXT REF FREQ IN

- Recall Defaults.
- Connect a stable 10 MHz signal (e.g REF OUT from another counter/analyzer) to input A. Connect a 10 MHz, 100 mV_{RMS} (0.28 V_{p-p}) signal from the LF synthesizer to EXT REF. Select Ext Ref. from the Timebase Oscillator setting menu
- The display should show 10 MHz.
- Change the external reference frequency to 5 and 1 MHz.
- The counting should continue, and the display should still show 10 MHz.

8.7.3. EXT ARM IN

- Proceed from the test above. Settings for the pulse generator:
 - single shot pulse,
 - manual trigger,
 - amplitude TTL = 0 – 2 VPP, and
 - duration = 10 ns.
- Connect the pulse generator to Ext Arm Input.
- Set Start Arming to EA on the Analyzer. The Analyzer does not measure.
- Apply one single pulse to Ext Arm Input.
- The Analyzer measures once and shows 10 MHz on the display.

8.7.4. PULSE OUT

- Connect an oscilloscope to the pulse output on the rear panel with a 50 Ω coaxial cable terminated at the scope input with 50 Ω (internally or externally).
- Enter Settings → Pulse Output.
- Set Mode to Pulse Generator. Select Pulse Period and set the value to 1000 ns. Select Pulse Width and set the value to 500 ns.
- The output signal should be a pure square wave signal with 1 MHz frequency and 50 % duty cycle. The rise/fall time should be approximately 2.5 ns. The low and the high level should be $<0.2\text{ V}$ resp. $>2.4\text{ V}$.

8.8. Measuring Functions

- Recall Defaults
- Set Settings → Advanced → Signal Source to Test
- Set Sample Interval to 200 ms
- Set DC, 50 Ω , Manual Trigger Levels, Absolute Trigger Level to 0.5 V for Inputs A, B, D, E
- Go through Measurement Functions from the Table 8 and verify the results.



Note that the results in the table are rounded off and very approximate. Test signal is not synchronized to Analyzer timebase and can generate Frequencies far from nominal. No tolerances are given for this test.

Measurement Function	Display	Pass/Fail
Frequency A,B,D,E	1 MHz	
Smart Frequency A,B,D,E	1 MHz	
Frequency Ratio A,B,D,E	1	
Period Average A,B,D,E	1 us	
Smart Period Avg A,B,D,E	1 us	
Period Single A,B (D, E)	1 us	
Time Interval A,B,D,E	>-100 ps, <100ps	
Time Interval Single A,B,D,E	>-100 ps, <100ps	
Acc. Time Interval A,B,D,E	>-100 ps, <100ps	
Phase A,B (D,E)	0° (360°)	
Acc. Phase A,B (D,E)	0° (360°)	
TIE	0 s	
Pos. Duty Cycle A (B,D,E)	0.5	
Neg. Duty Cycle A (B,D,E)	0.5	
Pos. Pulse Width A,B (D,E)	500 ns	
Neg. Pulse Width A,B (D,E)	500 ns	
Rise Time A, B (D,E)	< 5 ns	
Fall Time A, B (D,E)	< 5 ns	
Rise-Fall Time A (B,D,E)	< 5 ns	
Pos. Slew Rate A, B (D,E)	>350 MV/s	
Neg. Slew Rate A, B (D,E)	<-350 MV/s	
Totalize A,B,D,E	increments	
Totalize X+Y A,B,D,E	increments	
Totalize X-Y A,B,D,E	0	
Totalize X/Y A,B,D,E	1	
Vmin A,B,D,E	0 V	
Vmax A,B,D,E	2 V	
Vp-p A,B,D,E	2 V	
Vminmax A (B,D,E)	Vmin=0 V, Vmax=2 V	

Table 10. Measurement Functions check

8.8.1. Optional RF Input C

- With an optional RF input (Input C) you will require an external RF source to verify Input C. A simple functional check can be performed by connecting a 1 GHz, -10 dBm signal after selecting Freq C. No other settings need to be changed.
- Read 1 GHz on the display

8.9. Check of HOLD OFF Function

- Recall Defaults
- Select Period Single A Set DC, 50 Ω for Input A
- Connect the rear panel output marked 10 MHz Out to Input A. The Analyzer will display 100 ns
- Increase Hold-Off Time setting (Settings → Measurement → Hold-Off Time) in steps from 0 s to 120 ns
- While Hold-Off Time is below 100 ns the result will be about 100 ns (one period). As soon as Hold-Off Time exceeds 100 ns (e.g. 110 ns), the result displayed will be about 200 ns (two periods)

9. Specifications

9.1. Measuring Functions

Display modes

Values/Statistics: Numeric display of Measurement values or Statistics parameters with large digits. Values mode also display auxiliary parameter values (with less resolution).

Time-line/Distribution: All measurements are displayed graphically. Multi- channel graphs are colorcoded. Statistics values are also displayed beneath the graphs.

Resolution

Measure up to 4 input signals in parallel with 7 ps resolution per timestamp (Period single, Time Interval, Pulse width, Rise/Fall time, Duty cycle, TIE), or 12 digits/s (frequency and period average).

Smart Frequency/Period avg. calculation mode

Basic resolution for frequency and period average is 12 digits in 1s measuring time. Statistics resolution enhancement algorithm (smart mode) gives up to one extra result digit depending on input signal and measurement setting.

Frequency A, B, D, E

Mode: Parallel measurements on up to 4 inputs. Back-to-back, with or without smart calculation

Range: 0.001 Hz to 400 MHz Aux.

Parameter: Vmax, Vmin, Vp-p

Frequency C (option)

Mode: Back-to-back, with or without smart calculation

Range: See input C

Aux. Parameter: Period C

Frequency Ratio (A,B,C,D, or E) / (A,B,C,D, or E)

Mode: Parallel measurements on 2 or 4 inputs.

Range: (10^{-9}) to 10^{11}

Input Frequency: See input A,B,D,E and C

Aux Parameters: Freq 1, Freq 2

Period A, B, C, D, E average

Mode: Parallel measurements on up to 4 inputs. Back-to-back, with or without smart calculation

Range: See the inverse of Frequency specifications

Aux. Parameter:

Ch. A, B, D, E: Vmax, Vmin, Vp-p Ch. C: Frequency C

TIE A, B, C, D, E (Option 151)

TIE = Time Interval Error, calculated as: Accumulated period – Expected (“ideal”) accumulated period

Mode: Parallel measurements on up to 4 inputs. Back-to-back.

Freq range: See Frequency specifications

Aux. Parameter: Ref Frequency

Period A, B, D or E single

Mode: Parallel measurements on 1 or 2 inputs.

Range: 2.5 ns to 1000 sec.

Aux. Parameter (A, B): Vmax, Vmin, Vp-p

Time Interval A, B, D, E (single or continuous)

Mode: Parallel timestamping of trigger events on up to 4 channels on continuous or single-shot signals.

Start and stop channel(s): any of A, B, D, E

Note: each input can produce 1 or 2 trigger events with individual trigger level and slope

Accumulated Time Interval: ON or OFF (adding or subtracting one start channel period to the Time Interval, when required)

Range: -1000s to +1000s

Repetition rate: up to 400 MHz or single-shot events

Min. Pulse width: 1.5 ns

Channel-to-channel offset: 100ps rms typ. Positive and Negative Pulse Width A, B, D, E Mode: Parallel measurements on 1 or 2 inputs. **Range:** 1.5 ns to 1000 sec.

Repetition rate: up to 300 MHz or single-shot events

Resolution: <10 ps per calculated result

Rise / Fall Time A, B, D, E

Mode: Parallel measurements on 1 or 2 inputs of Rise OR Fall time, or

Mode 2: Single input measurement of Rise AND Fall time on the same pulse.

Range: 1.5 ns to 1000 sec.

Aux. Parameters: Slew rate, Vmax, Vmin

Positive and negative Slew Rate A, B, D, E

Mode: Parallel measurements on 1 or 2 inputs

Calculation: (80% of Vp-p) / (Rise or Fall Time)

Aux. Parameters: Slew rate, Vmax, Vmin

Positive and Negative Duty Cycle A, B, D, E

Mode: Single input measurement

Range: 0.000001 to 0.999999

Repetition rate: up to 300 MHz

Aux. parameters: Period, Pulse width

Phase A Relative B, B Relative A

Mode: Intended for phase shift or delay measurements of two signals with identical frequency

Accumulated Phase: OFF or ON (adding or subtracting 360° to the Phase, when required)

Range: -180° to +180° (Acc. Phase is OFF)

Resolution: 0.00003° to 100 kHz, decreasing to 0.03° >100 MHz. (10k sample statistics averaging)

Freq. Range: up to 300 MHz

Aux. Parameters: Freq (A), Va/Vb (in dB)

Totalize A, B, D, E

Inputs: up to 4 inputs (A, B, D, E)

Mode: Tot A, B, D, E; Tot A+B, D+E; Tot A-B, D-E; Tot A/B, D/E

Range: 1 to 10¹⁰ counts

Range: up to 400 MHz

Start control: Manual, start arming

Stop control: Manual, stop arming, timed

Vmax, Vmin, Vp-p A, B, D, E

Range: -5 V to +5 V, -50V to +50V

Freq. Range: DC, 100Hz to 200 MHz

Coupling: Sine (AC or DC), Square (DC only)

Resolution: 1 mV (5V range), 10 mV (50V range)

Uncertainty (5V range):

- DC, 1Hz to 1kHz: <1% +15 mV
- 1kHz to 20 MHz sine: 3% +15 mV (typ.)
- 20 to 100 MHz sine: 10% +15 mV (typ.)
- 100 to 200 MHz sine: 30% +15 mV (typ.)

(For square waves add 10% to Vmax,/min & 20% to Vp-p) (For 50V range, add 2% + 150 mV)

Aux parameters: Vmin, Vmax, Vp-p

9.2. Input Specifications

Inputs A, B, D and E

Frequency Range:

- DC-Coupled: DC to 400 MHz
- AC-Coupled: 10 Hz to 400 MHz

Impedance: 1M Ω // 40 pF or 50 Ω (VSWR \leq 2:1 typ.)

Trigger Slope: Positive or negative

Channel-channel skew: <50 ps (after calibration)

Sensitivity (typical):

- DC-400 MHz: <70 mVrms (PreAmp =OFF)
- DC-100 MHz: 15 mVrms (PreAmp = ON)
- 100-200 MHz: 25 mVrms (PreAmp = ON)
- 200-400 MHz: 35 mVrms (PreAmp = ON)

Hysteresis window: approx. 20 mV (PreAmp=OFF)

Attenuation: x1, x10

Dynamic Range (x1):

PreAmp = OFF: 0.04 to 10 Vp-p within \pm 5V window

PreAmp = ON: 0.01 to 2 V p-p within \pm 1V window

Trigger Level: Read-out in menu

- Resolution: 1mV
- Uncertainty (x1): \pm (15 mV + 1% of trigger level)

Trigger Level modes: Manual, Relative (to Vp-p), Auto

AUTO Trigger Level set to:

- 50% point of input signal's Vp-p, combined with a wide hysteresis between the 40% and 60% points, for frequency, period average, TIE
- 10% and 90% points, for Rise/Fall Time, Slew rate, combined with minimum hysteresis
- 50% point with minimum hysteresis for all other functions
- Min. voltage 200 mVp-p

Analog LP Filter: Nominal 10 or 100kHz selectable.

Max Voltage Without Damage:

- 1M Ω : 350 V (DC + AC pk) to 440 Hz, falling to 12 Vrms at 1MHz.
- 50 Ω : 12 Vrms

Connector: BNC

Input C (Option 10)

Operating Input Voltage Range opt. 10:

- 100 to 300 MHz: -21 dBm to +35 dBm
- 0.3 to 2.5 GHz: -27 dBm to +35 dBm
- 2.5 to 2.7 GHz: -21 dBm to +35 dBm
- 2.7 to 3.0 GHz: -15 dBm to +35 dBm

Prescaler Factor: 16

Impedance: 50 Ω nominal, VSWR <2.5:1 typ.

Max Voltage without Damage: +35 dBm

Connector: Type N Female

Input C (Option 110)

Freq. Range: 0.4 to 24 GHz; SW license enabled to 10, 15, 20 or 24 GHz

Operating input voltage range:

- 400 to 600 MHz: -21 to +27 dBm
- 0.6 to 17 GHz: -27 to +27 dBm
- 17 to 19 GHz: -24 to +27 dBm
- 19 to 21 GHz: -21 to +27 dBm
- 21 to 24 GHz: -15 to +27 dBm

Prescaler Factor: 64

Impedance: 50 Ω nominal, VSWR <2.0:1 typ.

AM tolerance: > 90% within sensitivity range

Max Voltage Without Damage: +27 dBm

Connector: 2.92 mm, SMA compatible Female

9.3. Rear Panel Inputs and Outputs

Reference Input

Frequency: 1, 5, or 10 MHz; 0.1 to 5Vrms sine

Impedance: 50 Ω (nom.)

Reference Output

Source: External input if used, otherwise internal

Frequency: External ref freq., or 10 MHz (internal)

Output impedance: 50 Ω

Amplitude: 1Vrms sine into 50 Ω (nom.)

Arming Input

Arming of all measuring functions

Impedance: Approx. 1k Ω Freq.

Range: DC to 200 MHz

Trigger level: approx. 1.5V fixed

Trigger slope: Pos. or neg. selectable

Programmable Pulse Output (Option 132)

Pulse mode: Pulse generator, Gate open, Alarm

Period range: 10ns-2s in 2ns steps

Pos. Pulse width range: 4ns-2s in 2ns steps

Min negative pulse width: 6ns

Rise time: 2.5 ns (nom.)

Output impedance: 50 Ω (nom.)

Output level: Low <0.4V; High: 4.5-5.25V (open output); 2.0-2.5V (50 ohm load)

9.4. Auxiliary Functions

Trigger Hold-Off

Time Delay Range: 20 ns to 2 s in 10 ns steps

External Start and Stop Arming

Modes:

- Start Arming Stop Arming
- Ext. Gate (combined Start and Stop Arming)
- Arming channels: A, B, D, E or rear panel ARM Arming delay to first trigger ready: <5 ns (typ.) Start/Stop Time Delay Range: 20 ns to 2 sec.

Statistics

Functions: Maximum, Minimum, Mean, Δ max-min, Standard Deviation and Allan Deviation

Display: Numeric or frequency distribution graph

Sample Size: 2 to 16×10^6 samples

Max. sample rate: up to 140 kSa/s calculated up to 20 MSa/s captured

Limit alarm

Graphical indication of limits with Pass/Fail message on front panel,

Limit Qualifier: OFF or Capture values above, below, inside or outside limits

Sample Interval (Gate time)

The Sample Interval sets the measuring time (gate) in Frequency/Period modes, the timing gate in Totalized timed measurements, and the time between measurements/samples in all other modes.

Range: OFF or 50 ns to 1000 sec.

Mathematics

Functions: OFF, $(K \times X - L)/M$, $(K/X - L)/M$, $X/M - 1$ X is current reading, and K (Scale factor), L (Nulling value) and M (Reference value) are constants

Other Functions

Timebase Reference: Internal, External or Autoselected

Restart: Aborts current measurement and starts a new

Run/Hold: Switch between RUN (continuous measurements) and HOLD (Freezes result, until a new measurement is initiated via Restart)

Save and Recall Settings and Measurements

Instrument Set-ups can be saved/recalled. Setups saved to internal memory can be user protected.

Measurement results (RAM) can be accessed by connected PC, and/or saved in internal non-volatile memory, and moved to USB stick.

Max. Measurement Speed and Storage size (RAM):

20 MSa/s (1 to 4 inputs): 16k samples

12.5 to 3.125 MSa/s (1 to 4 inputs): 32M samples

Display

Display: Graphic screen for menu control, numerical read-out, status information, plus distribution, trend and time-line graphs

Resolution: 1280×720 pixels

Type: Color Touch 5" TFT LCD display with backlight

Front panel accessible tools: Graph smoothing, pan and zoom, cursor read-out

9.5. Remote interfaces

Remote operation

Programmable Functions: All front panel accessible functions

Max. measurement rate (depending on measurement settings): Block mode: up to 170k readings/s

Individual results: up to 200 readings/s

To Internal Memory: 20M readings/s

Data Output format: ASCII, IEEE double precision floating point, or packed

USB interface

USB version: 2.0

Connectors

Rear panel: 1x Type B; (Device) used for remote communication and data transfer both ways

Front panel: 2x Type A; (Host) used for FW updates, mouse/keyboard connec" on, external result storage, WiFi dongle

Protocol: USBTMC-USB488

LAN & WLAN interface

Speed: 10/100/1000 Mbps

Capabilities:

- Web server
- SCPI over HiSLIP protocol, compatibility with VISA

Supported WiFi USB-dongles: TP-Link TL-WN321G, TP-LINK Archer T4U v.2, TPLINK Archer T4U v.3

9.6. Calibration of Timebase Oscillator

Mode: Closed case, electronic calibration, menu controlled. Calibration menu is password protected

Ref. Cal. Frequencies: 1, 5, 10, 1.544 or 2.048 MHz

9.7. General Specifications

Environmental Data

Class: MIL-PRF-28800F, Class 3

Installation category: II

Operating Temp:

- 0°C to +50°C / 5..75%RH bench-top,
- 0°C to +40°C / 5..75%RH rack-mount

Storage Temp: -40°C to +71°C

Vibration: Random and sinusoidal according to MIL-PRF-28800F, Class 3

Shock: Half-sine 30G per MIL-PRF-28800F; Bench handling

Transit drop test: According to MIL-PRF-28800F

Safety: EN 61010-1:2011, pollution degree 2, installation/over voltage category II, measurement category I, CE, indoor use only
CSA C22.2 No 61010-1-12

EMC: EN 61326-1:2013-06, increased test levels according to EN 61000-6-2:2008, Group 1, Class B, CE

Power Requirements

Max. Version: 90 to 265 Vrms, 47 to 63 Hz, <70 W

Dimensions and Weight

Width x Height x Depth: 210 x 90 x 395 mm (8.25 x 3.6 x 15.6 in)

Weight: Net 3 kg (6.6 lb)

9.8. Time Base Options

Option model	STD	30	40
Time base type:	TCXO	OCXO	OCXO
Uncertainty due to:			
-Aging per 24h	n/a	$<5 \times 10^{-10}^{(1)}$	$<3 \times 10^{-10}^{(1)}$
per month	$<2 \times 10^{-7}$ (typ.)	$<1 \times 10^{-8}$	$<3 \times 10^{-9}$
per year	$<1 \times 10^{-6}$	$<5 \times 10^{-8}$	$<1.5 \times 10^{-8}$
-Temperature variations: 0°C to 50°C	$<5 \times 10^{-7}$	$<5 \times 10^{-9}$	$<2.5 \times 10^{-9}$
20°C to 26°C (typ. values)	not specified	$<1 \times 10^{-9}$	$<4 \times 10^{-10}$
Short-term stability: $\tau = 1\text{s}$	$<1 \times 10^{-9}$ (typ.)	$<1 \times 10^{-11}$	$<1 \times 10^{-12}$
(root Allan Variance) $\tau = 10\text{s}$		$<1 \times 10^{-11}$	$<1 \times 10^{-12}$
Power-on stability:			
Deviation vs. final value after 24 h on time,	$<1 \times 10^{-6}$	$<1 \times 10^{-8}$	$<5 \times 10^{-9}$
after a warm-up time of:	5 min	10 min	10 min
Typical total uncertainty, for operating temperature			
20°C to 26°C, at 2 σ (95%) confidence interval:			
-1 year after calibration	$<1.2 \times 10^{-6}$	$<6 \times 10^{-8}$	$<1.8 \times 10^{-8}$
-2 years after calibration	$<2.4 \times 10^{-6}$	$<1.2 \times 10^{-7}$	$<3.5 \times 10^{-8}$

¹After 1 month of continuous operation

9.9. Ordering Information

Basic model CNT-104S:

4-channel 400 MHz Frequency Analyzer, 7 ps resolution, std. TCXO timebase 1 ppm/year

Input C Frequency Options

Option 10: 3 GHz Input C

Option 110: 10 GHz Input C (HW)

Option 110/15: SW upgrade from 10 to 15 GHz

Option 110/20: SW upgrade from 15 to 20 GHz

Option 110/24: SW upgrade from 20 to 24 GHz

Timebase Oscillator Options

Option 30: Very High Stability, OCXO 50 ppb/year

Option 40: Ultra High Stability, OCXO 15 ppb/year

Other options (SW license enabled)

Option 132: Programmable pulse output

Option 151: TIE measurement function

Included with Instrument:

- 2 year product warranty¹
- Line cord (dependent on destination country)
- Link to User documentation (PDF)
- Certificate of Calibration
- Important information document

¹: Warranty period may be extended to 3 years, at no cost, by registering the product

Optional Accessories

Option 22/90: Rack-Mount Kit- 1 unit

Option 22/05: Rack-Mount Kit -2 units

Option 27: Carrying Case – soft

Option 27H: Heavy-duty Hard Transport Case

Option 90/03: Calibration Certificate with Protocol; Standard TCXO oscillator

Option 90/06: Calibration Certificate with Protocol; Oven oscillator

Option 95/05: Extended warranty 2 extra years

OM-100: User's Manual English (printed)²

PM-100: Programmer's Manual English (printed)²

SM-100: Service Manual English

GS-100-EN: Getting Started English (printed)²

²: Always available as download from the Pendulum website

10. Sales and Service Contacts

For additional product information, customer support and service, please contact Pendulum Instruments at the following addresses:

Pendulum Instruments

SWEDEN

Madviksvägen 4, 370 22 Drottningstjärn, Sweden

Moravägen 1, 782 31 Malung

Phone: +46 280 41122

UNITED STATES

50 Woodside Plaza # 642, Redwood City, CA 94061

Phone: +1(866) 644-1230 (toll free)

POLAND

Lotnicza 37, 80-297 Banino, Poland

Phone: +48 (58) 681 89 01

CHINA

Room 1208, 12F, Building 2, Fuhai Center Daliushu, Haidian District, Beijing 100081

Phone: +86 13501221550

General Enquiries

info@pendulum-instruments.com

Request A Quotation

sales@pendulum-instruments.com

Orderdesk

orderdesk@pendulum-instruments.com

Technical Support

service@pendulum-instruments.com

CONTACT PENDULUM INSTRUMENTS

UNITED STATES

phone +1(866) 644-1230
us-office@pendulum-instruments.com

POLAND

phone. +48 (58) 681 8901
info@pendulum-instruments.com

CHINA

phone. +86 13501221550
china-office@pendulum-instruments.com

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